

FCC ID: 2APX7K5B

Page 1 of 108

FCC SAR TEST REPORT

Client Name : KRIPTO MOBILE CORPORATION

Address : 7236 NW 31ST ST,MIAMI, FL 33122, United States

Product Name : Mobile Phone

Date : Aug. 26, 2019

Shenzhen Anbotek Compliance Laboratory Limited

Shenzhen Anbotek Compliance Laboratory Limited





FCC ID: 2APX7K5B

Page 2 of 108

Contents

1.		6
2.	General Information	7
	2.1. Client Information	7
10	2.2. Testing Laboratory Information2.3. Description of Equipment Under Test (EUT)	7
	2.3. Description of Equipment Under Test (EUT)	7
hobo	2.4. Device Category and SAR Limits	9
1.3	2.5. Applied Standard	9
	2.6. Environment of Test Site	9
	2.7. Test Configuration	9
3.	Specific Absorption Rate (SAR)	10
poter.	3.1. Introduction	10
	3.2. SAR Definition	10
4.	March Mar	
	4.1. E-Field Probe	
	4.2. Data Acquisition Electronics (DAE)	12
Sec.	4.3. Robot	
	4.4. Measurement Server	
	4.5. Phantom	
	4.6. Device Holder	
	4.7. Data Storage and Evaluation	
5.	Test Equipment List	
6.	Tissue Simulating Liquids	20
7.	System Verification Procedures	22
8.	EUT Testing Position	24
	8.1. Define two imaginary lines on the handset	24
	8.2. Position for Cheek/Touch	25
	8.3. Position for Ear / 15°Tilt	
	8.4. Body Worn Position	
9.	Measurement Procedures	27
	9.1. Spatial Peak SAR Evaluation	27
	9.2. Power Reference Measurement	28
	9.3. Area Scan Procedures	28
	9.4. Zoom Scan Procedures	29
	9.5. Volume Scan Procedures	30
	9.6. Power Drift Monitoring	30
10.	Conducted Power	31
11.	Antenna Location	38
	SAR Test Results Summary	39
Antho	12.1 Head SAR Results	39
Sher	nzhen Anbotek Compliance Laboratory Limited	

Address: 1/F., Building D. Sogood Science and Technology Park, Sanwel Community, Hangcheng Street, Bao'an District, Shenzhen, Guangdong, China. Tel:(86) 755-26066440 Fax: (86) 755-26014772 Email: service@anbotek.com

Anbotek Product Safety

Antoonex

e^{gh}

Antonek

In 101

Report No.: R0219080013W FCC ID: 2APX7K5B 12.2. Body SAR Results	Page 3 of 108
13. Simultaneous Transmission Analysis	
13.1. Simultaneous TX SAR Considerations	43
13.2. Evaluation of Simultaneous SAR	43
14. Measurement Uncertainty	47
Appendix A. SAR Test Setup Photos	
Appendix B. Plots of SAR System Check	50
Appendix C. Plots of SAR Test Data	56
Appendix D. DASY System Calibration Certificate	66

Shenzhen Anbotek Compliance Laboratory Limited

Address: 1/F., Building D, Sogood Science and Technology Park, Sanwei Community, Hangcheng Street, Bao'an District, Shenzhen, Guangdong, China. Tel:(86) 755-26066440 Fax: (86) 755-26014772 Email: service@anbotek.com



public and

Anbotek Product Safety

Report No.: R0219080013W

FCC ID: 2APX7K5B

Page 4 of 108

TEST REPORT

Applicant	: KRIPTO MOBILE CORPORATION
Manufacturer	: KRIPTO MOBILE CORPORATION
Product Name	: Mobile Phone
Model No.	: K5b
Trade Mark	: Krip
Rating(s)	: DC 3.8V, 2000mAh Battery inside

Test Standard(s) : IEEE 1528-2013; IEC 62209-2:2010; ANSI/IEEE C95.1:2005; FCC 47 CFR Part 2 (2.1093:2013);

The device described above is tested by Shenzhen Anbotek Compliance Laboratory Limited to determine the maximum emission levels emanating from the device and the severe levels of the device can endure and its performance criterion. The measurement results are contained in this test report and Shenzhen Anbotek Compliance Laboratory Limited is assumed full of responsibility for the accuracy and completeness of these measurements. Also, this report shows that the EUT (Equipment Under Test) is technically compliant with the IEEE 1528-2013, IEC 62209-2:2010, ANSI/IEEE C95.1:2005 and FCC 47 CFR Part 2 (2.1093:2013) requirements.

This report applies to above tested sample only and shall not be reproduced in part without written approval of Shenzhen Anbotek Compliance Laboratory Limited.

Date of Receipt Date of Test



Aug. 13, 2019 Aug. 14~23, 2019

Prepared By

Reviewer

Bobby Warg

(Engineer / Bobby Wang)

Snowy Meng

(Supervisor / Snowy Meng)

Approved & Authorized Signer

(Manager / Sally Zhang)

Shenzhen Anbotek Compliance Laboratory Limited

Address: 1/F., Building D, Sogood Science and Technology Park, Sanwei Community, Hangcheng Street, Bao'an District, Sherizhen, Guangdong, China. Tel:(86) 755–26066440 Fax: (86) 755–26014772 Email: service@anbotek.com



Report No.: R0219080013W FCC ID: 2APX7K5B Page 5 of 108

Version

Version No.	Date	Description
01	Aug. 26, 2019	Original
stak substates 1	Contract Annual Annual	Antronet Antronet Antronet Antronet
nbotak Anticitak	Antony Antony	Antibation Antibatelik Antibatelik Antibatelik
habolak habola	Anticipals int	one and another alternate habout attent
Anbornet And	tak Anbalak	mbon white holdonest possible wat and and
Arbo ucted to	botak pubota	And Androis Androis Address Androise

Shenzhen Anbotek Compliance Laboratory Limited





Page 6 of 108

1. Statement of Compliance

The maximum results of Specific Absorption Rate (SAR) found during testing are as follows.

Fragueney Band	Highest Repo	orted 1g-SAR(W/Kg)	SAR Test Limit
Frequency Band	Head	Body	(W/Kg)
GSM 850	0.166	0.406	a abotak pot
PCS 1900	0.257	0.785	A worker
WCDMA Band 2	0.793	0.719	1.6
WCDMA Band 5	0.246	0.363	1.6
WIFI 2.4G	0.315	0.245	Antopton Anton in
Simultaneous SAR	1.108	1.03	Anbolek Anbo
Test Result	probation print	PASS	k upotok holo

<Highest SAR Summary>

This device is in compliance with Specific Absorption Rate (SAR) for general population/uncontrolled exposure limits (1.6 W/kg) specified in FCC 47 CFR part 2 (2.1093) and ANSI/IEEE C95.1-2005, and had been tested in accordance with the measurement methods and procedures specified in IEEE 1528-2013 and IEC 62209-2:2010

Shenzhen Anbotek Compliance Laboratory Limited





FCC ID: 2APX7K5B

Page 7 of 108

2. General Information

2.1. Client Information

Applicant	: KRIPTO MOBILE CORPORATION	
Address	: 7236 NW 31ST ST,MIAMI, FL 33122, United States	1
Manufacturer	: KRIPTO MOBILE CORPORATION	pole d
Address	: 7236 NW 31ST ST,MIAMI, FL 33122, United States	and and
Factory	: KRIPTO MOBILE CORPORATION	
Address	² 7236 NW 31ST ST,MIAMI, FL 33122, United States	5- -

2.2. Testing Laboratory Information

	Test Site:	:	Shenzhen Anbotek Compliance Laboratory Limited
	Address:		1/F, Building D, Sogood Science and Technology Park, Sanwei community,
1	/ 1001 0001		Hangcheng Street, Bao'an District, Shenzhen, Guangdong, China.518102

2.3. Description of Equipment Under Test (EUT)

Product Name	:	Mobile Phone	
Model No.	:	K5b	Antronet Antoniek Antronet Antronet
Trade Mark	:	Krip	Antonia Antonia Antonia Antonia
Test Power Supply	:	DC 3.8V Battery inside	the second hereader and and
Test Sample No.	:	1-2-1(Normal Sample), 1	-2-2(Normal Sample)
Product Description	:	Operation Frequency:	BDR+EDR: 2402MHz~2480MHz 2.4G WIFI:2412~2462MHz GSM/GPRS 850 TX:824.2~848.8 MHz; RX:869.2~893.8 MHz PCS/GPRS 1900 TX:1850.2~1909.8 MHz; RX:1930.2~1989.8 MHz UMTS-FDD Band 5 TX: 826.4 ~ 846.6 MHz; RX: 871.4 ~ 891.6 MH

Product Safety

Anbot

19080013W	FCC ID: 2APX7K5B Page 8 of 1 UMTS-FDD Band 2
hadron harris	TX:1852.4~1907.6 MHz; RX: 1932.4~1987.6 MHz
Transfer Rate:	BDR+EDR: 1/2/3 Mbits/s 802.11b: 11/5.5/2/1Mbps 802.11g: 54/48/36/24/18/12/9/6 Mbps 802.11n: up to 150Mbps
Number of Channel:	BDR+EDR: 79 Channels 802.11b/ g/ n(HT20): 11 Channels
GPRS Class:	8/10/12
Modulation Type:	GSM/GPRS: GMSK WCDMA: BPSK, 16QAM BDR+EDR: GFSK, π/4-DQPSK, 8-DPSK
and a second second	2.4G WiFi: CCK, DQPSK, DBPSK for DSSS 64QAM, 16QAM, QPSK, BPSK for OFDM
Antenna Type:	GSM/GPRS: FPCB Antenna WCDMA: FPCB Antenna BDR+EDR: FPCB Antenna 2.4G WiFi: FPCB Antenna
Andrew Andrew Andrew	GSM 850: -0.43 dBi PCS 1900: 0.42 dBi UMTS-FDD Band 2: 0.42 dBi
Antenna Gain(Peak):	UMTS-FDD Band 5: -0.43 dBi BDR+EDR: 1.03 dBi

Remark: 1) For a more detailed features description, please refer to the manufacturer's specifications or the User's Manual.

Shenzhen Anbotek Compliance Laboratory Limited



Anbotek Product Safety

FCC ID: 2APX7K5B

Page 9 of 108

2.4. Device Category and SAR Limits

This device belongs to portable device category because its radiating structure is allowed to be used within 20 centimeters of the body of the user. Limit for General Population/Uncontrolled exposure should be applied for this device, it is 1.6 W/kg as averaged over any 1 gram of tissue.

2.5. Applied Standard

The Specific Absorption Rate (SAR) testing specification, method, and procedure for this device is in accordance with the following standards:

- IEEE 1528-2013
- FCC 47 CFR Part 2 (2.1093:2013)
- ANSI/IEEE C95.1:2005
- KDB 248227 D01
- KDB 447498 D01
- KDB 648474 D04
- KDB 865664 D01
- KDB 941225 D01
- KDB 941225 D06

2.6. Environment of Test Site

Items	Required	Actual
Temperature (℃)	18-25	22~23
Humidity (%RH)	30-70	55~65

2.7. Test Configuration

The device was controlled by using a base station emulator. Communication between the device and the emulator was established by air link. The distance between the EUT and the antenna of the emulator is larger than 50 cm and the output power radiated from the emulator antenna is at least 30 dB smaller than the output power of EUT. The EUT was set from the emulator to radiate maximum output power during all tests.

Shenzhen Anbotek Compliance Laboratory Limited





FCC ID: 2APX7K5B

Page 10 of 108

3. Specific Absorption Rate (SAR)

3.1. Introduction

SAR is related to the rate at which energy is absorbed per unit mass in an object exposed to a radio field. The SAR distribution in a biological body is complicated and is usually carried out by experimental techniques or numerical modeling. The standard recommends limits for two tiers of groups, occupational/controlled and general population/uncontrolled, based on a person's awareness and ability to exercise control over his or her exposure. In general, occupational/controlled exposure limits are higher than the limits for general population/uncontrolled.

3.2. SAR Definition

The SAR definition is the time derivative (rate) of the incremental energy (dW) absorbed by (dissipated in) an incremental mass (dm) contained in a volume element (dv) of a given density (ρ).The equation description is as below:

$$SAR = \frac{d}{dt} \left(\frac{dW}{dm} \right) = \frac{d}{dt} \left(\frac{dW}{\rho dv} \right)$$

SAR is expressed in units of Watts per kilogram (W/kg)

SAR measurement can be either related to the temperature elevation in tissue by

$$SAR = C\left(\frac{\delta T}{\delta t}\right)$$

Where: C is the specific head capacity, δT is the temperature rise and δ tisthe exposure duration, or related to the electrical field in the tissue by

$$SAR = \frac{\sigma |E|^2}{\rho}$$

Where: σ is the conductivity of the tissue, ρ is the mass density of the tissue and E is the RMS electrical field strength.

However for evaluating SAR of low power transmitter, electrical field measurement is typically applied.

Shenzhen Anbotek Compliance Laboratory Limited

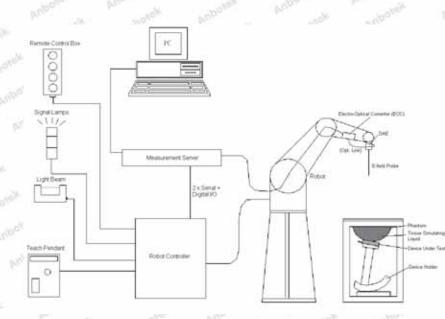




FCC ID: 2APX7K5B

Page 11 of 108

4. SAR Measurement System



DASY System Configurations

The DASY system for performance compliance tests is illustrated above graphically. This system consists of the following items:

- > A standard high precision 6-axis robot with controller, a teach pendant and software
- > A data acquisition electronic (DAE) attached to the robot arm extension
- > A dosimetric probe equipped with an optical surface detector system
- The electro-optical converter (EOC) performs the conversion between optical and electrical signals
- A measurement server performs the time critical tasks such as signal filtering, control of the robot operation and fast movement interrupts.
- > A probe alignment unit which improves the accuracy of the probe positioning
- > A computer operating Windows XP
- DASY software
- Remove control with teach pendant and additional circuitry for robot safety such as warming lamps, etc.
- The SAM twin phantom
- A device holder
- Tissue simulating liquid
- Dipole for evaluating the proper functioning of the system

components are described in details in the following sub-sections.

Shenzhen Anbotek Compliance Laboratory Limited



4.1. E-Field Probe

The SAR measurement is conducted with the dosimetric probe (manufactured by SPEAG). The probe is specially designed and calibrated for use in liquid with high permittivity. The dosimetric probe has special calibration in liquid at different frequency. This probe has a built in optical surface detection system to prevent from collision with phantom.

FCC ID: 2APX7K5B

E-Field Probe Specification <EX3DV4 Probe>

14.00				1.1	No. 1
Construction	Symmetrical design with triangular core Built-in shielding against static charges PEEK enclosure material (resistant to organic solvents, e.g., DGBE)			F	inte sente p
Frequency	10 MHz to 6 GHz; Linearity: ± 0.2 dB				
Directivity	 ± 0.3 dB in HSL (rotation around probe axis) ± 0.5 dB in tissue material (rotation normal to probe axis) 	nbari Sari			orek ator
Dynamic Range	10 μ W/g to 100 mW/g; Linearity: ± 0.2 dB (noise: typically < 1 μ W/g)	e P	T Photo of EX3	BDV4	142
Dimensions	Overall length: 330 mm (Tip: 20 mm) Tip diameter: 2.5 mm (Body: 12 mm) Typical distance from probe tip to dipole centers: 1 mm	hobatek Julianak	Antonia Internet Antonial	Anba Ada	botek Anbor

> E-Field Probe Calibration

Each probe needs to be calibrated according to a dosimetric assessment procedure with accuracy better than \pm 10%. The spherical isotropy shall be evaluated and within \pm 0.25dB. The sensitivity parameters (NormX, NormY, and NormZ), the diode compression parameter (DCP) and the conversion factor (ConvF) of the probe are tested. The calibration data can be referred to appendix C of this report.

4.2. Data Acquisition Electronics (DAE)

The data acquisition electronics (DAE) consists of a highly sensitive electrometer-grade preamplifier with auto-zeroing, a channel and gain-switching multiplexer, a fast 16 bit AD-converter and a command decoder and control logic unit. Transmission to the measurement server is accomplished through an optical downlink for data and status information as well as an optical uplink for commands and the clock.

The input impedance of the DAE is 200MOhm; the inputs are symmetrical and floating. Common mode rejection is above 80dB.

Shenzhen Anbotek Compliance Laboratory Limited

Address: 1/F., Building D, Sogood Science and Technology Park, Sanwel Community, Hangcheng Street, Bao'an District, Shenzhen, Guangdong, China. Tel:(86) 755-26066440 Fax: (86) 755-26014772 Email: service@anbotek.com

Antorra I

Page 12 of 108



FCC ID: 2APX7K5B

Page 13 of 108



Photo of DAE

4.3. Robot

The SPEAG DASY system uses the high precision robots (DASY5: TX60XL) type from Stäubli SA (France). For the 6-axis controller system, the robot controller version (DASY5: CS8c) from Stäubli is used. The Stäubli robot series have many features that are important for our application:

- > High precision (repeatability ±0.035 mm)
- High reliability (industrial design)
- Jerk-free straight movements
- Low ELF interference (the closed metallic construction shields against motor control fields)



Photo of DASY5

4. 4. Measurement Server

The measurement server is based on a PC/104 CPU board with CPU (DASY5: 400 MHz, Intel Celeron), chip disk (DASY5: 128 MB), RAM (DASY5: 128 MB). The necessary circuits for communication with the DAE electronic box, as well as the 16 bit AD converter system for optical

Shenzhen Anbotek Compliance Laboratory Limited



FCC ID: 2APX7K5B

Page 14 of 108

detection and digital I/O interface are contained on the DASY I/O board, which is directly connected to the PC/104 bus of the CPU board.

The measurement server performs all the real-time data evaluation for field measurements and surface detection, controls robot movements and handles safety operations.



Photo of Server for DASY5

Shenzhen Anbotek Compliance Laboratory Limited



FCC ID: 2APX7K5B

4.5. Phantom

<SAM Twin Phantom>

107	No wor part of a star
Shell Thickness	2 ± 0.2 mm;
	Center ear point: 6 ± 0.2 mm
Filling Volume	Approx. 25 liters
Dimensions	Length: 1000 mm; Width: 500 mm; Height: adjustable feet
Measurement	Left Hand, Right Hand, Flat
Areas	Phantom
	and and the second seco
	all spotter helicity have been all
	Photo of SAM Phantom

The bottom plate contains three pair of bolts for locking the device holder. The device holder positions are adjusted to the standard measurement positions in the three sections. A white cover is provided to tap the phantom during off-periods to prevent water evaporation and changes in the liquid parameters. On the phantom top, three reference markers are provided to identify the phantom position with respect to the robot.

<ELI4 Phantom>

x. 30 liters ellipse axis: 600 mm	
ellipse axis: 600 mm	
axis:400 mm	
ek ubinek Antonek k	
oolde Antonot Antonot	Photo of ELI4 Phantom
	han habarek Anbaren h ak Anbarek Anbarek balek Anbarek Anbarek habarek Anbarek Anbarek habarek Anbarek Anbarek

The ELI4 phantom is intended for compliance testing of handheld and body-mounted wireless devices in the frequency range of 30 MHz to 6 GHz. ELI4 is fully compatible with standard and all known tissue simulating liquids.

Shenzhen Anbotek Compliance Laboratory Limited



FCC ID: 2APX7K5B

Page 16 of 108

4.6. Device Holder

Anbotek Product Safety

The SAR in the phantom is approximately inversely proportional to the square of the distance between the source and the liquid surface. For a source at 5 mm distance, a positioning uncertainty of ± 0.5 mm would produce a SAR uncertainty of $\pm 20\%$. Accurate device positioning is therefore crucial for accurate and repeatable measurements. The positions in which the devices must be measured are defined by the standards.

The DASY device holder is designed to cope with different positions given in the standard. It has two scales for the device rotation (with respect to the body axis) and the device inclination (with respect to the line between the ear reference points). The rotation center for both scales is the ear reference point (ERP). Thus the device needs no repositioning when changing the angles.

The DASY device holder is constructed of low-loss POM material having the following dielectric parameters: relative permittivity ε = 3 and loss tangent δ = 0.02. The amount of dielectric material has been reduced in the closest vicinity of the device, since measurements have suggested that the influence of the clamp on the test results could thus be lowered.



Device Holder

Shenzhen Anbotek Compliance Laboratory Limited



FCC ID: 2APX7K5B

Page 17 of 108

4.7. Data Storage and Evaluation

Data Storage

The DASY software stores the assessed data from the data acquisition electronics as raw data (in microvolt readings from the probe sensors), together with all the necessary software parameters for the data evaluation (probe calibration data, liquid parameters and device frequency and modulation data) in measurement files. The post-processing software evaluates the desired unit and format for output each time the data is visualized or exported. This allows verification of the complete software setup even after the measurement and allows correction of erroneous parameter settings. For example, if a measurement has been performed with an incorrect crest factor parameter in the device setup, the parameter can be corrected afterwards and the data can be reevaluated.

The measured data can be visualized or exported in different units or formats, depending on the selected probe type (e.g., [V/m], [A/m], [mW/g]). Some of these units are not available in certain situations or give meaningless results, e.g., a SAR-output in a non-lose media, will always be zero. Raw data can also be exported to perform the evaluation with other software packages.

Data Evaluation

The DASY post-processing software (SEMCAD) automatically executes the following procedures to calculate the field units from the microvolt readings at the probe connector. The parameters used in the evaluation are stored in the configuration modules of the software:

Probe parameters:	- Sensitivity	Norm _i , a _{i0} , a _{i1} , a _i
	- Conversion factor	ConvFi
about sales antionals	- Diode compression point	dcp _i
Device parameters:	- Frequency	f fatootok Ant
	- Crest factor	cf
Media parameters:	- Conductivity	σ
at shortest an	- Density	ρ

These parameters must be set correctly in the software. They can be found in the component documents or they can be imported into the software from the configuration files issued for the DASY components. In the direct measuring mode of the multi-meter option, the parameters of the actual system setup are used. In the scan visualization and export modes, the parameters stored in the corresponding document files are used.

The first step of the evaluation is a linearization of the filtered input signal to account for the compression characteristics of the detector diode. The compensation depends on the input signal, the diode type and the DC-transmission factor from the diode to the evaluation electronics. If the exciting field is pulsed, the crest factor of the signal must be known to correctly compensate for peak power.

Shenzhen Anbotek Compliance Laboratory Limited



FCC ID: 2APX7K5B

Page 18 of 108

The formula for each channel can be given as:

$$V_i = U_i + U_i^2 \cdot \frac{cf}{dcp_i}$$

with V_i = compensated signal of channel i, (i = x, y, z)

 U_i = input signal of channel i, (i = x, y, z)

cf = crest factor of exciting field (DASY parameter)

dcp_i = diode compression point (DASY parameter)

From the compensated input signals, the primary field data for each channel can be evaluated:

E-field Probes: $E_i = \sqrt{\frac{V_i}{Norm_i \cdot ConvF}}$

H-field Probes: $H_i = \sqrt{V_i} \cdot \frac{a_{i0} + a_{i1}f + a_{i2}f^2}{f}$

with V_i = compensated signal of channel i,(i = x, y, z)

Norm_i= sensor sensitivity of channel i, (i = x, y, z), $\mu V/(V/m)^2$ for E-field Probes

ConvF= sensitivity enhancement in solution

a_{ij}= sensor sensitivity factors for H-field probes

f = carrier frequency [GHz]

E_i= electric field strength of channel i in V/m

H_i= magnetic field strength of channel i in A/m

The RSS value of the field components gives the total field strength (Hermitian magnitude):

$$\mathbf{E}_{tot} = \sqrt{\mathbf{E}_x^2 + \mathbf{E}_y^2 + \mathbf{E}_z^2}$$

The primary field data are used to calculate the derived field units.

$$SAR = E_{tot}^2 \cdot \frac{\sigma}{\rho \cdot 1000}$$

with SAR = local specific absorption rate in mW/g

Etot= total field strength in V/m

 σ = conductivity in [mho/m] or [Siemens/m]

 ρ = equivalent tissue density in g/cm³

Note that the density is set to 1, to account for actual head tissue density rather than the density of the tissue simulating liquid.

Shenzhen Anbotek Compliance Laboratory Limited

FCC ID: 2APX7K5B

Page 19 of 108

5. Test Equipment List

Manufacturar	Nome of Equipment	Turne/Madal	Carial Number	Calib	ration
Manufacturer	Name of Equipment	Type/Model	Serial Number	Last Cal.	Due Date
SPEAG	835MHz System Validation Kit	D835V2	4d154	Jun. 16,2018	Jun. 15,2021
SPEAG	1900MHz System Validation Kit	D1900V2	5d175	Jun. 15, 2019	Jun. 14, 2022
SPEAG	2450MHz System Validation Kit	D2450V2	910	Jun. 15,2018	Jun. 14,2021
SPEAG	Data Acquisition Electronics	DAE4	387	Sept. 06,2018	Sept. 05,2019
SPEAG	Dosimetric E-Field Probe	EX3DV4	7396	May 06,2019	May 05,2020
R&S	UNIVERSAL RADIO COMMUNICATION TESTER	CMU 200	117888	Nov. 05, 2018	Nov. 04, 2019
Agilent	ENA Series Network Analyzer	E5071C	MY46317418	May 22, 2019	May 21, 2020
SPEAG	DAK	DAK-3.5	1226	NCR	NCR
SPEAG	SAM Twin Phantom	QD000P40CD	1802	NCR	NCR
AR	Amplifier	ZHL-42W	QA1118004	NCR	NCR
Agilent	Power Meter	N1914A	MY50001102	Dec. 06, 2018	Nov. 06, 2019
Agilent	Power Sensor	N8481H	MY51240001	Dec. 06, 2018	Nov. 06, 2019
R&S	Spectrum Analyzer	N9020A	MY51170037	May.23, 2018	May. 22, 2019
Agilent	Signal Generation	N5182A	MY48180656	May.23, 2018	May. 22, 2019
Worken	Directional Coupler	0110A05601O- 10	COM5BNW1A2	May.23, 2018	May. 22, 2019

Note:

- 1. The calibration certificate of DASY can be referred to appendix C of this report.
- 2. The dipole calibration interval can be extended to 3 years with justification. The dipoles are also not physically damaged, or repaired during the interval.
- 3. The Insertion Loss calibration of Dual Directional Coupler and Attenuator were characterized via the network analyzer and compensated during system check.
- 4. The dielectric probe kit was calibrated via the network analyzer, with the specified procedure (calibrated in pure water) and calibration kit (standard) short circuit, before the dielectric measurement. The specific procedure and calibration kit are provided by Agilent.
- 5. In system check we need to monitor the level on the power meter, and adjust the power amplifier level to have precise power level to the dipole; the measured SAR will be normalized to 1W input power according to the ratio of 1W to the input power to the dipole. For system check, the calibration of the power amplifier is deemed not critically required for correct measurement; the power meter is critical and we do have calibration for it

Shenzhen Anbotek Compliance Laboratory Limited

Anbotek Product Safety

FCC ID: 2APX7K5B

Page 20 of 108

6. Tissue Simulating Liquids

For the measurement of the field distribution inside the SAM phantom with DASY, the phantom must be filled with around 25 liters of homogeneous body tissue simulating liquid. For head SAR testing, the liquid height from the ear reference point (ERP) of the phantom to the liquid top surface is larger than 15 cm, which is shown in Fig. 6.1. For body SAR testing, the liquid height from the center of the flat phantom to the liquid top surface is larger than 15 cm, which is shown as followed:



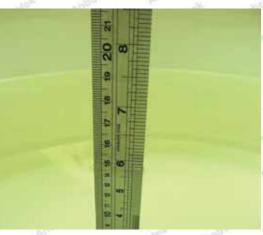


Photo of 835HSL Liquid Height for Head SAR

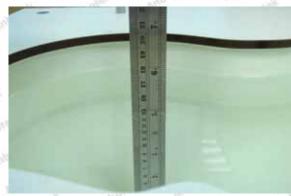


Photo of 1900HSL Liquid Height for Head SAR

Photo of 2450HSL Liquid Height for Head SAR

Photo of 835MSL Liquid Height for Body SAR

Photo of 1900MSL Liquid Height for Body SAR



Photo of 2450MSL Liquid Height for Body SAR

Shenzhen Anbotek Compliance Laboratory Limited Address: 1/F., Building D, Sogood Science and Technology Park, Sanwel Community Hangcheng Street, Bao'an District, Shenzhen, Guangdong, China.

Tel:(86) 755-26066440 Fax: (86) 755-26014772 Email: service@anbotek.com

FCC ID: 2APX7K5B

Page 21 of 108

Frequency (MHz)	Wate r (%)	Sugar (%)	Cellulose (%)	Salt (%)	Prevento I (%)	DGBE (%)	Conductivity (σ)	Permittivity (εr)
				For Hea	ad		·	
900	40.3	57.9	0.2	1.4	0.2	0	0.97	41.5
1750	55.2	0	0	0.3	0	44.5	1.37	40.1
1800,1900,2000	55.2	0	0	0.3	0	44.5	1.40	40.0
2450	55.0	0	0 000	0	0	45.0	1.80	39.2
2600	54.8	0	0	0.1	0	45.1	1.96	39.0
				For Boo	ły			
900	50.8	48.2	0.000	0.9	0.1	0	0.97	55.2
1750	70.2	0	0 500	0.4	0	29.4	1.49	53.4
1800,1900,2000	70.2	0	0	0.4	0	29.4	1.52	53.3
2450	68.6	0	0	0	0	31.4	1.95	52.7
2600	68.1	0	0	0.1	0	31.8	2.16	52.5

The following table gives the recipes for tissue simulating liquid.

The following table shows the measuring results for simulating liquid.

	Measured	Target ⁻	Tissue		Measure	ed Tissue	•		
Tissue Type	Frequenc y (MHz)	٤ _r	σ	٤r	Dev. (%)	σ	Dev. (%)	Liquid Temp.	Test Data
900HSL	850	41.50	0.97	41.68	0.43	0.96	-1.03	21.6	08/14/2019
900MSL	850	55.00	1.05	55.26	0.47	1.06	0.95	22.0	08/15/2019
1900HSL	1900	40.00	1.40	40.19	0.47	1.43	2.14	21.8	08/19/2019
1900MSL	1900	53.30	1.52	53.41	0.21	1.53	0.66	21.9	08/20/2019
2450HSL	2450	39.20	1.80	40.46	3.21	1.88	4.44	22.1	08/22/2019
2450MSL	2450	52.70	1.95	51.89	-1.54	1.97	1.03	22.3	08/23/2019

Shenzhen Anbotek Compliance Laboratory Limited

Address: 1/F., Building D, Sogood Science and Technology Park, Sanwel Community, Hangcheng Street, Bao'an District, Shenzhen, Guangdong, China. Tel:(86) 755-26066440 Fax: (86) 755-26014772 Email: service@anbotek.com

Anbotek Product Safety

FCC ID: 2APX7K5B

Page 22 of 108

7. System Verification Procedures

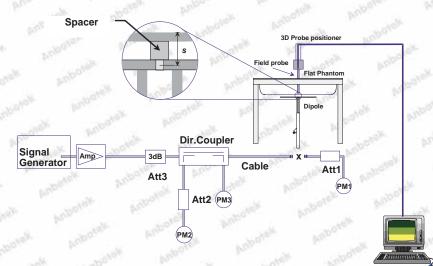
Each DASY system is equipped with one or more system validation kits. These units, together with the predefined measurement procedures within the DASY software, enable the user to conduct the system performance check and system validation. System validation kit includes a dipole, tripod holder to fix it underneath the flat phantom and a corresponding distance holder.

Purpose of System Performance check

The system performance check verifies that the system operates within its specifications. System and operator errors can be detected and corrected. It is recommended that the system performance check be performed prior to any usage of the system in order to guarantee reproducible results. The system performance check uses normal SAR measurements in a simplified setup with a well characterized source. This setup was selected to give a high sensitivity to all parameters that might fail or vary over time. The system check does not intend to replace the calibration of the components, but indicates situations where the system uncertainty is exceeded due to drift or failure.

System Setup

In the simplified setup for system evaluation, the EUT is replaced by a calibrated dipole and the power source is replaced by a continuous wave that comes from a signal generator. The calibrated dipole must be placed beneath the flat phantom section of the SAM twin phantom with the correct distance holder. The distance holder should touch the phantom surface with a light pressure at the reference marking and be oriented parallel to the long side of the phantom. The equipment setup is shown below:



System Setup for System Evaluation

Shenzhen Anbotek Compliance Laboratory Limited

Address: 1/F., Building D, Sogood Science and Technology Park, Sanwel Community, Hangcheng Street, Bao'an District, Shenzhen, Guangdong, China. Tel:(86) 755–26066440 Fax: (86) 755–26014772 Email: service@anbotek.com



FCC ID: 2APX7K5B

Page 23 of 108



Photo of Dipole Setup

Validation Results

Comparing to the original SAR value provided by SPEAG, the verification data should be within its specification of 10%. The table below shows the target SAR and measured SAR after normalized to 1W input power. It indicates that the system performance check can meet the variation criterion and the plots can be referred to Appendix A of this report.

Frequenc y (MHz)	Liquid Type	Power fed onto reference dipole (mW)	Targeted SAR (W/kg)	Measured SAR (W/kg)	Normalized SAR (W/kg)	Deviation (%)	Date
850	Head	250	9.50	2.32	9.28	-2.32	08/14/2019
850	Body	250	9.52	2.37	9.48	-0.42	08/15/2019
1900	Head	250	39.70	9.56	38.24	-3.68	08/19/2019
1900	Body	250	39.60	10.25	41.00	3.54	08/20/2019
2450	Head	250	52.00	12.86	51.44	-1.08	08/22/2019
2450	Body	250	51.10	12.53	50.12	-1.92	08/23/2019

Target and Measurement SAR after Normalized

Shenzhen Anbotek Compliance Laboratory Limited





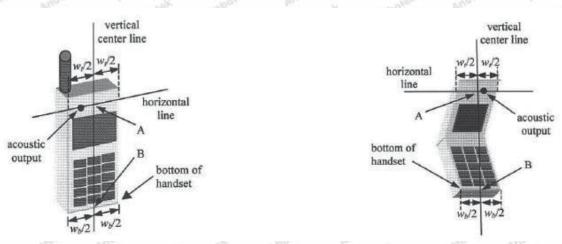
FCC ID: 2APX7K5B

Page 24 of 108

8. EUT Testing Position

8.1. Define two imaginary lines on the handset

- (a) The vertical centerline passes through two points on the front side of the handset the midpoint of the width w_t of the handset at the level of the acoustic output, and the midpoint of the width w_b of the bottom of the handset.
- (b) The horizontal line is perpendicular to the vertical centerline and passes through the center of the acoustic output. The horizontal line is also tangential to the face of the handset at point A.
- (c) The two lines intersect at point A. Note that for many handsets, point A coincides with the center of the acoustic output; however, the acoustic output may be located elsewhere on the horizontal line. Also note that the vertical centerline is not necessarily parallel to the front face of the handset, especially for clamshell handsets, handsets with flip covers, and other irregularly shaped handsets.



Handset Vertical and Horizontal Reference Lines

Shenzhen Anbotek Compliance Laboratory Limited

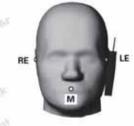


FCC ID: 2APX7K5B

Page 25 of 108

8.2. Position for Cheek/Touch

- (a) To position the device with the vertical center line of the body of the device and the horizontal line crossing the center piece in a plane parallel to the sagittal plane of the phantom. While maintaining the device in this plane, align the vertical center line with the reference plane containing the three ear and mouth reference point (M: Mouth, RE: Right Ear, and LE: Left Ear) and align the center of the ear piece with the line RE-LE.
- (b) To move the device towards the phantom with the ear piece aligned with the line LE-RE until the phone touched the ear. While maintaining the device in the reference plane and maintaining the phone contact with the ear, move the bottom of the phone until any point on the front side is in contact with the cheek of the phantom or until contact with the ear is lost.



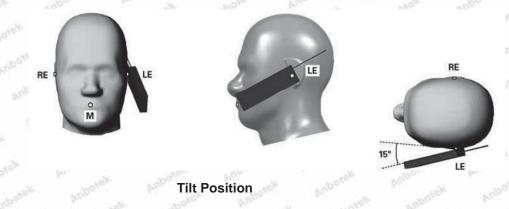
....



Cheek Position

8.3. Position for Ear / 15°Tilt

- (a) To position the device in the "cheek" position described above.
- (b) While maintaining the device the reference plane described above and pivoting against the ear, moves it outward away from the mouth by an angle of 15 degrees or until contact with the ear is lost (see Fig. 8.3).



Shenzhen Anbotek Compliance Laboratory Limited



Product Safety

Anbotek

Report No.: R0219080013W

FCC ID: 2APX7K5B

Page 26 of 108

8.4. Body Worn Position

Body-worn operating configurations are tested with the belt-clips and holsters attached to the device and positioned against a flat phantom in a normal use configuration. Per KDB 648474 D04, body-worn accessory exposure is typically related to voice mode operations when handsets are carried in body-worn accessories. The body-worn accessory procedures in FCC KDB 447498 D01 should be used to test for body-worn accessory SAR compliance, without a headset connected to it. This enables the test results for such configuration to be compatible with that required for hotspot mode when the body-worn accessory test separation distance is greater than or equal to that required for hotspot mode, when applicable. When the reported SAR for body-worn accessory, measured without a headset connected to the handset is < 1.2 W/kg, the highest reported SAR configuration for that wireless mode and frequency band should be repeated for that body-worn accessory with a handset attached to the handset.

Accessories for body-worn operation configurations are divided into two categories: those that do not contain metallic components and those that do contain metallic components. When multiple accessories that do not contain metallic components are supplied with the device, the device is tested with only the accessory that dictates the closest spacing to the body. Then multiple accessories that contain metallic components are test with the device with each accessory. If multiple accessories share an identical metallic component (i.e. the same metallic belt-chip used with different holsters with no other metallic components) only the accessory that dictates the closest spacing to the body is tested.

wowend yets

Body Worn Position

Shenzhen Anbotek Compliance Laboratory Limited





FCC ID: 2APX7K5B

Page 27 of 108

9. Measurement Procedures

The measurement procedures are as follows:

- (a) Use base station simulator (if applicable) or engineering software to transmit RF power continuously (continuous Tx) in the middle channel.
- (b) Keep EUT to radiate maximum output power or 100% duty factor (if applicable)
- (c) Measure output power through RF cable and power meter.
- (d) Place the EUT in the positions as setup photos demonstrates.
- (e) Set scan area, grid size and other setting on the DASY software.
- (f) Measure SAR transmitting at the middle channel for all applicable exposure positions.
- (g) Identify the exposure position and device configuration resulting the highest SAR
- (h) Measure SAR at the lowest and highest channels at the worst exposure position and device configuration if applicable.

According to the test standard, the recommended procedure for assessing the peak spatial-average SAR value consists of the following steps:

- (a) Power reference measurement
- (b) Area scan
- (c) Zoom scan
- (d) Power drift measurement

9.1. Spatial Peak SAR Evaluation

The procedure for spatial peak SAR evaluation has been implemented according to the test standard. It can be conducted for 1g and 10g, as well as for user-specific masses. The DASY software includes all numerical procedures necessary to evaluate the spatial peak SAR value.

The base for the evaluation is a "cube" measurement. The measured volume must include the 1g and 10g cubes with the highest averaged SAR values. For that purpose, the center of the measured volume is aligned to the interpolated peak SAR value of a previously performed area scan.

The entire evaluation of the spatial peak values is performed within the post-processing engine (SEMCAD). The system always gives the maximum values for the 1g and 10g cubes. The algorithm to find the cube with highest averaged SAR is divided into the following stages:

- (a) Extraction of the measured data (grid and values) from the Zoom Scan
- (b) Calculation of the SAR value at every measurement point based on all stored data (A/D values and measurement parameters)
- (c) Generation of a high-resolution mesh within the measured volume
- (d) Interpolation of all measured values form the measurement grid to the high-resolution grid
- (e) Extrapolation of the entire 3-D field distribution to the phantom surface over the distance from Shenzhen Anbotek Compliance Laboratory Limited



FCC ID: 2APX7K5B

Page 28 of 108

Report No.: R0219080013W sensor to surface

(f) Calculation of the averaged SAR within masses of 1g and 10g

9.2. Power Reference Measurement

The Power Reference Measurement and Power Drift Measurements are for monitoring the power drift of the device under test in the batch process. The minimum distance of probe sensors to surface determines the closest measurement point to phantom surface. This distance cannot be smaller than the distance of sensor calibration points to probe tip as defined in the probe properties.

9.3. Area Scan Procedures

The area scan is used as a fast scan in two dimensions to find the area of high field values, before doing a fine measurement around the hot spot. The sophisticated interpolation routines implemented in DASY software can find the maximum found in the scanned area, within a range of the global maximum. The range (in dB0 is specified in the standards for compliance testing. For example, a 2 dB range is required in IEEE standard 1528 and IEC 62209 standards, whereby 3 dB is a requirement when compliance is assessed in accordance with the ARIB standard (Japan), if only one zoom scan follows the area scan, then only the absolute maximum will be taken as reference. For cases where multiple maximums are detected, the number of zoom scans has to be increased accordingly.

Area scan parameters extracted from FCC KDB 865664 D01 SAR measurement 100 MHz to 6 GHz.

	\leq 3 GHz	> 3 GHz
Maximum distance from closest measurement point (geometric center of probe sensors) to phantom surface	5 ± 1 mm	$\frac{1}{2} \cdot \delta \cdot \ln(2) \pm 0.5 \text{ mm}$
Maximum probe angle from probe axis to phantom surface normal at the measurement location	$30^{\circ}\pm1^{\circ}$	$20^{\circ}\pm1^{\circ}$
	\leq 2 GHz: \leq 15 mm 2 - 3 GHz: \leq 12 mm	3 – 4 GHz: ≤ 12 mm 4 – 6 GHz: ≤ 10 mm
Maximum area scan spatial resolution: Δx_{Area} , Δy_{Area}	When the x or y dimension of measurement plane orientation the measurement resolution in x or y dimension of the test of measurement point on the test	on, is smaller than the above, must be \leq the corresponding evice with at least one

Shenzhen Anbotek Compliance Laboratory Limited

FCC ID: 2APX7K5B

Page 29 of 108

9.4. Zoom Scan Procedures

Zoom scans are used assess the peak spatial SAR values within a cubic averaging volume containing 1 gram and 10gram of simulated tissue. The zoom scan measures points (refer to table below) within a cube shoes base faces are centered on the maxima found in a preceding area scan job within the same procedure. When the measurement is done, the zoom scan evaluates the averaged SAR for 1 gram and 10 gram and displays these values next to the job's label. Zoom scan parameters extracted from FCC KDB 865664 D01 SAR measurement 100 MHz to 6 GHz.

			≤3 GHz	> 3 GHz		
Maximum zoom scan	spatial reso	olution: Δx _{Zoom} , Δy _{Zoom}	$\leq 2 \text{ GHz:} \leq 8 \text{ mm}$ 2 - 3 GHz: $\leq 5 \text{ mm}^*$	$3 - 4 \text{ GHz:} \le 5 \text{ mm}^*$ $4 - 6 \text{ GHz:} \le 4 \text{ mm}^*$		
	uniform	grid: $\Delta z_{Zoom}(n)$	$\leq 5 \text{ mm}$	3 – 4 GHz: ≤ 4 mm 4 – 5 GHz: ≤ 3 mm 5 – 6 GHz: ≤ 2 mm		
Maximum zoom scan spatial resolution, normal to phantom surface	graded	$\Delta z_{Zoom}(1)$: between 1 st two points closest to phantom surface	\leq 4 mm	3 – 4 GHz: ≤ 3 mm 4 – 5 GHz: ≤ 2.5 mm 5 – 6 GHz: ≤ 2 mm		
	grid	∆z _{Zoom} (n>1): between subsequent points	≤1.5·∆z	_{Zoom} (n-1)		
Minimum zoom scan volume	x, y, z	•	\geq 30 mm	3 – 4 GHz: ≥ 28 mm 4 – 5 GHz: ≥ 25 mm 5 – 6 GHz: ≥ 22 mm		

Note: δ is the penetration depth of a plane-wave at normal incidence to the tissue medium; see draft standard IEEE P1528-2011 for details.

* When zoom scan is required and the <u>reported</u> SAR from the area scan based 1-g SAR estimation procedures of KDB 447498 is ≤ 1.4 W/kg, ≤ 8 mm, ≤ 7 mm and ≤ 5 mm zoom scan resolution may be applied, respectively, for 2 GHz to 3 GHz, 3 GHz to 4 GHz and 4 GHz to 6 GHz.

Shenzhen Anbotek Compliance Laboratory Limited



FCC ID: 2APX7K5B

Page 30 of 108

9.5. Volume Scan Procedures

The volume scan is used for assess overlapping SAR distributions for antennas transmitting in different frequency bands. It is equivalent to an oversized zoom scan used in standalone measurements. The measurement volume will be used to enclose all the simultaneous transmitting antennas. For antennas transmitting simultaneously in different frequency bands, the volume scan is measured separately in each frequency band. In order to sum correctly to compute the 1g aggregate SAR, the EUT remain in the same test position for all measurements and all volume scan use the same spatial resolution and grid spacing. When all volume scan were completed, the software, SEMCAD postprocessor can combine and subsequently superpose these measurement data to calculating the multiband SAR.

9.6. Power Drift Monitoring

All SAR testing is under the EUT install full charged battery and transmit maximum output power. In DASY measurement software, the power reference measurement and power drift measurement procedures are used for monitoring the power drift of EUT during SAR test. Both these procedures measure the field at a specified reference position before and after the SAR testing. The software will calculate the field difference in dB. If the power drift more than 5%, the SAR will be retested.

Shenzhen Anbotek Compliance Laboratory Limited





FCC ID: 2APX7K5B

10. Conducted Power

100	100	2		250		
Burst Av	verage Pow	ver (dBm)	Frame-A	verage Pow	/er (dBm)	
128	190	251	128	190	251	
824.2	836.6	848.6	824.2	836.6	848.6	
31.20	31.13	31.14	22.17	22.11	22.11	
31.21	31.05	31.25	22.18	22.22	22.22	
28.58	28.53	28.34	22.56	22.51	22.32	
26.35	26.34	26.28	22.09	22.08	22.02	
25.55	25.39	25.45	22.54	22.38	22.44	
Burst Av	erage Pow	ver (dBm)	Frame-A	verage Pow	age Power (dBm)	
512	661	810	512	661	810	
1850.2	1880.0	1909.8	1850.2	1880.0	1909.8	
28.18	28.06	28.09	19.15	19.46	19.46	
27.79	27.82	27.38	18.76	18.35	18.35	
24.20	24.17	24.18	18.18	18.15	18.16	
23.18	23.07	23.08	18.92	18.81	18.82	
22.68	22.55	22.42	19.67	19.54	19.41	
	128 824.2 31.20 31.21 28.58 26.35 25.55 Burst Av 512 1850.2 28.18 27.79 24.20 23.18	128 190 824.2 836.6 31.20 31.13 31.21 31.05 28.58 28.53 26.35 26.34 25.55 25.39 Burst Average Power 512 661 1850.2 1880.0 28.18 28.06 27.79 27.82 24.20 24.17 23.18 23.07	824.2836.6848.631.2031.1331.1431.2131.0531.2528.5828.5328.3426.3526.3426.2825.5525.3925.45Burst Average Power (dBm)5126618101850.21880.01909.828.1828.0628.0927.7927.8227.3824.2024.1724.1823.1823.0723.08	128190251128824.2836.6848.6824.231.2031.1331.1422.1731.2131.0531.2522.1828.5828.5328.3422.5626.3526.3426.2822.0925.5525.3925.4522.54Burst Average Power (dBm)Frame-Average5126618105121850.21880.01909.81850.228.1828.0628.0919.1527.7927.8227.3818.7624.2024.1724.1818.1823.1823.0723.0818.92	128 190 251 128 190 824.2 836.6 848.6 824.2 836.6 31.20 31.13 31.14 22.17 22.11 31.21 31.05 31.25 22.18 22.22 28.58 28.53 28.34 22.56 22.51 26.35 26.34 26.28 22.09 22.08 25.55 25.39 25.45 22.54 22.38 Burst Average Power (dBm) Frame-Average Power 661 810 512 661 1850.2 1880.0 1909.8 1850.2 1880.0 28.18 28.06 28.09 19.15 19.46 27.79 27.82 27.38 18.76 18.35 24.20 24.17 24.18 18.18 18.15 23.18 23.07 23.08 18.92 18.81 18.15	

<GSM Conducted power>

Remark: The frame-averaged power is linearly scaled the maximum burst averaged power over 8 time slots.

The calculated method are shown as below:

Frame-averaged power = Maximum burst averaged power (1 Tx Slot) – 9.03 dB

Frame-averaged power = Maximum burst averaged power (2 Tx Slots) – 6.02 dB

Frame-averaged power = Maximum burst averaged power (3 Tx Slots) - 4.26 dB

Frame-averaged power = Maximum burst averaged power (4 Tx Slots) – 3.01 dB

Note:

- Per KDB 447498 D01, the maximum output power channel is used for SAR testing and for further SAR test reduction
- For Head SAR testing, GSM should be evaluated, therefore the EUT was set in GSM Voice for GSM850and PCS1900.
- 3. For Body SAR testing, GPRS should be evaluated, therefore the EUT was set inGPRS 4 Tx slots for GSM850and PCS1900 due to its highest frame-average power.

Shenzhen Anbotek Compliance Laboratory Limited



d

Report No.: R0219080013W <WCDMA Conducted Power>

FCC ID: 2APX7K5B

The following tests were conducted according to the test requirements outlines in 3GPP TS 34.121 specification. A summary of these settings are illustrated below:

HSDPA Setup Configuration:

- a. The EUT was connected to Base Station Agilent E5515C referred to the Setup Configuration.
- b. The RF path losses were compensated into the measurements.
- c. A call was established between EUT and Base Station with following setting:
 - i. Set Gain Factors (β_c and $\beta_d)$ and parameters were set according to each
 - ii. Specific sub-test in the following table, C10.1.4, quoted from the TS 34.121
 - iii. Set RMC 12.2Kbps + HSDPA mode.
 - iv. Set Cell Power = -86 dBm
 - v. Set HS-DSCH Configuration Type to FRC (H-set 1, QPSK)
 - vi. Select HSDPA Uplink Parameters
 - vii. Set Delta ACK, Delta NACK and Delta CQI = 8
 - viii. Set Ack-Nack Repetition Factor to 3
 - ix. Set CQI Feedback Cycle (k) to 4 ms
 - x. Set CQI Repetition Factor to 2
 - xi. Power Ctrl Mode = All Up bits
 - The transmitted maximum output power was recorded.

Sub-test	βο	βa	βd (SF)	βс/βа	βнs (Note1, Note 2)	CM (dB) (Note 3)	MPR (dB) (Note 3)
1	2/15	15/15	64	2/15	4/15	0.0	0.0
2	12/15	15/15	64	12/15	24/15	1.0	0.0
3	(Note 4) 15/15	(Note 4) 8/15	64	(Note 4) 15/8	30/15	1.5	0.5
4	15/15	4/15	64	15/4	30/15	1.5	0.5
Note 2:	For the HS-E Magnitude (B	OPCCH pow EVM) with H	er mask requ S-DPCCH te	$_{s}$ = 30/15 * β_{c} . uirement test in cla est in clause 5.13.1 \leq and Δ_{NACK} = 30/1	A, and HSDF	PA EVM with ph	ase
	with $\beta_{hs} = 2$		13. IAA, AAC		5 with p_{hs} -	p_c , and	u 2001 - 24/13
	DPCCH the	MPR is base		. For all other com ative CM difference r releases.			
Note 4:	For subtest 2	2 the β₀/β₀ ra	atio of 12/15 f	for the TFC during a factors for the ref			

Table C.10.1.4: β values for transmitter characteristics tests with HS-DPCCH

Setup Configuration

Shenzhen Anbotek Compliance Laboratory Limited

FCC ID: 2APX7K5B

Page 33 of 108

HSUPA Setup Configuration:

- a. The EUT was connected to Base Station Agilent E5515C referred to the Setup Configuration.
- b. The RF path losses were compensated into the measurements.
- c. A call was established between EUT and Base Station with following setting * :
 - i. Call Configs = 5.2B, 5.9B, 5.10B, and 5.13.2B with QPSK
 - ii. Set the Gain Factors (β_c and β_d) and parameters (AG Index) were set according to each specific sub-test in the following table, C11.1.3, quoted from the TS 34.121
 - iii. Set Cell Power = -86 dBm
 - iv. Set Channel Type = 12.2k + HSPA
 - v. Set UE Target Power
 - vi. Power Ctrl Mode= Alternating bits
 - vii. Set and observe the E-TFCI
 - viii. Confirm that E-TFCI is equal to the target E-TFCI of 75 for sub-test 1, and other subtest's E-TFCI
 - I. The transmitted maximum output power was recorded.

test	βε	βa	β _d (SF)	βc/βa	βнs (Note1)	βec	βed (Note 5) (Note 6)	βed (SF)	β _{ed} (Codes)	CM (dB) (Note 2)	MPR (dB) (Note 2)	AG Index (Note 6)	E- TFCI
1	11/15 (Note 3)	15/15 (Note 3)	64	11/15 (Note 3)	22/15	209/2 25	1309/225	4	1	1.0	0.0	20	75
2	6/15	15/15	64	6/15	12/15	12/15	94/75	4	1	3.0	2.0	12	67
3	15/15	9/15	64	15/9	30/15	30/15	βed1: 47/15 βed2: 47/15	4 4	2	2.0	1.0	15	92
4	2/15	15/15	64	2/15	4/15	2/15	56/75	4	1	3.0	2.0	17	71
5	15/15 (Note 4)	15/15 (Note 4)	64	15/15 (Note 4)	30/15	24/15	134/15	4	1	1.0	0.0	21	81
		- 4)											
Note 1 Note 2 Note 3	CM = and E For su	ANACK and 1 for β ₀ /β -DPCCH ibtest 1 t	the MP he β_0/β	= 30/15 v 5, βhs/βc R is bas a ratio of	ed on the 11/15 for	For all ot relative the TFC	her combinatio CM difference during the m	e. easure	ement peri	od (TF1,	TF0) is	achieved	
Note 2	CM = and E For su setting For su setting In cas	Δινικκ and 1 for βe/β -DPCCH ibtest 1 the g the sign ibtest 5 the g the sign	$h_d = 12/1$ the MF he β _d /β halled g halled g halled g	30/15 v 5. β _{hi} /β _c R is bas a ratio of a ratio of a ratio of a ratio of a ratio of L using	=24/15. F ed on the 11/15 for ors for the 15/15 for ors for the	For all ot relative the TFC reference the TFC reference	her combinatio CM difference	e. easure TF1) tr easure TF1) tr	ement peri $\beta_c = 10/1$ ement peri $\beta_c = 14/1$	od (TF1, 5 and β od (TF1, 5 and β	TF0) is = 15/15 TF0) is = 15/15	achieved achieved	ьу

Table C.11.1.3: β values for transmitter characteristics tests with HS-DPCCH and E-DCH

Setup Configuration

Shenzhen Anbotek Compliance Laboratory Limited



FCC ID: 2APX7K5B

Page 34 of 108

Band	W	CDMA Ban	d 2	W	WCDMA Band 5			
TX Channel	9262	9400	9538	4132	4183	4233		
Frequency (MHz)	1852.4	1880.0	1907.6	826.4	836.6	846.6		
RMC 12.2Kbps	22.53	22.17	22.06	23.55	23.22	23.35		
AMR	22.07	22.21	21.81	23.12	23.09	22.62		
HSDPA Subtest-1	21.24	20.95	20.63	22.20	22.40	22.24		
HSDPA Subtest-2	20.02	20.03	20.54	22.42	22.08	22.29		
HSDPA Subtest-3	19.99	19.97	20.13	20.93	21.57	21.82		
HSDPA Subtest-4	20.11	20.59	20.89	22.31	22.17	22.57		
HSUPA Subtest-1	20.75	20.19	20.29	22.75	22.31	23.06		
HSUPA Subtest-2	21.63	21.66	21.48	22.37	22.51	22.66		
HSUPA Subtest-3	21.06	20.94	21.30	22.57	22.18	22.30		
HSUPA Subtest-4	21.34	22.26	22.30	22.55	22.23	22.42		
HSUPA Subtest-5	21.34	21.83	22.04	22.65	22.86	22.69		

General Note

Per KDB 941225 D01 v02, RMC 12.2kbps setting is used to evaluate SAR. If AMR 12.2kbps power is
 < 0.25dB higher than RMC 12.2kbps, SAR tests with AMR 12.2kbps can be excluded.

- 2. By design, AMR and HSDPA/HSUPA RF power will not be larger than RMC 12.2kbps, detailed information is included in Tune-up Procure exhibit.
 - It is expected by the manufacturer that MPR for some HSDPA/HSUPA subtests may differ from the specification of 3GPP, according to the chipset implementation in this model. The implementation and expected deviation are detailed in tune-up procedure exhibit.

Shenzhen Anbotek Compliance Laboratory Limited



Report No.: R0219080013W <WIFI 2.4GHz Conducted Power>

FCC ID: 2APX7K5B

Page 35 of 108

Mode	Channel	Frequency (MHz)	Conducted Average Power (dBm)	Test Rate Data
	oren 1 Martine	2412	12.14	1 Mbps
802.11b	6	2437	12.50	1 Mbps
	11	2462	13.20	1 Mbps
	1	2412	11.02	6 Mbps
802.11g	6	2437	11.66	6 Mbps
	11	2462	11.97	6 Mbps
802.11n(20MHz)	1,000	2412	9.95	MCS0
	6	2437	10.70	MCS0
	11	2462	10.84	MCS0

Note:

1. Per KDB 447498 D01, the 1-g SAR test exclusion thresholds for 100 MHz to 6 GHz at *test separation* $distances \le 50$ mm are determined by:

[(max. power of channel, including tune-up tolerance, mW) / (min. test separation distance,

mm)] $\cdot [\sqrt{f(GHz)}] \le 3.0$ for 1-g SAR, where

f(GHz) is the RF channel transmit frequency in GHz

Power and distance are rounded to the nearest mW and mm before calculation

3	Mode	Frequency (GHz)	Tune-up Power (dBm)	Max. Power (mW)	Test distance (mm)	Result	exclusion thresholds for 1-g SAR
s	802.11b	2.462	13.20	20.893	5	6.557	3.0
	802.11g	2.462	11.97	15.740	5	4.939	3.0

The result is rounded to one decimal place for comparison

2. Base on the result of note1, RF exposure evaluation of 802.11 b and g mode is required.

- 3. Per KDB 248227 D01, choose the highest output power channel to test SAR and determine further SAR exclusion.
- 4. Per KDB 248227 D01, In the 2.4 GHz band, separate SAR procedures are applied to DSSS and OFDM configurations to simplify DSSS test requirements. SAR is not required for the following 2.4 GHz OFDM conditions:

1) When KDB Publication 447498 SAR test exclusion applies to the OFDM configuration.

2) When the highest reported SAR for DSSS is adjusted by the ratio of OFDM to DSSS specified maximum output power and the adjusted SAR is \leq 1.2 W/kg.

- 5. According to chapter 12 of this report, the max report SAR of 802.11b mode is 0.315 W/Kg, and
- 0.315 W/Kg $\times \frac{4.939}{6.557}$ = 0.237 W/Kg which is smaller than 1.2 W/Kg, so SAR evaluation of 802.11g mode

is not required. And the same for 802.11n.

Shenzhen Anbotek Compliance Laboratory Limited

Report No.: R0219080013W <Bluetooth Conducted Power>

FCC ID: 2APX7K5B

Page 36 of 108

Mode	Channel	Frequency (MHz)	Conducted Peak Power (dBm)		
	00	2402	5.976		
GFSK	39	2441	6.422		
	78	2480	6.466		
π/4DQPSK	00	2402	6.157		
	39	2441	6.417		
	78	2480	6.494		
	00	2402	6.469		
8DPSK	39	2441	6.774		
	78	2480	6.865		
BLE	00	2402	-3.445		
	19	2440	-3.528		
	39	2480	-3.723		

Note:

 Per KDB 447498 D01Chapter 4.3.1, the 1-g and 10-g SAR test exclusion thresholds for 100 MHz to 6 GHz at test separation distances ≤ 50 mm are determined by:

[(max. power of channel, including tune-up tolerance, mW)/(min. test separation distance, mm)] $\cdot [\sqrt{f(GHz)}] \le 3.0$ for 1-g SAR and ≤ 7.5 for 10-g extremity SAR

f(GHz) is the RF channel transmit frequency in GHz

Power and distance are rounded to the nearest mW and mm before calculation

The result is rounded to one decimal place for comparison

Bluetooth Max Power	Separation Distance	Frequency	exclusion	
(dBm)	(mm)	(GHz)	thresholds	
6.865	0	2.48	1.530	

- Per KDB 447498 D01Chapter 4.3.1, when the minimum test separation distance is < 5 mm, a distance of 5 mm is applied to determine SAR test exclusion. The test exclusion threshold is 1.530 which is<= 3, SAR test for BT mode is not required.
- 3. Per KDB 447498 D01Chapter 4.3.2b), When an antenna qualifies for the standalone SAR test exclusion of 4.3.1 and also transmits simultaneously with other antennas, the standalone SAR value must be estimated according to the following to determine the simultaneous transmission SAR test exclusion criteria:

[(max. power of channel, including tune-up tolerance, mW) / (min. test separation distance, mm)]·[$\sqrt{f}(GHz)/x$] W/kg, for test separation distances \leq 50 mm;

where x = 7.5 for 1-g SAR and x = 18.75 for 10-g SAR.

0.4 W/kg for 1-g SAR and 1.0 W/kg for 10-g SAR, when the test separation distance is > 50 mm.

Test position	Bluetooth Max Power (dBm)	Separation Distance (mm)	Frequency (GHz)	Scaled SAR value (W/kg)
Shenzhen Anbotek	Compliance Laborato	ory Limited	andr somotion	and all all all all all all all all all al
	D, Sogood Science and T an District Shenzhen G		Community, product	Hotline

86) 755-26066440 Fax: (86) 755-26014772 Email: service@anbotek.com



Antoonek

Antonek

trupod

e^{ge}

Antophal

Report No.: R02190	080013W	FCC ID:	2APX7K5B	Page 37 of 108
Head	6.865	5	2.48	0.204
Body	6.865	5 ALL	2.48	0.204

Anboli

Shenzhen Anbotek Compliance Laboratory Limited

Address: 1/F., Building D, Sogood Science and Technology Park, Sanwei Community, Hangcheng Street, Bao'an District, Shenzhen, Guangdong, China. Tel:(86) 755-26066440 Fax: (86) 755-26014772 Email: service@anbotek.com



Anbatel

philo

Antontal

 Report No.: R0219080013W
 FCC ID: 2APX7K5B
 Page 38 of 108

11. Antenna Location



	Dista	ance of The A	ntenna to the E	EUT surface and	edge								
Antennas													
WWAN	potent / preso	1	>25mm	<25mm	<25mm	<25mm							
WIFI/BT	uboriek pr	popul au	<25mm	>25mm	>25mm	<25mm							

General Note:

Referring to KDB 941225 D06, When the overall device length and width are ≥9cm*5cm, the test distance is 10mm, SAR must be measured for all sides and surfaces with a transmitting antenna located with 25mm from that surface or edge.

Shenzhen Anbotek Compliance Laboratory Limited

Address: 1/F., Building D, Sogood Science and Technology Park, Sanwei Community, Hangcheng Street, Bao'an District, Shenzhen, Guangdong, China. Tel:(86) 755–26066440 Fax: (86) 755–26014772 Email: service@anbotek.com



FCC ID: 2APX7K5B

Page 39 of 108

12. SAR Test Results Summary

General Note:

1. Per KDB 447498 D01v05r01, the reported SAR is the measured SAR value adjusted for maximum tune-up tolerance.

Scaling Factor = tune-up limit power (mW) / EUT RF power (mW), where tune-up limit is the maximum rated power among all production units.

- Reported SAR(W/kg)= Measured SAR(W/kg)* Scaling Factor
- 2. Per KDB 447498 D01v05r01, for each exposure position, if the highest output channel reported SAR≤0.8W/kg, other channels SAR testing are not necessary

12.1. Head SAR Results

<GSM>

Plot No.	Band	Mode	Test Position	Gap (mm)	Ch.	` ´	Avera ge Power (dBm)		Scalin g Factor	r Drift	Measure d SAR _{1g} (W/kg)	Reported SAR _{1g} (W/kg)
#1	GSM850	GSM Voice	Right Cheek	0	128	824.2	31.20	31.50	1.07	-0.02	0.155	0.166
8400	GSM850	GSM Voice	Right Tilt	0	128	824.2	31.20	31.50	1.07	0.04	0.111	0.119
1	GSM850	GSM Voice	Left Cheek	0	128	824.2	31.20	31.50	1.07	-0.09	0.143	0.153
3	GSM850	GSM Voice	Left Tilt	0	128	824.2	31.20	31.50	1.07	-0.04	0.102	0.109
alt i	PCS1900	GSM Voice	Right Cheek	0	512	1850.2	28.18	29.00	1.21	0.06	0.205	0.248
- Sale	PCS1900	GSM Voice	Right Tilt	0	512	1850.2	28.18	29.00	1.21	-0.04	0.127	0.153
#2	PCS1900	GSM Voice	Left Cheek	0	512	1850.2	28.18	29.00	1.21	-0.01	0.213	0.257
P4/20	PCS1900	GSM Voice	Left Tilt	0	512	1850.2	28.18	29.00	1.21	0.03	0.134	0.162

<WCDMA>

Plot No.	Band	Mode	Test Position	Gap (mm)	Ch.		ge Power	Tune-U p Limit (dBm)	Scalin g Factor	r Drift	Measure d SAR _{1g} (W/kg)	Reported SAR _{1g} (W/kg)
1 ³	WCDMA Band2	RMC12.2K	Right Cheek	0	9262	1852.4	22.53	23.00	1.11	0.01	0.458	0.510
à.	WCDMA Band2	RMC12.2K	Right Tilt	0	9262	1852.4	22.53	23.00	1.11	-0.04	0.293	0.326
#3	WCDMA Band2	RMC12.2K	Left Cheek	0	9262	1852.4	22.53	23.00	1.11	0.09	0.714	0.793
PC	WCDMA	RMC12.2K	Left Tilt	0	9262	1852.4	22.53	23.00	1.11	0.06	0.332	0.370

Shenzhen Anbotek Compliance Laboratory Limited

Address: 1/F., Building D, Sogood Science and Technology Park, Sanwel Community, Hangcheng Street, Bao'an District, Shenzhen, Guangdong, China. Tel:(86) 755-26066440 Fax: (86) 755-26014772 Email: service@anbotek.com

100	Report No.	: R02190800)13W	10010	Ē	CC ID:	2APX7	K5B	PULDO		Page 40) of 108
	Band2	unbrater	pu sol	1000		Pupa.	N. 8	hotek	2	poster.	ARD	J
Po	WCDMA Band5	RMC12.2K	Right Cheek	0	4132	826.4	23.55	24.00	1.11	0.08	0.214	0.237
p still	WCDMA Band5	RMC12.2K	Right Tilt	0	4132	826.4	23.55	24.00	1.11	0.02	0.135	0.150
#4	WCDMA Band5	RMC12.2K	Left Cheek	0	4132	826.4	23.55	24.00	1.11	-0.03	0.222	0.246
hini	WCDMA Band5	RMC12.2K	Left Tilt	0	4132	826.4	23.55	24.00	1.11	-0.05	0.141	0.156

<WIFI 2.4GHz>

Plot No.	Band	Mode	Test Position	Gap (mm)	Ch.	Freq. (MHz)	Avera ge Power (dBm)		Scalin g Factor	r Drift	Measure d SAR _{1g} (W/kg)	Reported SAR _{1g} (W/kg)
8. É	WIFI2.4G	802.11b	Right Cheek	0	11	2462	13.20	13.50	1.07	-0.06	0.285	0.305
36	WIFI2.4G	802.11b	Right Tilt	0	11	2462	13.20	13.50	1.07	0.11	0.212	0.227
#5	WIFI2.4G	802.11b	Left Cheek	0	11	2462	13.20	13.50	1.07	0.04	0.294	0.315
NOOLO	WIFI2.4G	802.11b	Left Tilt	0	11	2462	13.20	13.50	1.07	-0.03	0.223	0.239

Per KDB865664 D01, for each frequency band, repeated SAR measurement is required only when the measured SAR is $\geq 0.8W/Kg$; if the deviation among the repeated measurement is $\leq 20\%$, and the measured SAR <1.45W/Kg, only one repeated measurement is required.

12. 2. Body SAR Results

<GSM>

Plot No.	Band	Mode	Test Position	Gap (cm)	l C.n.	Freq. (MHz)	Avera ge Power (dBm)		Scalin g Factor	r Drift	Measure d SAR _{1g} (W/kg)	Reported SAR _{1g} (W/kg)
oonee bal	GSM850	GPRS(4 Tx slots)	Front	0.5	128	824.2	25.55	26.00	1.11	0.03	0.249	0.276
#6	GSM850	GPRS(4 Tx slots)	Back	0.5	128	824.2	25.55	26.00	1.11	0.13	0.366	0.406
÷	GSM850	GPRS(4 Tx slots)	Left Side	0.5	128	824.2	25.55	26.00	1.11	-0.04	0.232	0.257
otok	GSM850	GPRS(4 Tx slots)	Right Side	0.5	128	824.2	25.55	26.00	1.11	0.08	0.225	0.250
And	GSM850	GPRS(4 Tx slots)	Top Side	0.5	128	824.2	25.55	26.00	1.11	N/A	N/A	N/A

Shenzhen Anbotek Compliance Laboratory Limited

Address: 1/F., Building D, Sogood Science and Technology Park, Sanwel Community, Hangcheng Street, Bao'an District, Shenzhen, Guangdong, China. Tel:(86) 755-26066440 Fax: (86) 755-26014772 Email: service@anbotek.com

Product Safety

Anbote

	Report No.:	R0219080013W	V	p ^{ror}	Ē	CC ID:	2APX7	K5B	partero.		Page 41	of 108
	GSM850	GPRS(4 Tx slots)	Bottom Side	0.5	128	824.2	25.55	26.00	1.11	-0.06	0.246	0.273
e.	PCS1900	GPRS(4 Tx slots)	Front	0.5	512	1850.2	22.68	23.00	1.08	0.03	0.593	0.638
#7	PCS1900	GPRS(4 Tx slots)	Back	0.5	512	1850.2	22.68	23.00	1.08	-0.08	0.729	0.785
hin)	PCS1900	GPRS(4 Tx slots)	Left Side	0.5	512	1850.2	22.68	23.00	1.08	-0.05	0.521	0.561
	PCS1900	GPRS(4 Tx slots)	Right Side	0.5	512	1850.2	22.68	23.00	1.08	0.09	0.506	0.545
	PCS1900	GPRS(4 Tx slots)	Top Side	0.5	512	1850.2	22.68	23.00	1.08	N/A	N/A	N/A
- p. 18	PCS1900	GPRS(4 Tx slots)	Bottom Side	0.5	512	1850.2	22.68	23.00	1.08	0.11	0.532	0.573

<WCDMA>

Plot No.	Band	Mode	Test Position	Gap (cm)	Ch.	Freq. (MHz)	Averag e Power (dBm)	Tune-U p Limit (dBm)	Scalin g Factor	Powe r Drift (dB)	Measure d SAR _{1g} (W/kg)	Reported SAR _{1g} (W/kg)
	WCDMA Band 2	RMC 12.2K	Front	0.5	9262	1852.4	22.53	23.00	1.11	0.03	0.492	0.548
#8	WCDMA Band 2	RMC 12.2K	Back	0.5	9262	1852.4	22.53	23.00	1.11	-0.08	0.645	0.719
aughole	WCDMA Band 2	RMC 12.2K	Left Side	0.5	9262	1852.4	22.53	23.00	1.11	0.06	0.381	0.425
Pure Part	WCDMA Band 2	RMC 12.2K	Right Side	0.5	9262	1852.4	22.53	23.00	1.11	-0.03	0.375	0.418
20	WCDMA Band 2	RMC 12.2K	Top Side	0.5	9262	1852.4	22.53	23.00	1.11	N/A	N/A	N/A
pondk	WCDMA Band 2	RMC 12.2K	Bottom Side	0.5	9262	1852.4	22.53	23.00	1.11	0.05	0.413	0.460
probine pick	WCDMA Band 5	RMC 12.2K	Front	0.5	4132	826.4	23.55	24.00	1.11	0.02	0.256	0.284
#9	WCDMA Band 5	RMC 12.2K	Back	0.5	4132	826.4	23.55	24.00	1.11	0.07	0.327	0.363
otex	WCDMA Band 5	RMC 12.2K	Left Side	0.5	4132	826.4	23.55	24.00	1.11	-0.04	0.231	0.256
Anton	WCDMA Band 5	RMC 12.2K	Right Side	0.5	4132	826.4	23.55	24.00	1.11	0.02	0.245	0.272

Shenzhen Anbotek Compliance Laboratory Limited

Address: 1/F., Building D, Sogood Science and Technology Park, Sanwel Community, Hangcheng Street, Bao'an District, Shenzhen, Guangdong, China. Tel:(86) 755-26066440 Fax: (86) 755-26014772 Email: service@anbotek.com

1.000	Report No.:	R021908001	3W	N/DOT-		FCC ID:	2APX7	K5B	Antoo		Page 42	of 108
	WCDMA Band 5	RMC 12.2K	Top Side	0.5	4132	826.4	23.55	24.00	1.11	N/A	N/A	N/A
ye.	WCDMA Band 5	RMC 12.2K	Bottom Side	0.5	4132	826.4	23.55	24.00	1.11	0.06	0.249	0.276

<WIFI 2.4GHz>

Plot No.	Band	Mode	Test Position	Gap (cm)		Freq. (MHz	е	Tune-U p Limit	Scalin g	Powe r Drift	Measure d SAR _{1g}	Reporte d SAR _{1q}
)	(dBm)	(dBm)	Factor		(W/kg)	(W/kg)
-36	WIFI 2.4GHz	802.11b	Front	0.5	11	2462	13.20	13.50	1.07	0.06	0.185	0.198
#10	WIFI 2.4GHz	802.11b	Back	0.5	11	2462	13.20	13.50	1.07	0.04	0.229	0.245
ASB OTHE	WIFI 2.4GHz	802.11b	Left Side	0.5	11	2462	13.20	13.50	1.07	N/A	N/A	N/A
1000	WIFI 2.4GHz	802.11b	Right Side	0.5	11	2462	13.20	13.50	1.07	-0.03	0.135	0.145
	WIFI 2.4GHz	802.11b	Top Side	0.5	11	2462	13.20	13.50	1.07	0.02	0.128	0.137
1. 19. 1.	WIFI 2.4GHz	802.11b	Bottom Side	0.5	11	2462	13.20	13.50	1.07	N/A	N/A	N/A

Note:

- Per IEC62209-2:2010 Chapter 6.1.4.2, only Back and Front of the mobile phone are required for test. The mobile do not support Hotspot mode and other surfaces are not need to be tested
 Per KDB865664 D01, for each frequency band, repeated SAR measurement is required only when
 - the measured SAR is ≥0.8W/Kg; if the deviation among the repeated measurement is ≤20%,and the measured SAR <1.45W/Kg, only one repeated measurement is required.

Shenzhen Anbotek Compliance Laboratory Limited





FCC ID: 2APX7K5B

Page 43 of 108

13. Simultaneous Transmission Analysis

13.1. Simultaneous TX SAR Considerations

No.	Applicable Simultaneous Transmission	
1.	GSM+WIFI 2.4GHz	20
2.	WCDMA+WIFI2.4GHz	
3.	GSM+BT	36
4.	WCDMA+BT	

13. 2. Evaluation of Simultaneous SAR

< Head Exposure Conditions>

Simultaneous transmission SAR for WIFI2.4G and GSM

Test Position	GSM850 SAR _{1-g} (W/Kg)	GSM1900 SAR _{1-g} (W/Kg)	WIFI2.4G SAR _{1-g} (W/Kg)	MAX. ΣSAR _{1-g} (W/Kg)	SAR _{1-g} Limit (W/Kg)	Simut. Meas. Required
Right Cheek	0.166	0.248	0.305	0.553	1.6	NO
Right Tilt	0.119	0.153	0.227	0.38	1.6	NO
Left Cheek	0.153	0.257	0.315	0.572	1.6	NO
Left Tilt	0.109	0.162	0.239	0.401	1.6	NO

Simultaneous transmission SAR for WIFI2.4G and WCDMA

Test Position	WCDMA Band2 SAR _{1-g} (W/Kg)	WCDMA Band5 SAR _{1-g} (W/Kg)	WIFI2.4G SAR _{1-g} (W/Kg)	MAX. ΣSAR _{1-g} (W/Kg)	SAR _{1-g} Limit (W/Kg)	Simut. Meas. Required
Right Cheek	0.510	0.237	0.305	0.815	1.6	NO
Right Tilt	0.326	0.150	0.227	0.553	1.6	NO
Left Cheek	0.793	0.246	0.315	1.109	1.6	NO
Left Tilt	0.370	0.156	0.239	0.609	1.6	NO

Shenzhen Anbotek Compliance Laboratory Limited

Address: 1/F., Building D, Sogood Science and Technology Park, Sanwel Community, Hangcheng Street, Bao'an District, Shenzhen, Guangdong, China. Tel:(86) 755-26066440 Fax: (86) 755-26014772 Email: service@anbotek.com



Report No.: R0219080013W FCC ID: 2APX7K5B Page 44 of 108 Simultaneous transmission SAR for WIFI2.4G and GSM Image 44 of 108

Test Position	GSM850 SAR _{1-g} (W/Kg)	GSM1900 SAR _{1-g} (W/Kg)	BT SAR _{1-g} (W/Kg)	MAX. ΣSAR _{1-g} (W/Kg)	SAR _{1-g} Limit (W/Kg)	Simut. Meas. Required
Right Cheek	0.166	0.248	0.204	0.452	1.6	NO
Right Tilt	0.119	0.153	0.204	0.357	1.6	NO
Left Cheek	0.153	0.257	0.204	0.461	1.6	NO
Left Tilt	0.109	0.162	0.204	0.366	1.6	NO

Simultaneous transmission SAR for WIFI2.4G and WCDMA

Test Position	WCDMA Band2 SAR _{1-g} (W/Kg)	WCDMA Band5 SAR _{1-g} (W/Kg)	BT SAR _{1-g} (W/Kg)	MAX. ΣSAR _{1-g} (W/Kg)	SAR _{1-g} Limit (W/Kg)	Simut. Meas. Required
Right Cheek	0.510	0.237	0.204	0.714	1.6	NO
Right Tilt	0.326	0.150	0.204	0.53	1.6	NO
Left Cheek	0.793	0.246	0.204	0.997	1.6	NO
Left Tilt	0.370	0.156	0.204	0.574	1.6	NO

Shenzhen Anbotek Compliance Laboratory Limited



Report No.: R0219080013W

FCC ID: 2APX7K5B

Page 45 of 108

<Body Exposure Conditions>

Simultaneous transmission SAR for WIFI2.4G and GSM

Test Position	GSM850 SAR _{1-g} (W/Kg)	GSM1900 SAR _{1-g} (W/Kg)	WIFI2.4G SAR _{1-g} (W/Kg)	MAX. ΣSAR _{1-g} (W/Kg)	SAR _{1-g} Limit (W/Kg)	Simut. Meas. Required
Front	0.276	0.638	0.198	0.836	1.6	NO
Back	0.406	0.785	0.245	1.03	1.6	NO
Left Side	0.257	0.561	N/A	N/A	1.6	NO
Right Side	0.250	0.545	0.145	0.69	1.6	NO
Top Side	N/A	N/A	0.137	N/A	1.6	NO
Bottom Side	0.273	0.573	N/A	N/A	1.6	NO

Simultaneous transmission SAR for WIFI2.4G and WCDMA

Test Position	WCDMA Band2 SAR _{1-g} (W/Kg)	WCDMA Band5 SAR _{1-g} (W/Kg)	WIFI2.4G SAR _{1-g} (W/Kg)	MAX. ΣSAR _{1-g} (W/Kg)	SAR _{1-g} Limit (W/Kg)	Simut. Meas. Required
Front	0.548	0.284	0.198	0.746	1.6	NO
Back	0.719	0.363	0.245	0.964	1.6	NO
Left Side	0.425	0.256	N/A	N/A	1.6	NO
Right Side	0.418	0.272	0.145	0.563	1.6	NO
Top Side	N/A	N/A	0.137	N/A	1.6	NO
Bottom Side	0.460	0.276	N/A	N/A	1.6	NO

Simultaneous transmission SAR for BT and GSM

Test Position	GSM850 SAR _{1-g} (W/Kg)	GSM1900 SAR _{1-g} (W/Kg)	BT SAR _{1-g} (W/Kg)	MAX. ΣSAR _{1-g} (W/Kg)	SAR _{1-g} Limit (W/Kg)	Simut. Meas. Required
Front	0.276	0.638	0.204	0.842	1.6	NO
Back	0.406	0.785	0.204	0.989	1.6	NO
Left Side	0.257	0.561	0.204	0.765	1.6	NO
Right Side	0.250	0.545	0.204	0.749	1.6	NO
Top Side	N/A	N/A	0.204	N/A	1.6	NO
Bottom Side	0.273	0.573	0.204	0.777	1.6	NO

Simultaneous transmission SAR for BT and WCDMA Shenzhen Anbotek Compliance Laboratory Limited

Address: 1/F., Building D, Sogood Science and Technology Park, Sanwei Community, Hangcheng Street, Bao'an District, Shenzhen, Guangdong, China. Tel:(86) 755-26066440 Fax: (86) 755-26014772 Email: service@anbotek.com

Product Safety

Anbote

e^{gh}

e^{Se}

Antonek

trugge

Report No.: F	R0219080013W	Mibolish	FCC ID: 24	APX7K5B	Anthon F	Page 46 of 108
Test Position	WCDMA Band2 SAR _{1-g} (W/Kg)	WCDMA Band5 SAR _{1-g} (W/Kg)	BT SAR _{1-g} (W/Kg)	MAX. ΣSAR _{1-g} (W/Kg)	SAR _{1-g} Limit (W/Kg)	Simut. Meas. Required
Front	0.548	0.284	0.204	0.752	1.6	NO
Back	0.719	0.363	0.204	0.923	1.6	NO
Left Side	0.425	0.256	0.204	0.629	1.6	NO
Right Side	0.418	0.272	0.204	0.622	1.6	NO
Top Side	N/A	N/A	0.204	N/A	1.6	NO
Bottom Side	0.460	0.276	0.204	0.664	1.6	NO

Shenzhen Anbotek Compliance Laboratory Limited

Address: 1/F., Building D, Sogood Science and Technology Park, Sanwei Community, Hangcheng Street, Bao'an District, Shenzhen, Guangdong, China. Tel:(86) 755-26066440 Fax: (86) 755-26014772 Email: service@anbotek.com



Anb



FCC ID: 2APX7K5B

Page 47 of 108

14. Measurement Uncertainty

Per KDB 865664 D01 SAR Measurement 100 MHz to 6 GHz, when the highest measured 1-g SAR within a frequency band is< 1.5 W/Kg, the extensive SAR measurement uncertainty analysis described in IEC 62209-2:2010 is not required in SAR reports submitted for equipment approval.

Shenzhen Anbotek Compliance Laboratory Limited





FCC ID: 2APX7K5B

Page 48 of 108

Appendix A. SAR Test Setup Photos



Left Cheek

Left Tilt 15°



Right Cheek

Right Tilt 15°



Body Front(5mm)

Body Back(5mm)

Shenzhen Anbotek Compliance Laboratory Limited

Address: 1/F., Building D, Sogood Science and Technology Park, Sanwei Community, Hangcheng Street, Bao'an District, Shenzhen, Guangdong, China. Tel:(86) 755-26066440 Fax: (86) 755-26014772 Email: service@anbotek.com



FCC ID: 2APX7K5B

Page 49 of 108



Bottom Side(5mm)

Top Side(5mm)



Right Side(5mm)

Left Side(5mm)

Shenzhen Anbotek Compliance Laboratory Limited

Address: 1/F., Building D, Sogood Science and Technology Park, Sanwei Community, Hangcheng Street, Bao'an District, Shenzhen, Guangdong, China. Tel:(86) 755-26066440 Fax: (86) 755-26014772 Email: service@anbotek.com



FCC ID: 2APX7K5B

Page 50 of 108

Appendix B. Plots of SAR System Check

Date: 08/14/2019

835MHz Head System Check DUT: Dipole 835 MHz; Type: D835V2; Serial: D835V2 - SN:4d160

Communication System: UID 0, CW; Frequency: 835 MHz; Duty Cycle: 1:1 Medium parameters used: f = 835 MHz; σ = 0.96 S/m; ϵ_r = 41.68; ρ = 1000 kg/m³ Phantom section: Flat Section

DASY5 Configuration:

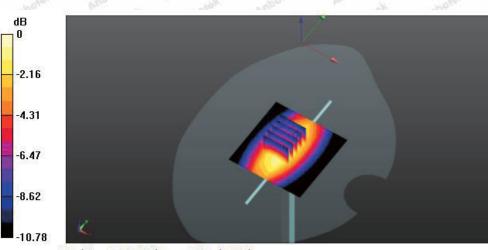
- Probe: EX3DV4 SN7396; ConvF(9.71, 9.71, 9.71); Calibrated: 6.5.2019;
- Sensor-Surface: 2mm (Mechanical Surface Detection)
- Electronics: DAE4 Sn387; Calibrated: 6.9.2018
- Phantom: SAM1; Type: QD000P40CD; Serial: TP:1670
- Measurement SW: DASY52, Version 52.8 (2); SEMCAD X Version 14.6.10 (7164)

Configuration/Pin=250mW/Area Scan (7x7x1): Measurement grid: dx=15mm, dy=15mm Maximum value of SAR (measured) = 2.80 W/kg

Configuration/Pin=250mW/Zoom Scan (5x5x7)/Cube 0: Measurement grid: dx=8mm, dy=8mm, dz=5mm

Reference Value = 56.553 V/m; Power Drift = 0.01 dB Peak SAR (extrapolated) = 3.39 W/kg SAR(1 g) = 2.32 W/kg; SAR(10 g) = 1.69 W/kg

Maximum value of SAR (measured) = 2.86 W/kg



0 dB = 2.86 W/kg = 4.56 dBW/kg

Shenzhen Anbotek Compliance Laboratory Limited



Anbotek Product Safety

FCC ID: 2APX7K5B

Page 51 of 108 Date: 08/15/2019

835MHz Body System Check DUT: Dipole 835 MHz; Type: D835V2; Serial: D835V2 - SN:4d160

Communication System: UID 0, CW; Frequency: 835 MHz; Duty Cycle: 1:1 Medium parameters used: f = 835 MHz; σ = 1.06 S/m; ϵ_r = 55.26; ρ = 1000 kg/m³ Phantom section: Flat Section

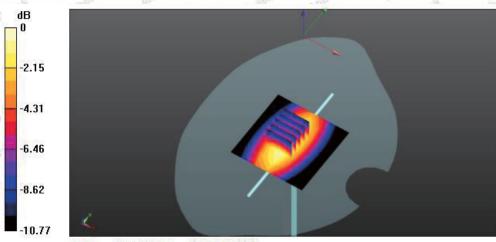
DASY5 Configuration:

- Probe: EX3DV4 SN7396; ConvF(9.88, 9.88, 9.88); Calibrated: 6.5.2019;
- Sensor-Surface: 2mm (Mechanical Surface Detection)
- Electronics: DAE4 Sn387; Calibrated: 6.9.2018
- Phantom: SAM1; Type: QD000P40CD; Serial: TP:1670
- Measurement SW: DASY52, Version 52.8 (2); SEMCAD X Version 14.6.10 (7164)

Configuration/Pin=250mW/Area Scan (7x7x1): Measurement grid: dx=15mm, dy=15mm Maximum value of SAR (measured) = 2.97 W/kg

Configuration/Pin=250mW/Zoom Scan (5x5x7)/Cube 0: Measurement grid: dx=8mm, dy=8mm, dz=5mm

Reference Value = 58.282 V/m; Power Drift = -0.00 dB Peak SAR (extrapolated) = 3.55 W/kg SAR(1 g) = 2.37 W/kg; SAR(10 g) = 1.55 W/kg Maximum value of SAR (measured) = 3.01 W/kg



0 dB = 3.01 W/kg = 4.79 dBW/kg

Shenzhen Anbotek Compliance Laboratory Limited





FCC ID: 2APX7K5B

Page 52 of 108

Date: 08/19/2019

1900MHz Head System Check DUT: Dipole 1900 MHz; Type: D1900V2; Serial: D1900V2 - SN:5d179

Communication System: UID 0, CW; Frequency: 1900 MHz; Duty Cycle: 1:1 Medium parameters used: f = 1880 MHz; σ = 1.43 S/m; ϵ_r = 40.19; ρ = 1000 kg/m³ Phantom section: Flat Section

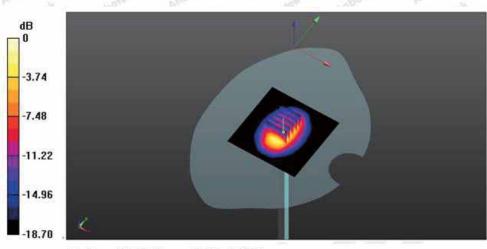
DASY5 Configuration:

- Probe: EX3DV4 SN7396; ConvF(8.13, 8.13, 8.13); Calibrated: 6.5.2019;
- Sensor-Surface: 2mm (Mechanical Surface Detection)
- Electronics: DAE4 Sn387; Calibrated: 6.9.2018
- Phantom: SAM1; Type: QD000P40CD; Serial: TP:1670
- Measurement SW: DASY52, Version 52.8 (2); SEMCAD X Version 14.6.10 (7164)

Configuration/Pin=250mW/Area Scan (71x71x1): Interpolated grid: dx=1.500 mm, dy=1.500 mm Maximum value of SAR (interpolated) = 14.6 W/kg

Configuration/Pin=250mW/Zoom Scan (5x5x7)/Cube 0: Measurement grid: dx=8mm, dy=8mm, dz=5mm

Reference Value = 101.1 V/m; Power Drift = 0.10 dB Peak SAR (extrapolated) = 17.9 W/kg SAR(1 g) = 9.56 W/kg; SAR(10 g) = 4.91 W/kg Maximum value of SAR (measured) = 14.9 W/kg



0 dB = 14.9 W/kg = 11.73 dBW/kg

Shenzhen Anbotek Compliance Laboratory Limited





FCC ID: 2APX7K5B

Page 53 of 108 Date: 08/20/2019

1900MHz Body System Check DUT: Dipole 1900 MHz; Type: D1900V2; Serial: D1900V2 - SN:5d179

Communication System: UID 0, CW; Frequency: 1900 MHz; Duty Cycle: 1:1 Medium parameters used: f = 1880 MHz; σ = 1.53 S/m; ϵ_r = 53.41; ρ = 1000 kg/m³ Phantom section: Flat Section

DASY5 Configuration:

- Probe: EX3DV4 SN7396; ConvF(7.97, 7.97, 7.97); Calibrated: 6.5.2019;
- Sensor-Surface: 2mm (Mechanical Surface Detection)
- Electronics: DAE4 Sn387; Calibrated: 6.9.2018
- Phantom: SAM1; Type: QD000P40CD; Serial: TP:1670
- Measurement SW: DASY52, Version 52.8 (2); SEMCAD X Version 14.6.10 (7164)

Configuration/Pin=250mW/Area Scan (7x7x1): Measurement grid: dx=15mm, dy=15mm Maximum value of SAR (measured) = 14.0 W/kg

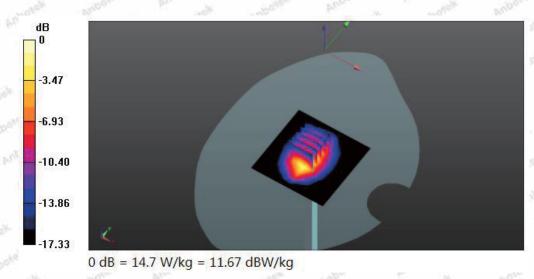
Configuration/Pin=250mW/Zoom Scan (5x5x7)/Cube 0: Measurement grid: dx=8mm, dy=8mm, dz=5mm

Reference Value = 85.081 V/m; Power Drift = -0.00 dB

Peak SAR (extrapolated) = 18.6 W/kg

SAR(1 g) = 10.25 W/kg; SAR(10 g) = 5.48 W/kg

Maximum value of SAR (measured) = 14.7 W/kg



Shenzhen Anbotek Compliance Laboratory Limited





FCC ID: 2APX7K5B

Page 54 of 108 Date:08/22/2019

2450MHz Head System Check

DUT: Dipole 2450 MHz; Type: D2450V2; Serial: D2450V2 - SN:919 Communication System: UID 0, CW; Frequency: 2450 MHz;Duty Cycle: 1:1 Medium parameters used: f = 2450 MHz; σ = 1.88 S/m; ϵ_r = 40.46; ρ = 1000 kg/m³ Phantom section: Flat Section

DASY5 Configuration:

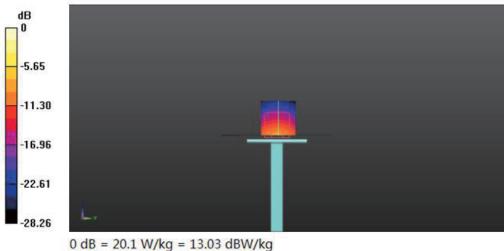
- Probe: EX3DV4 SN7396; ConvF(7.57, 7.57, 7.57); Calibrated: 6.5.2019;
- Sensor-Surface: 2mm (Mechanical Surface Detection)
- Electronics: DAE4 Sn387; Calibrated: 6.9.2018
- Phantom: SAM; Type: QD000P40CD; Serial: TP:1670
- Measurement SW: DASY52, Version 52.8 (2); SEMCAD X Version 14.6.10 (7164)

Configuration/Pin=250mW/Area Scan (81x81x1): Interpolated grid: dx=1.200 mm, dy=1.200 mm Maximum value of SAR (interpolated) = 20.1 W/kg

Configuration/Pin=250mW/Zoom Scan (7x7x7)/Cube 0: Measurement grid: dx=5mm, dy=5mm, dz=5mm

Reference Value = 87.352 V/m; Power Drift = 0.03 dB Peak SAR (extrapolated) = 26.4 W/kg

SAR(1 g) = 12.86 W/kg; SAR(10 g) = 5.68W/kg Maximum value of SAR (measured) = 19.6 W/kg



Shenzhen Anbotek Compliance Laboratory Limited





FCC ID: 2APX7K5B

Page 55 of 108

Date:08/23/2019

2450MHz Body System Check

DUT: Dipole 2450 MHz; Type: D2450V2; Serial: D2450V2 - SN:919

Communication System: UID 0, CW; Frequency: 2450 MHz;Duty Cycle: 1:1 Medium parameters used: f = 2450 MHz; σ = 1.97 S/m; ϵ_r = 51.89; ρ = 1000 kg/m³ Phantom section: Flat Section

DASY5 Configuration:

- Probe: EX3DV4 SN7396; ConvF(7.53, 7.53, 7.53); Calibrated: 6.5.2019;
- Sensor-Surface: 2mm (Mechanical Surface Detection)
- Electronics: DAE4 Sn387; Calibrated: 6.9.2018
- Phantom: SAM; Type: QD000P40CD; Serial: TP:1670
- Measurement SW: DASY52, Version 52.8 (2); SEMCAD X Version 14.6.10 (7164)

Configuration/Pin=250mW/Area Scan (81x81x1): Interpolated grid: dx=1.200 mm, dy=1.200 mm Maximum value of SAR (interpolated) = 17.2 W/kg

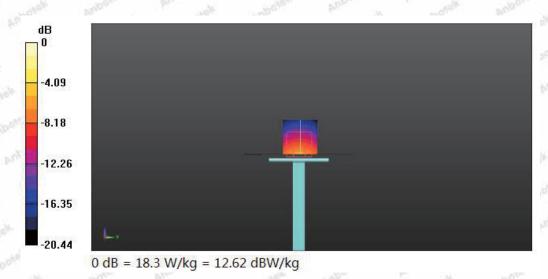
Configuration/Pin=250mW/Zoom Scan (7x7x7)/Cube 0: Measurement grid: dx=5mm, dy=5mm, dz=5mm

Reference Value = 82.205 V/m; Power Drift = -0.01 dB

Peak SAR (extrapolated) = 24.5 W/kg

SAR(1 g) = 12.53 W/kg; SAR(10 g) = 5.87 W/kg

Maximum value of SAR (measured) = 18.3 W/kg



Shenzhen Anbotek Compliance Laboratory Limited





FCC ID: 2APX7K5B

Page 56 of 108

Appendix C. Plots of SAR Test Data

#1

Date: 08/14/2019

GSM850_GSM Voice_Right Cheek_Ch128

Communication System: UID 0, CW; Frequency: 824.2 MHz; Duty Cycle: 1:1 Medium parameters used: f = 824.2 MHz; σ = 0.96 S/m; ϵ_r = 41.68; ρ = 1000 kg/m³ Phantom section: Right Section

DASY5 Configuration:

- Probe: EX3DV4 SN7396; ConvF(9.71, 9.71, 9.71); Calibrated: 6.5.2019;
- Sensor-Surface: 2mm (Mechanical Surface Detection)
- Electronics: DAE4 Sn387; Calibrated: 6.9.2018
- Phantom: SAM1; Type: QD000P40CD; Serial: TP:1670
- Measurement SW: DASY52, Version 52.8 (2); SEMCAD X Version 14.6.10 (7164)

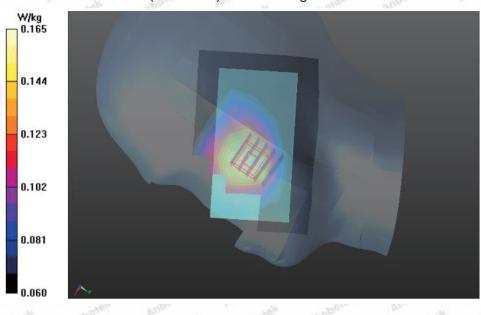
RIGHT HEAD/R-C-L/Area Scan (8x11x1): Measurement grid: dx=15mm, dy=15mm Maximum value of SAR (measured) = 0.163 W/kg

RIGHT HEAD/R-C-L/Zoom Scan (5x5x7)/Cube 0: Measurement grid: dx=8mm, dy=8mm, dz=5mm

Reference Value = 8.227 V/m; Power Drift = -0.02 dB Peak SAR (extrapolated) = 0.184 W/kg

SAR(1 g) = 0.155 W/kg; SAR(10 g) = 0.127 W/kg

Maximum value of SAR (measured) = 0.165 W/kg



Shenzhen Anbotek Compliance Laboratory Limited

Address: 1/F., Building D, Sogood Science and Technology Park, Sanwel Community, Hangcheng Street, Bao'an District, Shenzhen, Guangdong, China. Tel:(86) 755-26066440 Fax: (86) 755-26014772 Email: service@anbotek.com

Report No.: R0219080013W **#2**

FCC ID: 2APX7K5B

Page 57 of 108 Date: 08/19/2019

PCS1900_GSM Voice_Left Cheek_Ch512

Communication System: UID 0, CW; Frequency: 1850.2 MHz; Duty Cycle: 1:1 Medium parameters used: f = 1850.2 MHz; σ = 1.43 S/m; ϵ_r = 40.19; ρ = 1000 kg/m³ Phantom section: Left Section

DASY5 Configuration:

- Probe: EX3DV4 SN7396; ConvF(8.13, 8.13, 8.13); Calibrated: 6.5.2019;
- Sensor-Surface: 2mm (Mechanical Surface Detection)
- Electronics: DAE4 Sn387; Calibrated: 6.9.2018
- Phantom: SAM1; Type: QD000P40CD; Serial: TP:1670
- Measurement SW: DASY52, Version 52.8 (2); SEMCAD X Version 14.6.10 (7164)

LEFT HEAD/L-C-L/Area Scan (8x11x1): Measurement grid: dx=15mm, dy=15mm

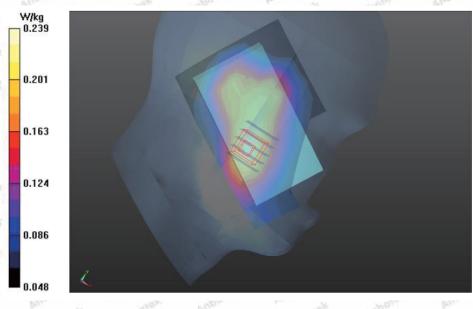
Maximum value of SAR (measured) = 0.241 W/kg

LEFT HEAD/L-C-L/Zoom Scan (5x5x7)/Cube 0: Measurement grid: dx=8mm, dy=8mm, dz=5mm Reference Value = 11.461 V/m; Power Drift = -0.01 dB

Peak SAR (extrapolated) = 0.279 W/kg

SAR(1 g) = 0.213 W/kg; SAR(10 g) = 0.153 W/kg

Maximum value of SAR (measured) = 0.239 W/kg



Shenzhen Anbotek Compliance Laboratory Limited



#3

Report No.: R0219080013W

FCC ID: 2APX7K5B

Page 58 of 108 Date: 08/19/2019

WCDMA 1900_RMC 12.2K_Left Cheek_Ch9262

Communication System: UID 0, Generic WCDMA (0); Frequency: 1852.4 MHz; Duty Cycle: 1:1 Medium parameters used: f = 1852.4 MHz; σ = 1.388 S/m; ϵ_r = 39.717; ρ = 1000 kg/m³ Phantom section: Left Section

DASY5 Configuration:

- Probe: EX3DV4 SN7396; ConvF(8.13, 8.13, 8.13); Calibrated: 6.5.2019;
- Sensor-Surface: 2mm (Mechanical Surface Detection)
- Electronics: DAE4 Sn387; Calibrated: 6.9.2018
- Phantom: SAM; Type: QD000P40CD; Serial: TP:1670
- Measurement SW: DASY52, Version 52.8 (2); SEMCAD X Version 14.6.10 (7164)

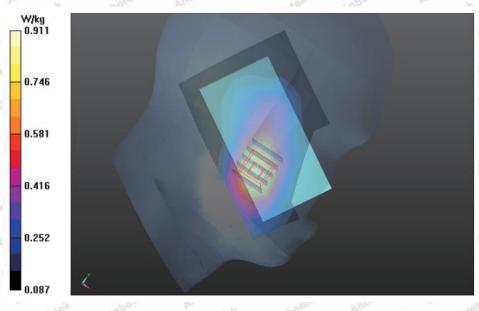
LEFT HEAD/L-C-L/Area Scan (8x11x1): Measurement grid: dx=15mm, dy=15mm Maximum value of SAR (measured) = 0.893 W/kg

LEFT HEAD/L-C-L/Zoom Scan (5x5x7)/Cube 0: Measurement grid: dx=8mm, dy=8mm, dz=5mm

Reference Value = 11.825 V/m; Power Drift = 0.09 dB

Peak SAR (extrapolated) = 1.12 W/kg

SAR(1 g) = 0.714 W/kg; SAR(10 g) = 0.515 W/kg Maximum value of SAR (measured) = 0.911 W/kg



Shenzhen Anbotek Compliance Laboratory Limited



#4

Report No.: R0219080013W

FCC ID: 2APX7K5B

Page 59 of 108 Date: 08/14/2019

WCDMA 850_RMC 12.2K_Left Cheek_Ch4133

Communication System: UID 0, Generic WCDMA (0); Frequency: 826.4 MHz; Duty Cycle: 1:1 Medium parameters used: f = 826.4 MHz; σ = 0.927 S/m; ϵ_r = 41.682; ρ = 1000 kg/m³ Phantom section: Left Section

DASY5 Configuration:

- Probe: EX3DV4 SN7396; ConvF(9.71, 9.72, 9.71); Calibrated: 6.5.2019;
- Sensor-Surface: 2mm (Mechanical Surface Detection)
- Electronics: DAE4 Sn387; Calibrated: 6.9.2018
- Phantom: SAM; Type: QD000P40CD; Serial: TP:1670
- Measurement SW: DASY52, Version 52.8 (2); SEMCAD X Version 14.6.10 (7164)

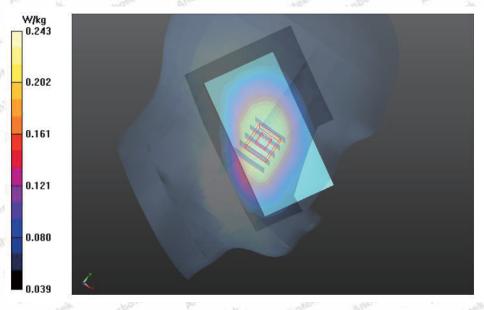
LEFT HEAD/L-C/Area Scan (8x11x1): Measurement grid: dx=15mm, dy=15mm Maximum value of SAR (measured) = 0.239 W/kg

LEFT HEAD/L-C/Zoom Scan (5x5x7)/Cube 0: Measurement grid: dx=8mm, dy=8mm, dz=5mm

Reference Value = 9.573 V/m; Power Drift = -0.03 dB

Peak SAR (extrapolated) = 0.280 W/kg

SAR(1 g) = 0.222 W/kg; SAR(10 g) = 0.169 W/kg Maximum value of SAR (measured) = 0.243 W/kg



Shenzhen Anbotek Compliance Laboratory Limited



Report No.: R0219080013W #5

FCC ID: 2APX7K5B

Page 60 of 108 Date: 08/22/2019

WIFI 2.4G_Left Cheek_Ch11

Communication System: UID 0, wifi (fcc) (0); Frequency: 2462 MHz; Duty Cycle: 1:1 Medium parameters used (interpolated): f = 2462 MHz; σ = 1.963 S/m; ϵ r = 52.013; ρ = 1000 kg/m3 Phantom section: Flat Section

DASY5 Configuration:

- Probe: EX3DV4 SN7396; ConvF(7.57, 7.57, 7.57); Calibrated: 6.5.2019;
- Sensor-Surface: 2mm (Mechanical Surface Detection)
- Electronics: DAE4 Sn1303; Calibrated: 6.9.2018
- Phantom: SAM; Type: QD000P40CD; Serial: TP:1670
- Measurement SW: DASY52, Version 52.8 (2); SEMCAD X Version 14.6.10 (7164)

LEFT HEAD/L-C-H/Area Scan (12x16x1): Measurement grid: dx=10mm, dy=10mm Maximum value of SAR (measured) = 0.279 W/kg

LEFT HEAD/L-C-H/Zoom Scan (7x7x7)/Cube 0: Measurement grid: dx=5mm, dy=5mm, dz=5mm

Reference Value = 7.199 V/m; Power Drift = 0.04 dB

Peak SAR (extrapolated) = 1.58 W/kg

SAR(1 g) = 0.294 W/kg; SAR(10 g) = 0.155 W/kg Maximum value of SAR (measured) = 0.334 W/kg



Shenzhen Anbotek Compliance Laboratory Limited





FCC ID: 2APX7K5B

Page 61 of 108 Date: 08/15/2019

GSM850_GPRS_4TX_Body Back_Ch128

Communication System: UID 0, GPRS(4 Tx slots) (0); Frequency: 824.2 MHz;Duty Cycle: 1:1.99986 Medium parameters used (interpolated): f = 824.2 MHz; σ = 0.96 S/m; ϵ_r = 55.858; ρ = 1000 kg/m³ Phantom section: Flat Section

DASY5 Configuration:

- Probe: EX3DV4 SN7396; ConvF(9.88, 9.88, 9.88); Calibrated: 6.5.2019;
- Sensor-Surface: 2mm (Mechanical Surface Detection)
- Electronics: DAE4 Sn387; Calibrated: 6.9.2018
- Phantom: SAM; Type: QD000P40CD; Serial: TP:1670
- Measurement SW: DASY52, Version 52.8 (2); SEMCAD X Version 14.6.10 (7164)

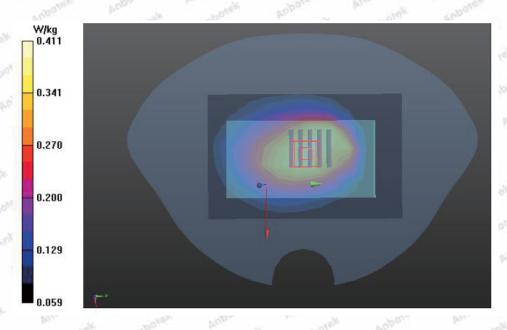
BODY/4ST-BACK-L/Area Scan (8x12x1): Measurement grid: dx=15mm, dy=15mm Maximum value of SAR (measured) = 0.404 W/kg

BODY/4ST-BAC-LK/Zoom Scan (5x5x7)/Cube 0: Measurement grid: dx=8mm, dy=8mm, dz=5mm

Reference Value = 21.221 V/m; Power Drift = 0.13 dB

Peak SAR (extrapolated) = 0.541 W/kg

SAR(1 g) = 0.366 W/kg; SAR(10 g) = 0.262 W/kg Maximum value of SAR (measured) = 0.411 W/kg



Shenzhen Anbotek Compliance Laboratory Limited



Report No.: R0219080013W **#7**

FCC ID: 2APX7K5B

Page 62 of 108 Date: 08/20/2019

GSM1900_GPRS_4TX_Body Back_Ch512

Communication System: UID 0, GPRS(4 Tx slots) (0); Frequency: 1850.2 MHz;Duty Cycle: 1:1.99986 Medium parameters used: f = 1850.2 MHz; σ = 1.57 S/m; ϵ_r = 51.14; ρ = 1000 kg/m³ Phantom section: Flat Section

DASY5 Configuration:

- Probe: EX3DV4 SN7396; ConvF(7.97, 7.97, 7.97); Calibrated: 6.5.2019;
- Sensor-Surface: 2mm (Mechanical Surface Detection)
- Electronics: DAE4 Sn387; Calibrated: 6.9.2018
- Phantom: SAM; Type: QD000P40CD; Serial: TP:1670
- Measurement SW: DASY52, Version 52.8 (2); SEMCAD X Version 14.6.10 (7164)

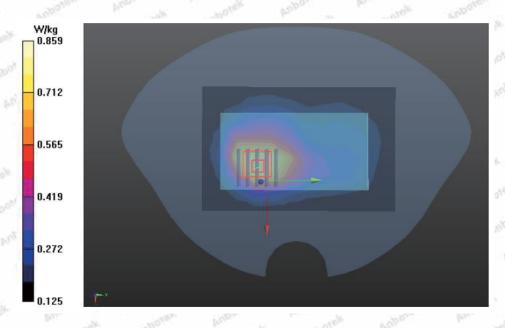
BODY/4ST-BACK-L/Area Scan (8x12x1): Measurement grid: dx=15mm, dy=15mm Maximum value of SAR (measured) = 0.787 W/kg

BODY/4ST-BACK-L/Zoom Scan (5x5x7)/Cube 0: Measurement grid: dx=8mm, dy=8mm, dz=5mm

Reference Value = 18.546 V/m; Power Drift = -0.08 dB

Peak SAR (extrapolated) = 1.10 W/kg

SAR(1 g) = 0.729 W/kg; SAR(10 g) = 0.480 W/kg Maximum value of SAR (measured) = 0.859 W/kg



Shenzhen Anbotek Compliance Laboratory Limited



#8

Report No.: R0219080013W

FCC ID: 2APX7K5B

Page 63 of 108 Date: 08/20/2019

WCDMA 1900_RMC 12.2K_Body Back_Ch9262

Communication System: UID 0, Generic WCDMA (0); Frequency: 1852.4 MHz; Duty Cycle: 1:1 Medium parameters used: f = 1852.4 MHz; σ = 1.57 S/m; ϵ_r = 51.14; ρ = 1000 kg/m³ Phantom section: Flat Section

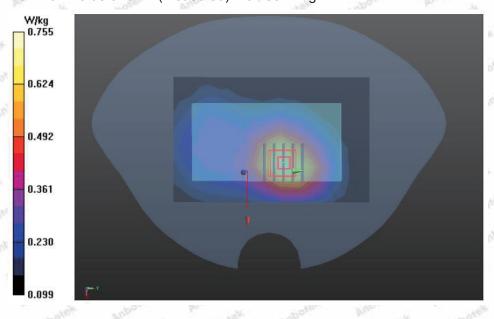
DASY5 Configuration:

- Probe: EX3DV4 SN7396; ConvF(7.97, 7.97, 7.97); Calibrated: 6.5.2019;
- Sensor-Surface: 2mm (Mechanical Surface Detection)
- Electronics: DAE4 Sn387; Calibrated: 6.9.2018
- Phantom: SAM; Type: QD000P40CD; Serial: TP:1670
- Measurement SW: DASY52, Version 52.8 (2); SEMCAD X Version 14.6.10 (7164)

BODY/BACK-L/Area Scan (8x12x1): Measurement grid: dx=15mm, dy=15mm Maximum value of SAR (measured) = 0.743 W/kg

BODY/BACK-L/Zoom Scan (5x5x7)/Cube 0: Measurement grid: dx=8mm, dy=8mm, dz=5mm Reference Value = 19.540 V/m; Power Drift = -0.08 dB Peak SAR (extrapolated) = 0.950 W/kg

SAR(1 g) = 0.645 W/kg; SAR(10 g) = 0.424 W/kg Maximum value of SAR (measured) = 0.755 W/kg



Shenzhen Anbotek Compliance Laboratory Limited



#9

Report No.: R0219080013W

FCC ID: 2APX7K5B

Page 64 of 108 Date: 08/15/2019

WCDMA 850_RMC 12.2K_Body Back_Ch4132

Communication System: UID 0, Generic WCDMA (0); Frequency: 826.4 MHz; Duty Cycle: 1:1 Medium parameters used (interpolated): f = 826.4 MHz; σ = 0.96 S/m; ϵ_r = 55.858; ρ = 1000 kg/m³ Phantom section: Flat Section

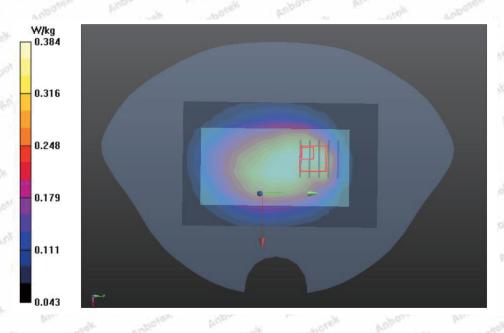
DASY5 Configuration:

- Probe: EX3DV4 SN7396; ConvF(9.88, 9.88, 9.88); Calibrated: 6.5.2019;
- Sensor-Surface: 2mm (Mechanical Surface Detection)
- Electronics: DAE4 Sn387; Calibrated: 6.9.2018
- Phantom: SAM; Type: QD000P40CD; Serial: TP:1670
- Measurement SW: DASY52, Version 52.8 (2); SEMCAD X Version 14.6.10 (7164)

BODY/BACK-L/Area Scan (8x12x1): Measurement grid: dx=15mm, dy=15mm Maximum value of SAR (measured) = 0.390 W/kg

BODY/BACK-L/Zoom Scan (5x5x7)/Cube 0: Measurement grid: dx=8mm, dy=8mm, dz=5mm Reference Value = 20.892 V/m; Power Drift = 0.07 dB Peak SAR (extrapolated) = 0.525 W/kg

SAR(1 g) = 0.327 W/kg; SAR(10 g) = 0.212 W/kg Maximum value of SAR (measured) = 0.384 W/kg



Shenzhen Anbotek Compliance Laboratory Limited

Address: 1/F., Building D, Sogood Science and Technology Park, Sanwei Community, Hangcheng Street, Bao'an District, Shenzhen, Guangdong, China. Tel:(86) 755-26066440 Fax: (86) 755-26014772 Email: service@anbotek.com



FCC ID: 2APX7K5B

Page 65 of 108 Date: 08/23/2019

WIFI 2.4G_Body Back_Ch11

Communication System: UID 0, wifi (fcc) (0); Frequency: 2462 MHz; Duty Cycle: 1:1 Medium parameters used (interpolated): f = 2462 MHz; σ = 1.963 S/m; ϵ r = 52.013; ρ = 1000 kg/m3 Phantom section: Flat Section

DASY5 Configuration:

- Probe: EX3DV4 SN7396; ConvF(7.53, 7.53, 7.53); Calibrated: 6.5.2019;
- Sensor-Surface: 2mm (Mechanical Surface Detection)
- Electronics: DAE4 Sn1303; Calibrated: 6.9.2018
- Phantom: SAM; Type: QD000P40CD; Serial: TP:1670
- Measurement SW: DASY52, Version 52.8 (2); SEMCAD X Version 14.6.10 (7164)

BODY/BACK-H/Area Scan (12x18x1): Measurement grid: dx=10mm, dy=10mm

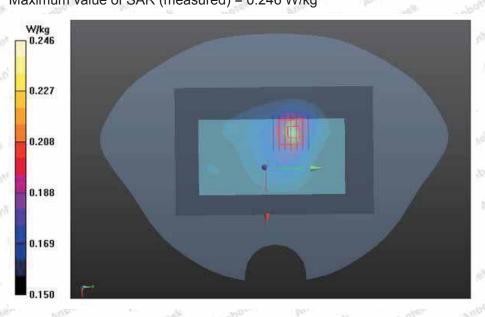
Maximum value of SAR (measured) = 0.223 W/kg

BODY/BACK-H/Zoom Scan (7x7x7)/Cube 0: Measurement grid: dx=5mm, dy=5mm, dz=5mm

Reference Value = 8.932 V/m; Power Drift = 0.04 dB

Peak SAR (extrapolated) = 0.416 W/kg

SAR(1 g) = 0.229 W/kg; SAR(10 g) = 0.191 W/kg Maximum value of SAR (measured) = 0.246 W/kg



Shenzhen Anbotek Compliance Laboratory Limited





FCC ID: 2APX7K5B

Page 66 of 108

Appendix D. DASY System Calibration Certificate

Schmid & Partner Engineering AG

speag

Zeughausstrasse 43, 8004 Zurich, Switzerland Phone +41 44 245 9700, Fax +41 44 245 9779 info@speag.com, http://www.speag.com

IMPORTANT NOTICE

USAGE OF THE DAE 4

The DAE unit is a delicate, high precision instrument and requires careful treatment by the user. There are no serviceable parts inside the DAE. Special attention shall be given to the following points:

Battery Exchange: The battery cover of the DAE4 unit is closed using a screw, over tightening the screw may cause the threads inside the DAE to wear out.

Shipping of the DAE: Before shipping the DAE to SPEAG for calibration, remove the batteries and pack the DAE in an antistatic bag. This antistatic bag shall then be packed into a larger box or container which protects the DAE from impacts during transportation. The package shall be marked to indicate that a fragile instrument is inside.

E-Stop Failures: Touch detection may be malfunctioning due to broken magnets in the E-stop. Rough handling of the E-stop may lead to damage of these magnets. Touch and collision errors are often caused by dust and dirt accumulated in the E-stop. To prevent E-stop failure, the customer shall always mount the probe to the DAE carefully and keep the DAE unit in a non-dusty environment if not used for measurements.

Repair: Minor repairs are performed at no extra cost during the annual calibration. However, SPEAG reserves the right to charge for any repair especially if rough unprofessional handling caused the defect.

DASY Configuration Files: Since the exact values of the DAE input resistances, as measured during the calibration procedure of a DAE unit, are not used by the DASY software, a nominal value of 200 MOhm is given in the corresponding configuration file.

Important Note:

Warranty and calibration is void if the DAE unit is disassembled partly or fully by the Customer.

Important Note:

Never attempt to grease or oil the E-stop assembly. Cleaning and readjusting of the Estop assembly is allowed by certified SPEAG personnel only and is part of the annual calibration procedure.

Important Note:

To prevent damage of the DAE probe connector pins, use great care when installing the probe to the DAE. Carefully connect the probe with the connector notch oriented in the mating position. Avoid any rotational movement of the probe body versus the DAE while turning the locking nut of the connector. The same care shall be used when disconnecting the probe from the DAE.

Schmid & Partner Engineering

TN_BR040315AD DAE4.doc

11.12.2009

Shenzhen Anbotek Compliance Laboratory Limited

Address, 1/F., Building D, Sogood Science and Technology Park, Sanwel Community, Hangcheng Street, Bao'an District, Shenzhen, Guangdong, China. Tel:(86) 755–26066440 Fax: (86) 755–26014772 Email: service@anbotek.com



FCC ID: 2APX7K5B

Page 67 of 108

Calibration Laboratory of Schmid & Partner Engineering AG sughausstrasse 43, 8004 Zurich, Switzerland Zeugt

Accredited by the Swiss Accreditation Service (SAS)

The Swiss Accreditation Service is one of the signatories to the EA Multilateral Agreement for the recognition of calibration certificates



Schweizerischer Kalibrierdienst s Service suisse d'étalonnage С Servizio avizzero di taratura S Swiss Calibration Service

Accreditation No.: SCS 0108

Certificate No: DAE4-387 Sep08

Calibration procedure(a) QA CAL-06.v29 Calibration procedure for the data acquisition electronics (DAE) Calibration date: September 06, 2018 This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SThe measurements and the uncertainties with confidence probability are given on the following pages and are part of the certific All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)*C and humidity < 70%. Calibration Equipment used (M&TE critical for calibration) Primary Standards ID # Cal Date (Certificate No.) Scheduled Calibration Keithey Multimeter Type 2001 SN: 0810278 15-Aug-16 (No:21092) Aug-19 Secondary Standards ID # Check Date (in house) Scheduled Check Auto DAE Calibration Unit SE UWS 053 AA 1001 05-Jen-16 (in house check) In house check	Client Anbotek (Aude	en)	Certificate I	No: DAE4-387_Sep08
Calibration procedure(s) QA CAL-06.v29 Calibration procedure for the data acquisition electronics (DAE) Calibration date: September 06, 2018 This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (S The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certific AI calibrations have been conducted in the closed taboratory facility: environment temperature (22 ± 3)*C and humidity < 70%. Calibration Equipment used (M&TE critical for calibration) Primary Standards ID # Cal Date (Certificate No.) Scheduled Calibration Keithey Mutimeter Type 2001 SN: 0810278 15-Aug-18 (No:21092) Aug-19 Secondary Standards ID # Check Date (in house) Scheduled Chee Auto DAE Calibration Unit SE UWS 006 AA 1002 05-Jan-18 (in house check) In house check	CALIBRATION	CERTIFICATE		
Calibration procedure for the data acquisition electronics (DAE) Calibration date: September 06, 2018 This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (5 The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certific All calibrations have been conducted in the closed taboratory facility: environment temperature (22 a 3)°C and humidity < 70%. Calibration Equipment used (M&TE critical for calibration) Primary Standards ID # Cal Date (Certificate No.) Scheduled Calibration Scheduled Calibration Standards Primary Standards ID # Cal Date (Certificate No.) Scheduled Calibration Calibration Standards Secondary Standards ID # Check Date (in house) Scheduled Check Date Calibration Standards Auto DAE Calibration Unit SE UWS 053 AA 1001 05-Jan-18 (in house check) In house check Calibrator Box V2.1 SE UMS 006 AA 1002 05-Jan-18 (in house check) In house check	Object	DAE4 - SD 000 D	004 BM - SN: 387	
This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (S The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certific All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)*C and humidity < 70%. Calibration Equipment used (M&TE critical for calibration) Primary Standards. ID # Cal Date (Certificate No.) Scheduled Calibration Keithlay Multimeter Type 2001 SN: 0810278 15-Aug-18 (No:21092) Aug-19 Secondary Standards ID # Check Date (in house) Scheduled Che Auto DAE Calibration Unit SE UWS 053 AA 1001 05-Jan-18 (in house check) In house check Calibrator Box V2.1 SE UMS 008 AA 1002 05-Jan-18 (in house check) In house check	Calibration procedure(s)	the state of the second s	dure for the data acquisition ele	ctronics (DAE)
The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certific All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)*C and humidity < 70%. Calibration Equipment used (M&TE critical for calibration) Primary Standards ID # Cal Date (Certificate No.) Scheduled Calib Keithley Multimeter Type 2001 SN: 0810278 15-Aug-18 (No:21092) Aug-19 Secondary Standards ID # Check Date (in house) Scheduled Che Auto DAE Calibration Unit SE UWS 053 AA 1001 05-Jan-16 (in house check) In house check Calibrator Box V2:1 SE UMS 006 AA 1002 05-Jan-18 (in house check) In house check	Calibration date:	September 06, 20	018	
Keithley Muttimeter Type 2001 SN: 0810278 15-Aug-18 (No:21092) Aug-19 Secondary Standards ID # Check Date (in house) Scheduled Che Auto DAE Calibration Unit SE UWS 053 AA 1001 05-Jan-16 (in house check) In house check Calibrator Box V2.1 SE UMS 008 AA 1002 05-Jan-16 (in house check) In house check	The measurements and the unce All calibrations have been condu Calibration Equipment used (M&	Intainties with confidence pe cted in the closed laboratory TE critical for calibration)	obability are given on the following pages a γ facility: environment temperature (22 \pm 3)	nd are part of the certificate.
Secondary Standards ID # Check Date (in house) Scheduled Che Auto DAE Calibration Unit SE UWS 053 AA 1001 05-Jan-18 (in house check) In house check Calibrator Box V2.1 SE UMS 008 AA 1002 05-Jan-18 (in house check) In house check		and the second se	and the second se	Scheduled Calibration
Auto DAE Calibration Unit SE UWS 053 AA 1001 05-Jan-18 (in house check) In house check Calibrator Box V2.1 SE UMS 008 AA 1002 05-Jan-18 (in house check) In house check	warming warminger (Abe \$201	1 94: 0810518	10-Aug-18 (No:21042)	Aug-19
Auto DAE Calibration Unit SE UWS 053 AA 1001 05-Jan-18 (in house check) In house check Calibrator Box V2.1 SE UMS 006 AA 1002 05-Jan-18 (in house check) In house check	Secondary Standards	ID#	Check Date (in house)	Scheduled Check
Name Function Signature	Auto DAE Calibration Unit Calibrator Box V2.1	1 20 3 8 20 3 3 5 1 2 5 1 2 5 1 5 5 5 F	and the second se	In house check: Jan-19 In house check: Jan-19
Name Puncom Signature		Mama	Danies	
Calibrated by: Dominique Steffen Laboratory Technician	Calibrated by:			algranue

Deputy Manager

Page 1 of 5

2.1 131

Ulum

Issued: September 03, 2018

Sven Kühn

This calibration certificate shall not be reproduced except in full without written approval of the laborate

Shenzhen Anbotek Compliance Laboratory Limited

Certificate No: DAE4-387 Sep08

Approved by:





FCC ID: 2APX7K5B

Page 68 of 108

Calibration Laboratory of Schmid & Partner Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland





Schweizerischer Kalibrierdienat Service suisse d'étalonnage Servizio svizzero di taratura Swiss Calibration Service

Accreditation No.: SCS 0108

Accredited by the Swiss Accreditation Service (SAS) The Swiss Accreditation Service is one of the signatories to the EA Multilateral Agreement for the recognition of calibration certificates

Glossary

DAE	data acquisition electronics
Connector angle	information used in DASY system to align probe sensor X to the robot coordinate system.

Methods Applied and Interpretation of Parameters

- DC Voltage Measurement: Calibration Factor assessed for use in DASY system by comparison with a calibrated instrument traceable to national standards. The figure given corresponds to the full scale range of the voltmeter in the respective range.
- Connector angle: The angle of the connector is assessed measuring the angle mechanically by a tool inserted. Uncertainty is not required.
- The following parameters as documented in the Appendix contain technical information as a
 result from the performance test and require no uncertainty.
 - DC Voltage Measurement Linearity: Verification of the Linearity at +10% and -10% of the nominal calibration voltage. Influence of offset voltage is included in this measurement.
 - Common mode sensitivity: Influence of a positive or negative common mode voltage on the differential measurement.
 - Channel separation: Influence of a voltage on the neighbor channels not subject to an input voltage.
 - AD Converter Values with inputs shorted: Values on the internal AD converter corresponding to zero input voltage
 - Input Offset Measurement: Output voltage and statistical results over a large number of zero voltage measurements.
 - Input Offset Current: Typical value for information; Maximum channel input offset current, not considering the input resistance.
 - Input resistance: Typical value for information: DAE input resistance at the connector, during internal auto-zeroing and during measurement.
 - Low Battery Alarm Voltage: Typical value for information. Below this voltage, a battery alarm signal is generated.
 - Power consumption: Typical value for information. Supply currents in various operating modes.

Certificate No: DAE4-387_Sep08

Page 2 of 5

Shenzhen Anbotek Compliance Laboratory Limited



FCC ID: 2APX7K5B

Page 69 of 108

DC Voltage Measurement A/D - Converter Resolution nominal

High Range:	1LSB =	6.1µV	full range =	-100+300 mV
Low Range:	1LSB =	61nV .	full range =	-1+3mV
DASY measurement	parameters: Aut	to Zero Time: 3	sec; Measuring	time: 3 sec

Calibration Factors	x	Y	z
High Range	404.489 ± 0.02% (k=2)	404.852 ± 0.02% (k=2)	404.862 ± 0.02% (k=2)
		3.95875 ± 1.50% (k=2)	

Connector Angle

Connector Angle to be used in DASY system	6202118
and a second and a second system	53.0°±1"

Certificate No: DAE4-387_Sep08

Page 3 of 5

Shenzhen Anbotek Compliance Laboratory Limited



FCC ID: 2APX7K5B

Page 70 of 108

Appendix (Additional assessments outside the scope of SCS0108)

1. DC Voltage Linearity

High Bange	Reading (µV)	Difference (µV)	Error (%)
Channel X + Input	200032.85	-3.31	-0.00
Channel X + Input	20007.64	1.88	0.01
Channel X - Input	-20003.48	1.18	-0.01
Channel Y + Input	200034.23	-1.43	-0.00
Channel Y + Input	20006.60	0.91	0.00
Channel Y - Input	-20004.04	0.72	-0.00
Channel Z + Input	200035.38	-0.83	-0.00
Channel Z + Input	20003.69	-2.11	-0.01
Channel Z - Input	-20006.38	-1.59	0.01

Low Range	Reading (µV)	Difference (µV)	Error (%)
Channel X + Input	2001.63	0.08	0.00
Channel X + Input	202.29	0.70	0.35
Channel X - Input	-197.90	0.60	-0.30
Channel Y + Input	2001.33	-0.07	-0.00
Channel Y + Input	200.86	-0.60	-0.30
Channel Y - Input	-199.87	-1.23	0.62
Channel Z + Input	2001.61	0.27	0.01
Channel Z + Input	200.60	-0.70	-0.35
Channel Z - Input	-199.51	-0.85	0.43

2. Common mode sensitivity

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	Common mode Input Voltage (mV)	High Range Average Reading (µV)	Low Range Average Reading (µV)
Channel X	200	13.50	11.56
	- 200	-8.64	-11.18
Channel Y	200	-0.81	-1.28
	- 200	1.05	0.09
Channel Z	200	7.17	6.91
	- 200	-9.46	-9.01

3. Channel separation

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	Input Voltage (mV)	Channel X (µV)	Channel Y (µV)	Channel Z (µV)
Channel X	200		-1.70	0.33
Channel Y	200	10.70		-0.38
Channel Z	200	7.11	7.89	

Certificate No: DAE4-387_Sep08

Page 4 of 5

Shenzhen Anbotek Compliance Laboratory Limited



FCC ID: 2APX7K5B

Page 71 of 108

4. AD-Converter Values with inputs shorted

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	High Range (LSB)	Low Range (LSB)
Channel X	15969	17466
Channel Y	15661	16162
Channel Z	15990	16190

5. Input Offset Measurement DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec Input 10MQ

	Average (μV)	min. Offset (µV)	max. Offset (µV)	Std. Deviation (µV)
Channel X	0.73	-2.58	3.29	0.62
Channel Y	0.41	-0.49	1.23	0.40
Channel Z	-0.80	-1.88	0.30	0.42

6. Input Offset Current

Nominal Input circuitry offset current on all channels: <25fA

7. Input Resistance (Typical values for information)

	Zeroing (kOhm)	Measuring (MOhm)
Channel X	200	200
Channel Y	200	200
Channel Z	200	200

8. Low Battery Alarm Voltage (Typical values for information)

Typical values	Alarm Level (VDC)
Supply (+ Vcc)	+7.9
Supply (- Vcc)	-7.6

9. Power Consumption (Typical values for information)

Typical values	Switched off (mA)	Stand by (mA)	Transmitting (mA)
Supply (+ Vcc)	+0.01	+6	+14
Supply (- Vcc)	-0.01	-8	-9

Certificate No: DAE4-387_Sep08

Page 5 of 5

Shenzhen Anbotek Compliance Laboratory Limited

Address: 1/F., Building D, Sogood Science and Technology Park, Sanwel Community, Hangcheng Street, Bao'an District, Shenzhen, Guangdong, China. Email: service@anbotek.com Tel:(86) 755-26066440 Fax: (86) 755-26014772





Shenzhen Anbotek Compliance Laboratory Limited





FCC ID: 2APX7K5B

Page 73 of 108



 Add: No.51 Xueyuan Road, Haidian District, Beijang, 100191, China

 Tel: +86-10-62304633-2218
 Fax: +86-10-62304633-2209

 E-mail: ettl@chinattl.com
 <u>Http://www.chinattl.cn</u>

Glossary:

TSL	tissue simulating liquid
NORMx,y,z	sensitivity in free space
ConvF	sensitivity in TSL / NORMx,y,z
DCP	diode compression point
CF	crest factor (1/duty_cycle) of the RF signal
A,B,C,D	modulation dependent linearization parameters
Polarization Φ	Φ rotation around probe axis
Polarization 0	θ rotation around an axis that is in the plane normal to probe axis (at measurement center), i θ=0 is normal to probe axis

Connector Angle information used in DASY system to align probe sensor X to the robot coordinate system Calibration is Performed According to the Following Standards:

- a) IEEE Std 1528-2013, "IEEE Recommended Practice for Determining the Peak Spatial-Averaged Specific Absorption Rate (SAR) in the Human Head from Wireless Communications Devices: Measurement Techniques", June 2013
- b) IEC 62209-1, "Procedure to measure the Specific Absorption Rate (SAR) for hand-held devices used in close proximity to the ear (frequency range of 300MHz to 3GHz)", February 2005
 c) IEC 62209-2, "Procedure to determine the Specific Absorption Rate (SAR) for wireless communication
- c) IEC 62209-2, "Procedure to determine the Specific Absorption Rate (SAR) for wireless communication devices used in close proximity to the human body (frequency range of 30 MHz to 6 GHz)", March 2010

d) KDB 865664, "SAR Measurement Requirements for 100 MHz to 6 GHz" Methods Applied and Interpretation of Parameters:

- NORMx,y,z: Assessed for E-field polarization θ=0 (f≤900MHz in TEM-cell; f>1800MHz: waveguide). NORMx,y,z are only intermediate values, i.e., the uncertainties of NORMx,y,z does not effect the E²-field uncertainty inside TSL (see below ConvF).
- NORM(f)x,y,z = NORMx,y,z* frequency_response (see Frequency Response Chart). This
 linearization is implemented in DASY4 software versions later than 4.2. The uncertainty of the
 frequency response is included in the stated uncertainty of ConvF.
- DCPx, y, z: DCP are numerical linearization parameters assessed based on the data of power sweep (no uncertainty required). DCP does not depend on frequency nor media.
- PAR: PAR is the Peak to Average Ratio that is not calibrated but determined based on the signal characteristics.
- Ax,y,z; Bx,y,z; Cx,y,z; VRx,y,z:A,B,C are numerical linearization parameters assessed based on the data of power sweep for specific modulation signal. The parameters do not depend on frequency nor media. VR is the maximum calibration range expressed in RMS voltage across the diode.
- ConvF and Boundary Effect Parameters: Assessed in flat phantom using E-field (or Temperature Transfer Standard for f≤800MHz) and inside waveguide using analytical field distributions based on power measurements for f >800MHz. The same setups are used for assessment of the parameters applied for boundary compensation (alpha, depth) of which typical uncertainty valued are given. These parameters are used in DASY4 software to improve probe accuracy close to the boundary. The sensitivity in TSL corresponds to NORMx.y.z* ConvF whereby the uncertainty corresponds to that given for ConvF. A frequency dependent ConvF is used in DASY version 4.4 and higher which allows extending the validity from±50MHz to±100MHz.
- Spherical isotropy (3D deviation from isotropy): in a field of low gradients realized using a flat phantom exposed by a patch antenna.
- Sensor Offset: The sensor offset corresponds to the offset of virtual measurement center from the
 probe tip (on probe axis). No tolerance required.
- Connector Angle: The angle is assessed using the information gained by determining the NORMx (no uncertainty required).

Certificate No: Z19-68716

Page 2 of 11

Shenzhen Anbotek Compliance Laboratory Limited

Address: 1/F., Building D, Sogood Science and Technology Park, Sanwel Community, Hangcheng Street, Bao'an District, Shenzhen, Guangdong, China. Tel:(86) 755–26066440 Fax: (86) 755–26014772 Email: service@anbotek.com





FCC ID: 2APX7K5B





Add: No.51 Xueyuan Road, Haidian Distri Tel: +86-10-62304633-2218 Fax: +86 E-mail: cttl@chinattLcom <u>Http://w</u>

ad, Haidian District, Beijing, 100191, China 118 Fax: +86-10-62304633-2209 Hitp://www.chinattl.en

Probe EX3DV4

SN: 7396

Calibrated: May 06, 2019

Calibrated for DASY/EASY Systems (Note: non-compatible with DASY2 system!)

Certificate No: Z19-68716

Page 3 of 11

Shenzhen Anbotek Compliance Laboratory Limited

Address: 1/F., Building D, Sogood Science and Technology Park, Sanwei Community, Hangcheng Street, Bao'an District, Shenzhen, Guangdong, China. Tel:(86) 755-26066440 Fax: (86) 755-26014772 Email: service@anbotek.com





FCC ID: 2APX7K5B

Page 75 of 108



 Add: No.51 Xueyuan Road, Haidian District, Beijing, 100191, China

 Tel: +86-10-62304633-2218
 Fax: +86-10-62304633-2209

 E-mail: cttl@chinattl.com
 <u>Http://www.chinattl.cn</u>

DASY/EASY – Parameters of Probe: EX3DV4 – SN: 7396

Basic Calibration Parameters

	Sensor X	Sensor Y	Sensor Z	Unc (k=2)
Norm(µV/(V/m)2)^	0.54	0.53	0.50	±10.0%
DCP(mV) ^B	97.8	104.5	102.5	

Modulation Calibration Parameters

UID	Communication System Name		A dB	B dBõV	c	D dB	VR mV	Unc [#] (k=2)
0	CW	X	0.0	0.0	1.0	0.00	199.9	±2.4%
		Y	0.0	0.0	1.0		203.3	
		z	0.0	0.0	1.0		195.0	

The reported uncertainty of measurement is stated as the standard uncertainty of Measurement multiplied by the coverage factor k=2, which for a normal distribution Corresponds to a coverage probability of approximately 95%.

^A The uncertainties of Norm X, Y, Z do not affect the E²-field uncertainty inside TSL (see Page 5 and Page 6). ^B Numerical linearization parameter: uncertainty not required.

^E Uncertainty is determined using the max. deviation from linear response applying rectangular distribution and is expressed for the square of the field value.

Certificate No: Z19-68716

Page 4 of 11

Shenzhen Anbotek Compliance Laboratory Limited

Address, 1/F., Building D, Sogood Science and Technology Park, Sanwel Community, Hangcheng Street, Bao'an District, Shenzhen, Guangdong, China. Tel:(86) 755-26066440 Fax: (86) 755-26014772 Email: service@anbotek.com





FCC ID: 2APX7K5B

Page 76 of 108



 Add: No.51 Xueyuan Road, Haidian District, Beijing, 100191, China

 Tel: +86-10-62304633-2218
 Fax: +86-10-62304633-2209

 E-mail: cttl@chinattl.com
 <u>Http://www.chinattl.cn</u>

DASY/EASY – Parameters of Probe: EX3DV4 – SN: 7396

Calibration Parameter Determined in Head Tissue Simulating Media

f [MHz] ^C	Relative Permittivity ^F	Conductivity (S/m) ^r	ConvF X	ConvF Y	ConvF Z	Alpha ^G	Depth ^G (mm)	Unct. (k=2)
750	41.9	0.89	9.82	9.82	9.82	0.30	0.85	±12.1%
835	41.5	0.90	9.71	9,71	9.71	0.15	1.36	±12.1%
900	41.5	0.97	9.87	9.87	9.87	0.16	1.37	±12.1%
1750	40.1	1.37	8.61	8.61	8.61	0.25	1.04	±12.1%
1900	40.0	1.40	8.13	8.13	8.13	0.24	1.01	±12.1%
2100	39.8	1.49	8.14	8.14	8.14	0.24	1.04	±12.1%
2300	39.5	1.67	7.85	7.85	7.85	0.40	0.75	±12.1%
2450	39.2	1.80	7.57	7.57	7.57	0.50	0.75	±12.1%
2600	39.0	1.96	7.38	7.38	7.38	0.64	0.68	±12.1%
5250	35.9	4.71	5.33	5.33	5.33	0.45	1.30	±13.3%
5600	35.5	5.07	4.89	4.89	4.89	0.45	1.35	±13.3%
5750	35.4	5.22	4.92	4.92	4.92	0.45	1.45	±13.3%

^C Frequency validity above 300 MHz of ±100MHz only applies for DASY v4.4 and higher (Page 2), else it is restricted to ±50MHz. The uncertainty is the RSS of ConvF uncertainty at calibration frequency and the uncertainty for the indicated frequency band. Frequency validity below 300 MHz is ± 10, 25, 40, 50 and 70 MHz for ConvF assessments at 30, 64, 128, 150 and 220 MHz respectively. Above 5 GHz frequency validity can be extended to ± 110 MHz.

⁶ At frequency below 3 GHz, the validity of tissue parameters (*c* and *o*) can be relaxed to ±10% if liquid compensation formula is applied to measured SAR values. At frequencies above 3 GHz, the validity of tissue parameters (*c* and *o*) is restricted to ±5%. The uncertainty is the RSS of the ConvF uncertainty for indicated target tissue parameters.
⁹ Alpha/Depth are determined during calibration. SPEAG warrants that the remaining deviation due to the boundary effect after compensation is always less than ± 1% for frequencies below 3 GHz and below ± 2% for the frequencies between 3-6 GHz at any distance larger than half the probe tip diameter from the boundary.

Certificate No: Z19-68716

Page 5 of 11

Shenzhen Anbotek Compliance Laboratory Limited

Address: 1/F., Building D, Sogood Science and Technology Park, Sanwel Community, Hangcheng Street, Bao'an District, Shenzhen, Guangdong, China. Tel:(86) 755-26066440 Fax: (86) 755-26014772 Email: service@anbotek.com





FCC ID: 2APX7K5B

Page 77 of 108



 Add: No.51 Xueyuan Road, Haidian District, Beijing, 100191, China

 Tel: +86-10-62304633-2218
 Fax: +86-10-62304633-2209

 E-mail: cttl/gchinattl.com
 <u>Http://www.chinattl.cn</u>

DASY/EASY – Parameters of Probe: EX3DV4 – SN: 7396

Calibration Parameter Determined in Body Tissue Simulating Media

f [MHz] ^C	Relative Permittivity	Conductivity (S/m) ^r	ConvF X	ConvF Y	ConvF Z	Alpha ^G	Depth ^G (mm)	Unct. (k=2)
750	55.5	0.96	10.09	10.09	10.09	0.30	0.90	±12.1%
835	55.2	0.97	9.88	9.88	9.88	0.19	1.32	±12.1%
900	55.0	1.05	9.82	9.82	9.82	0.23	1.15	±12.1%
1750	53.4	1.49	8.24	8.24	8.24	0.24	1.06	±12.1%
1900	53.3	1.52	7.97	7.97	7.97	0.19	1.24	±12.1%
2100	53.2	1.62	8.18	8.18	8.18	0.19	1.39	±12.1%
2300	52.9	1.81	7.88	7.88	7.88	0.55	0.80	±12.1%
2450	52.7	1.95	7.53	7.53	7.53	0.46	0.89	±12.1%
2600	52.5	2.16	7.38	7.38	7.38	0.52	0.80	±12.1%
5250	48.9	5.36	4.93	4.93	4.93	0.45	1.80	±13.3%
5600	48.5	5.77	4.19	4.19	4.19	0.48	1.90	±13.3%
5750	48.3	5.94	4.52	4.52	4.52	0.48	1.95	±13.3%

^C Frequency validity above 300 MHz of ±100MHz only applies for DASY v4.4 and higher (Page 2), else it is restricted to ±50MHz. The uncertainty is the RSS of ConvF uncertainty at calibration frequency and the uncertainty for the indicated frequency band. Frequency validity below 300 MHz is ± 10, 25, 40, 50 and 70 MHz for ConvF assessments at 30, 64, 128, 150 and 220 MHz respectively. Above 5 GHz frequency validity can be extended to ± 110 MHz.

[#] At frequency below 3 GHz, the validity of tissue parameters (ε and σ) can be relaxed to ±10% if liquid compensation formula is applied to measured SAR values. At frequencies above 3 GHz, the validity of tissue parameters (ε and σ) is restricted to ±5%. The uncertainty is the RSS of the ConvF uncertainty for indicated target tissue parameters.
[®] Alpha/Depth are determined during calibration. SPEAG warrants that the remaining deviation due to the boundary effect after compensation is always less than ± 1% for frequencies below 3 GHz and below ± 2% for the frequencies between 3-6 GHz at any distance larger than half the probe tip diameter from the boundary.

Certificate No: Z19-68716

Page 6 of 11

Shenzhen Anbotek Compliance Laboratory Limited

Address: 1/F., Building D, Sogood Science and Technology Park, Sanwel Community, Hangcheng Street, Bao'an District, Shenzhen, Guangdong, China. Tel:(86) 755-26066440 Fax: (86) 755-26014772 Email: service@anbotek.com





FCC ID: 2APX7K5B

Page 78 of 108

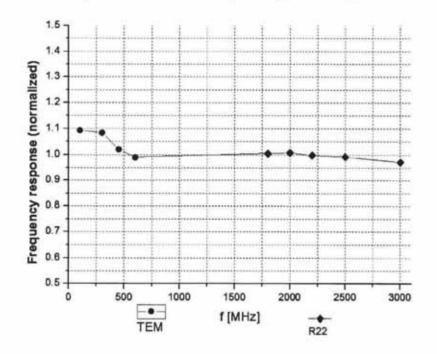


 Add: No.51 Xueyuan Roud, Haidian District, Beijing, 100191, China

 Tcl: +86-10-62304633-2218
 Fax: +86-10-62304633-2209

 E-mall: cttl/achinatt.com
 <u>Http://www.chinattl.cn</u>

Frequency Response of E-Field (TEM-Cell: ifi110 EXX, Waveguide: R22)





Certificate No: Z19-68716

Page 7 of 11

Shenzhen Anbotek Compliance Laboratory Limited

Address: 1/F., Building D, Sogood Science and Technology Park, Sanwei Community, Hangcheng Street, Bao'an District, Shenzhen, Guangdong, China. Tel:(86) 755-26066440 Fax: (86) 755-26014772 Email: service@anbotek.com



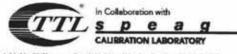


truggy

Report No.: R0219080013W

FCC ID: 2APX7K5B

Page 79 of 108



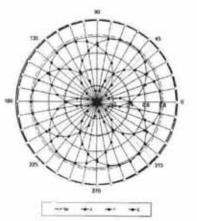
 Add: No.51 Xueyuan Rond, Haidian District, Beijing, 100191, China

 Tel: +86-10-62304633-2218
 Fax: +86-10-62304633-2209

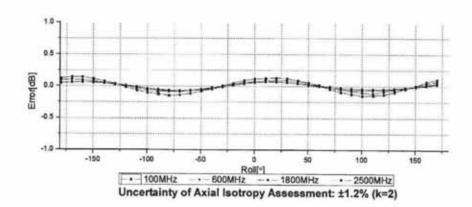
 E-mail: cul@chinattl.com
 <u>Http://www.chinattl.cn</u>

Receiving Pattern (Φ), θ=0°

f=600 MHz, TEM



f=1800 MHz, R22



Certificate No: Z19-68716

Page 8 of 11

Shenzhen Anbotek Compliance Laboratory Limited

Address: 1/F., Building D, Sogood Science and Technology Park, Sanwei Community, Hangcheng Street, Bao'an District, Shenzhen, Guangdong, China. Tel:(86) 755-26066440 Fax: (86) 755-26014772 Email: service@anbotek.com

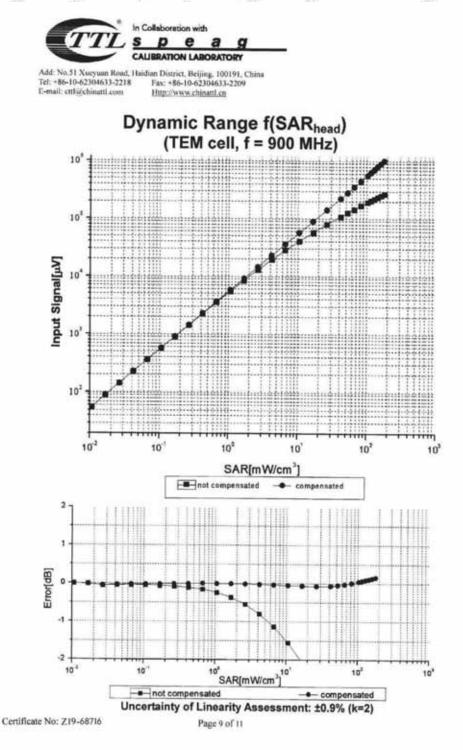


Anbotek Product Safety

Report No.: R0219080013W

FCC ID: 2APX7K5B

Page 80 of 108



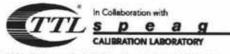
Shenzhen Anbotek Compliance Laboratory Limited

Address: 1/F., Building D, Sogood Science and Technology Park, Sanwel Community, Hangcheng Street, Bao'an District, Shenzhen, Guangdong, China. Tel:(86) 755–26066440 Fax: (86) 755–26014772 Email: service@anbotek.com Hotline 400-003-0500 www.anbotek.com Anbotek Product Safety

Report No.: R0219080013W

FCC ID: 2APX7K5B

Page 81 of 108

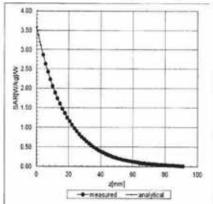


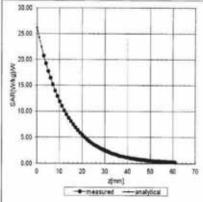
Add: No.51 Xueyuan Road, Haidian District, Beijing, 100191, China Tel: +86-10-62304633-2218 Fax: +86-10-62304633-2209 E-mail: ettl@chinattl.com <u>Http://www.chinattl.cn</u>

Conversion Factor Assessment

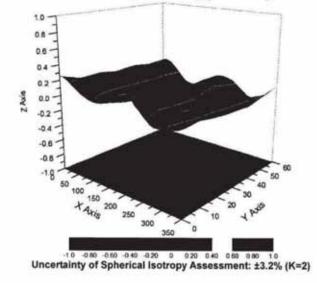
f=900 MHz, WGLS R9(H_convF)

f=1750 MHz, WGLS R22(H_convF)





Deviation from Isotropy in Liquid



Certificate No: Z19-68716

Page 10 of 11

Shenzhen Anbotek Compliance Laboratory Limited

Address: 1/F., Building D, Sogood Science and Technology Park, Sanwel Community, Hangcheng Street, Bao'an District, Shenzhen, Guangdong, China. Tel:(86) 755–26066440 Fax: (86) 755–26014772 Email: service@anbotek.com





FCC ID: 2APX7K5B

Page 82 of 108



 Add: No.51 Xueyuan Road, Haidian District, Beijing, 100191, China

 Tel: +86-10-62304633-2218
 Fax: +86-10-62304633-2209

 E-mail: cttl@chinatt.com
 <u>Http://www.chinattl.cn</u>

DASY/EASY – Parameters of Probe: EX3DV4 – SN: 7396

Other Probe Parameters

Sensor Arrangement	Triangular
Connector Angle (*)	156.9
Mechanical Surface Detection Mode	enabled
Optical Surface Detection Mode	disable
Probe Overall Length	337mm
Probe Body Diameter	10mm
Tip Length	9mm
Tip Diameter	2.5mm
Probe Tip to Sensor X Calibration Point	1mm
Probe Tip to Sensor Y Calibration Point	1mm
Probe Tip to Sensor Z Calibration Point	1mm
Recommended Measurement Distance from Surface	1.4mm

Certificate No: Z19-68716

Page 11 of 11

Shenzhen Anbotek Compliance Laboratory Limited

Address: 1/F., Building D, Sogood Science and Technology Park, Sanwel Community, Hangcheng Street, Bao'an District, Shenzhen, Guangdong, China. Tel:(86) 755-26066440 Fax: (86) 755-26014772 Email: service@anbotek.com





FCC ID: 2APX7K5B

Page 83 of 108

	CALIERAT		NAS関係互认
Add: No.51 Xueyun Tel: +86-10-623046		rict, Beijing, 100191, China	CALIBRATI CNAS L051
E-mail: cttl@chinatt	t.com Effectiv	www.chinatil.cn	
Gient	k (Auden)		8-97089
CALIBRATION CE	RTIFICAT	E	
Object	D835V2	- SN: 4d154	
Calibration Procedure(s)			
		-2-003-01 ion Procedures for dipole validation kits	
Calibration date:	Jun 16.		
Califoration date.	Jun 10,	2016	
pages and are part of the ce	rtificate.	the uncertainties with confidence probability he closed laboratory facility: environment	
pages and are part of the ce All calibrations have been	rtificate.	he closed laboratory facility: environment	
pages and are part of the ce All calibrations have been humidity<70%. Calibration Equipment used Primary Standards	ID #	he closed laboratory facility: environment or calibration) Cal Date(Calibrated by, Certificate No.)	temperature(22±3)°C ai Schedulet Calibration
pages and are part of the ce All calibrations have been humidity<70%. Calibration Equipment used Primary Standards Power Meter NRP2	ID # 101919	he closed laboratory facility: environment or calibration) Cal Date(Calibrated by, Certificate No.) 01-Jul-17 (CTTL, No.J17X04256)	temperature(22±3)°C ai Schedulet Calibration Jun-18
Pages and are part of the ce All calibrations have been humidity<70%. Calibration Equipment used Primary Standards Power Meter NRP2 Power sensor NRP-291	ID# 101547	he closed laboratory facility: environment or calibration) Cal Date(Calibrated by, Certificate No.) 01-Jul-17 (CTTL, No.J17X04256) 01-Jul-17 (CTTL, No.J17X04256)	temperature(22±3)°C and Scheduled Calibration Jun-18 Jun-18
pages and are part of the ce All calibrations have been humidity<70%. Calibration Equipment used Primary Standards Power Meter NRP2	ID # 101919	he closed laboratory facility: environment or calibration) Cal Date(Calibrated by, Certificate No.) 01-Jul-17 (CTTL, No.J17X04256)	temperature(22±3)°C ai Schedulet Calibration Jun-18
Pages and are part of the ce All calibrations have been humidity<70%. Calibration Equipment used Primary Standards Power Meter NRP2 Power sensor NRP-291 Reference Probe EX3DV4	ID# 101919 101547 SN 7307	he closed laboratory facility: environment or calibration) Cal Date(Calibrated by, Certificate No.) 01-Jul-17 (CTTL, No.J17X04256) 01-Jul-17 (CTTL, No.J17X04256) 19-Feb-18(SPEAG.No.EX3-7307_Feb18)	temperature(22±3) © an Schedulet Calibration Jun-18 Jun-18 Feb-19
Pages and are part of the ce All calibrations have been humidity<70%. Calibration Equipment used Primary Standards Power Meter NRP2 Power sensor NRP-291 Reference Probe EX3DV4 DAE4	ID# 101919 101547 SN 7307 SN 771	he closed laboratory facility: environment or calibration) Cal Date(Calibrated by, Certificate No.) 01-Jul-17 (CTTL, No.J17X04256) 01-Jul-17 (CTTL, No.J17X04256) 19-Feb-18(SPEAG,No.EX3-7307_Feb18) 02-Feb-18(CTTL-SPEAG,No.Z18-97011)	temperature(22±3) © an Schedulet Calibration Jun-18 Jun-18 Feb-19 Feb-19
Pages and are part of the ce All calibrations have been humidity<70%. Calibration Equipment used Primary Standards Power Meter NRP2 Power sensor NRP-291 Reference Probe EX3DV4 DAE4 Secondary Standards	ID # 101919 101547 SN 7307 SN 771 ID # MY49071430	he closed laboratory facility: environment or calibration) Cal Date(Calibrated by, Certificate No.) 01-Jul-17 (CTTL, No.J17X04256) 01-Jul-17 (CTTL, No.J17X04256) 19-Feb-18(SPEAG,No.EX3-7307_Feb18) 02-Feb-18(CTTL-SPEAG,No.Z18-97011) Cal Date(Calibrated by, Certificate No.)	temperature(22±3) © an Schedulet Calibration Jun-18 Jun-18 Feb-19 Feb-19 Schedulet Calibration
Pages and are part of the ce All calibrations have been humidity<70%. Calibration Equipment used Primary Standards Power Meter NRP2 Power sensor NRP-291 Reference Probe EX3DV4 DAE4 Secondary Standards Signal Generator E4438C	ID # 101919 101547 SN 7307 SN 771 ID # MY49071430	he closed laboratory facility: environment or calibration) Cal Date(Calibrated by, Certificate No.) 01-Jul-17 (CTTL, No.J17X04256) 01-Jul-17 (CTTL, No.J17X04256) 19-Feb-18(SPEAG,No.EX3-7307_Feb18) 02-Feb-18(CTTL-SPEAG,No.Z18-97011) Cal Date(Calibrated by, Certificate No.) 01-Feb-18 (CTTL, No.J18X00893)	temperature(22±3) C at Schedulet Calibration Jun-18 Jun-18 Feb-19 Feb-19 Schedulet Calibration Jan-19
Pages and are part of the ce All calibrations have been humidity<70%. Calibration Equipment used Primary Standards Power Meter NRP2 Power sensor NRP-291 Reference Probe EX3DV4 DAE4 Secondary Standards Signal Generator E4438C	rtificate. conducted in t (M&TE critical fo ID # 101919 101547 SN 7307 SN 7307 SN 771 ID # MY49071430 MY46110673	he closed laboratory facility: environment or calibration) Cal Date(Calibrated by, Certificate No.) 01-Jul-17 (CTTL, No.J17X04256) 01-Jul-17 (CTTL, No.J17X04256) 19-Feb-18(SPEAG,No.EX3-7307_Feb18) 02-Feb-18(CTTL-SPEAG,No.Z18-97011) Cal Date(Calibrated by, Certificate No.) 01-Feb-18 (CTTL, No.J18X00893) 26-Jan-18 (CTTL, No.J18X00894)	temperature(22±3) C at Scheduled Calibration Jun-18 Jun-18 Feb-19 Feb-19 Schedules Calibration Jan-19 Jan-19
Pages and are part of the ce All calibrations have been humidity<70%. Calibration Equipment used Primary Standards Power Meter NRP2 Power sensor NRP-291 Reference Probe EX3DV4 DAE4 Secondary Standards Signal Generator E4438C Network Analyzer E5071C	rtificate. conducted in t (M&TE critical fo ID # 101919 101547 SN 7307 SN 771 ID # MY49071430 MY49071430 MY46110673 Name	he closed laboratory facility: environment or calibration) Cal Date(Calibrated by, Certificate No.) 01-Jul-17 (CTTL, No.J17X04256) 01-Jul-17 (CTTL, No.J17X04256) 19-Feb-18(SPEAG.No.EX3-7307_Feb18) 02-Feb-18(CTTL-SPEAG.No.Z18-97011) Cal Date(Calibrated by, Certificate No.) 01-Feb-18 (CTTL, No.J18X00893) 26-Jan-18 (CTTL, No.J18X00894) Function	temperature(22±3) © an Schedulet Calibration Jun-18 Jun-18 Feb-19 Feb-19 Schedulet Calibration Jan-19 Jan-19
Pages and are part of the ce All calibrations have been humidity<70%. Calibration Equipment used Primary Standards Power Meter NRP2 Power sensor NRP-291 Reference Probe EX3DV4 DAE4 Secondary Standards Signal Generator E4438C Network Analyzer E5071C	rtificate. conducted in t (M&TE critical fo ID # 101919 101547 SN 7307 SN 771 ID # MY49071430 MY46110673 Name Zhao Jing	he closed laboratory facility: environment or calibration) Cal Date(Calibrated by, Certificate No.) 01-Jul-17 (CTTL, No.J17X04256) 01-Jul-17 (CTTL, No.J17X04256) 19-Feb-18(SPEAG.No.EX3-7307_Feb18) 02-Feb-18(CTTL-SPEAG.No.Z18-97011) Cal Date(Calibrated by, Certificate No.) 01-Feb-18 (CTTL, No.J18X00893) 26-Jan-18 (CTTL, No.J18X00894) Function SAR Test Engineer	temperature(22±3) © an Schedulet Calibration Jun-18 Jun-18 Feb-19 Feb-19 Schedulet Calibration Jan-19 Jan-19

Certificate No: Z18-97089

Page 1 of 8

Shenzhen Anbotek Compliance Laboratory Limited

Address: 1/F., Building D, Sogood Science and Technology Park, Sanwei Community, Hangcheng Street, Bao'an District, Sherizhen, Guangdong, China. Tel:(86) 755-26066440 Fax: (86) 755-26014772 Email: service@anbotek.com





FCC ID: 2APX7K5B

Page 84 of 108



Add: No.51 Xue n Road, Haid m District, Beijing, 100191, China Tel: +86-10-62304633-2079 Fax: +86-10-62304633-2504 Http://www.chinattl.co ail: ettl@chinattl.com

Glossary:

TSL ConvF N/A

tissue simulating liquid sensitivity in TSL / NORMx,y,z not applicable or not measured

Calibration is Performed According to the Following Standards:

- a) IEEE Std 1528-2013, "IEEE Recommended Practice for Determining the Peak Spatial-Averaged Specific Absorption Rate (SAR) in the Human Head from Wireless Communications Devices: Measurement Techniques*, June 2013
- b) IEC 62209-1, "Procedure to measure the Specific Absorption Rate (SAR) For hard-held devices used in close proximity to the ear (frequency range of 300MHz to 3GHz)', February 2005
- c) IEC 62209-2, "Procedure to measure the Specific Absorption Rate (SAR) For wireless communication devices used in close proximity to the human body (frequency range of 30MHz to 6GHz)", March 2010 d) KDB865664, SAR Measurement Requirements for 100 MHz to 6 GHz

Additional Documentation:

e) DASY4/5 System Handbook

Methods Applied and Interpretation of Parameters:

- Measurement Conditions: Further details are available from the Validation Report at the end of the certificate. All figures stated in the certificate are valid at the frequency indicated.
- Antenna Parameters with TSL: The dipole is mounted with the spacer to position its feed point exactly below the center marking of the flat phantom section, with the arms oriented parallel to the body axis.
- Feed Point Impedance and Return Loss: These parameters are measured with the dipole positioned under the liquid filled phantom. The impedance stated is transformed from the measurement at the SMA connector to the feed point. The Return Loss ensures ow reflected power. No uncertainty required.
- Electrical Delay: One-way delay between the SMA connector and the antenna feed point. No uncertainty required.
- SAR measured: SAR measured at the stated antenna input power.
- SAR normalized: SAR as measured, normalized to an input power of 1 W at the antenna connector.
- SAR for nominal TSL parameters: The measured TSL parameters are used to calculate the nominal SAR result.

The reported uncertainty of measurement is stated as the standard uncertainty of Measurement multiplied by the coverage factor k=2, which for a normal disribution Corresponds to a coverage probability of approximately 95%.

Certificate No: Z18-97089

Page 2 of 8

Shenzhen Anbotek Compliance Laboratory Limited

Address: 1/F., Building D, Sogood Science and Technology Park, Sanwei Community, Hangcheng Street, Bao'an District, Shenzhen, Guangdong, China. Tel:(86) 755-26066440 Fax: (86) 755-26014772 Email: service@anbotek.com





Anton

Report No.: R0219080013W

FCC ID: 2APX7K5B

Page 85 of 108



Add: No.51 Xueyuan Road, Haidian District, Beijing, 100191, China Tel: +86-10-62304633-2079 Fax: +86-10-62304633-2504 E-mail: etti@chinatil.com Http://www.chinatil.cn

Measurement Conditions

DASY Version	DASY52	52.8.8.1258
Extrapolation	Advanced Extrapolation	
Phantom	Triple Flat Phantom 5.1C	
Distance Dipole Center - TSL	15 mm	with Spacer
Zoom Scan Resolution	dx, dy, dz = 5 mm	
Frequency	835 MHz ± 1 MHz	

Head TSL parameters

The following parameters and calculations were applied

	Temperature	Permittivity	Conductivity
Nominal Head TSL parameters	22.0 °C	41.5	m/whm 00.0
Measured Head TSL parameters	(22.0 ± 0.2) °C	41.0 ± 6 %	0.89 mho/n ± 6 %
Head TSL temperature change during test	<1.0 °C		

SAR result with Head TSL

SAR averaged over 1 cm ² (1 g) of Head TSL	Condition	
SAR measured	250 mW input power	2.30 mW / g
SAR for nominal Head TSL parameters	normalized to 1W	9.24 mW /g ± 20.8 ½ (k=2)
SAR averaged over 10 cm ³ (10 g) of Head TSL	Condition	
SAR measured	250 mW input power	1.50 mW / g
SAR for nominal Head TSL parameters	normalized to 1W	6.02 mW /g ± 20.4 % (k=2)

Body TSL parameters

S

The following parameters and calculations were applied.

	Temperature	Permitti	vity	Conductivity
Nominal Body TSL parameters	22.0 °C	55.2		0.97 mho/m
Measured Body TSL parameters	(22.0 ± 0.2) °C	55.4 ± 6	3 %	0.99 mho/n ± 6 %
Body TSL temperature change during test	<1.0 °C	-		
R result with Body TSL				
SAR averaged over 1 cm3 (1 g) of Body TSL	Cond	ition		
SAR measured	250 mW in	nput power		2.43 mW/g
SAR for nominal Body TSL parameters	normalize	ed to 1W	9.57	mW /g ± 20.8 % (k=2)
SAR averaged over 10 cm ³ (10 g) of Body T	SL Cond	ition		
SAR measured	250 mW ir	nput power		1.61 mW/g
SAR for nominal Body TSL parameters	normalize	ed to 1W	6.36	mW /g ± 20.4 % (k=2)

Certificate No: Z18-97089

Page 3 of #

Shenzhen Anbotek Compliance Laboratory Limited

Address: 1/F., Building D, Sogood Science and Technology Park, Sanwei Community, Hangcheng Street, Bao'an District, Sherizhen, Guangdong, China. Tel:(86) 755–26066440 Fax: (86) 755–26014772 Email: service@anbotek.com





Antontol

prilon

Anbotok

(boto)

Report No.: R0219080013W

FCC ID: 2APX7K5B

Page 86 of 108



Add: No.51 Xueyuan Road, Haidian District, Beijing, 100191, China Tel: +86-10-62304633-2079 Fax: +86-10-62304633-2504 E-mail: ett/@chinattl.com Http://www.chinattl.en

Appendix

Antenna Parameters with Head TSL

Impedance, transformed to feed point	49.2D- 3.11jD	
Return Loss	- 29.8dB	

Antenna Parameters with Body TSL

Impedance, transformed to feed point	46.6Ω- 2.33jΩ	
Return Loss	- 27.4dB	

General Antenna Parameters and Design

Electrical Delay (one direction)	1.508 ns
The second s	

After long term use with 100W radiated power, only a slight warming of the dipole near the feedpoint can be measured.

The dipole is made of standard semirigid coaxial cable. The center conductor of the feeding line is directly connected to the second arm of the dipole. The antenna is therefore short-circuited for DC-signals. On some of the dipoles, small end caps are added to the dipole arms in order to improve matching when leaded according to the position as explained in the "Measurement Conditions" paragraph. The SAR data are not affected by this change. The overall dipole length is still according to the Standard. No excessive force must be applied to the dipole arms, because they might bend or the soldered connections near the feedpoint may be damaged.

Additional EUT Data

Manufactured by	SPEAG
-----------------	-------

Certificate No: Z18-97089

Page 4 of 8

Shenzhen Anbotek Compliance Laboratory Limited

Address: 1/F., Building D, Sogood Science and Technology Park, Sanwei Community, Hangcheng Street, Bao'an District, Shenzhen, Guangdong, China. Tel:(86) 755-26066440 Fax: (86) 755-26014772 Email: service@anbotek.com





FCC ID: 2APX7K5B

Page 87 of 108



ian District, Beijing, 100191, China Fax: +86-10-62304633-2504 Http://www.chinattl.cn Tel: +86-10-62304633-2079 nail: cttlijchinattl.com

DASY5 Validation Report for Head TSL

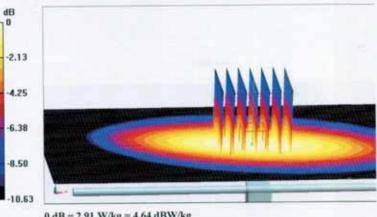
Date: 06.16.2018

Test Laboratory: CTTL, Beijing, China DUT: Dipole 835 MHz; Type: D835V2; Serial: D835V2 - SN: 4d154 Communication System: UID 0, CW; Frequency: 835 MHz; Duty Cycle: 1:1 Medium parameters used: f = 835 MHz; $\sigma = 0.891$ S/m; $\epsilon_r = 40.97$; $\rho = 1000$ kg/m³ Phantom section: Right Section Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2007) **DASY5** Configuration:

- Probe: EX3DV4 SN7307; ConvF(10.01, 10.01, 10.01); Calibrated: 2/19/2018;
- Sensor-Surface: 2mm (Mechanical Surface Detection) .
- Electronics: DAE4 Sn771; Calibrated: 2018-02-02 .
- Phantom: Triple Flat Phantom 5.1C; Type: QD 000 P51 CA; Serial: 1161/1
- Measurement SW: DASY52, Version 52.8 (8); SEMCAD X Version 14.6.10 (7372)

Dipole Calibration/Zoom Scan (7x7x7) (7x7x7)/Cube 0: Measurement grid: dx=5mm,

dy=5mm, dz=5mm Reference Value = 58.14V/m; Power Drift = 0.02 dB Peak SAR (extrapolated) = 3.41 W/kg SAR(1 g) = 2.3 W/kg; SAR(10 g) = 1.5 W/kg Maximum value of SAR (measured) = 2.91 W/kg



0 dB = 2.91 W/kg = 4.64 dBW/kg

Certificate No: Z18-97089

Page 5 of 8

Shenzhen Anbotek Compliance Laboratory Limited

Address: 1/F., Building D, Sogood Science and Technology Park, Sanwei Community, Hangcheng Street, Bao'an District, Sherizhen, Guangdong, China. Tel:(86) 755-26066440 Fax: (86) 755-26014772 Email: service@anbotek.com



Anibo



prilor

Antoptel

prilon

Anbotel

Anbotel

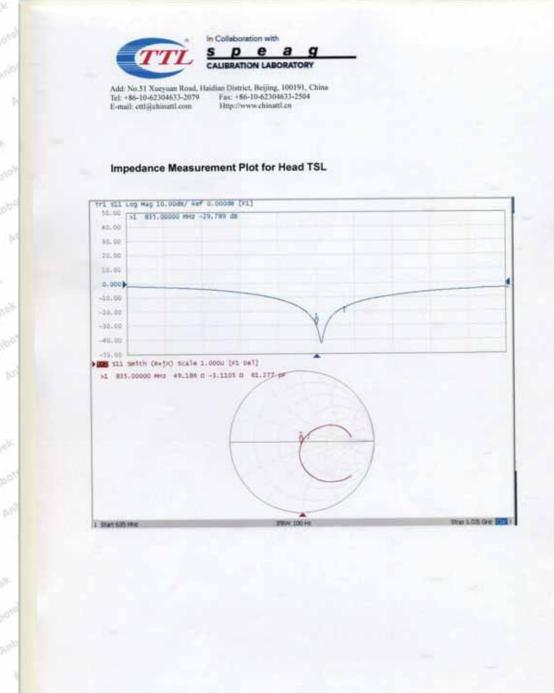
(botok

Report No.: R0219080013W

FCC ID: 2APX7K5B

Page 88 of 108

Anbote



Certificate No: Z18-97089 Page 6 of 8

Shenzhen Anbotek Compliance Laboratory Limited

Address: 1/F., Building D, Sogood Science and Technology Park, Sanwei Community, Hangcheng Street, Bao'an District, Shenzhen, Guangdong, China. Tel:(86) 755-26066440 Fax: (86) 755-26014772 Email: service@anbotek.com



Anbo



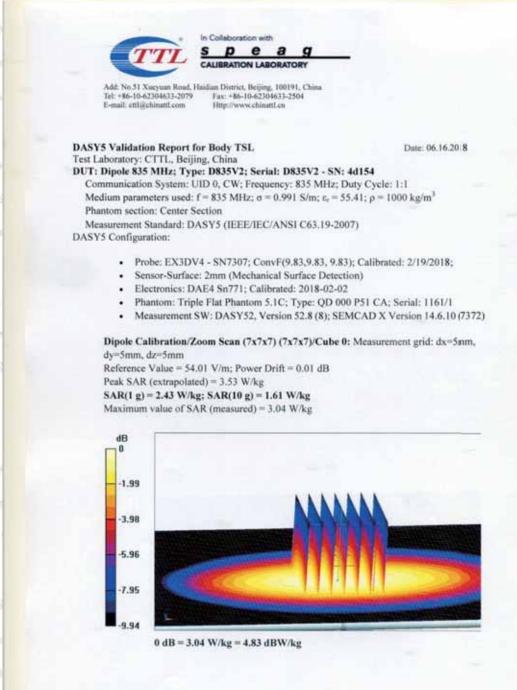
Antontel

(boto)

Report No.: R0219080013W

FCC ID: 2APX7K5B

Page 89 of 108



Certificate No: Z18-97089

Page 7 of 8

Shenzhen Anbotek Compliance Laboratory Limited

Address: 1/F., Building D, Sogood Science and Technology Park, Sanwei Community, Hangcheng Street, Bao'an District, Sherizhen, Guangdong, China. Tel:(86) 755-26066440 Fax: (86) 755-26014772 Email: service@anbotek.com





prilor

Anton

Mon

Anbotel

Anbol

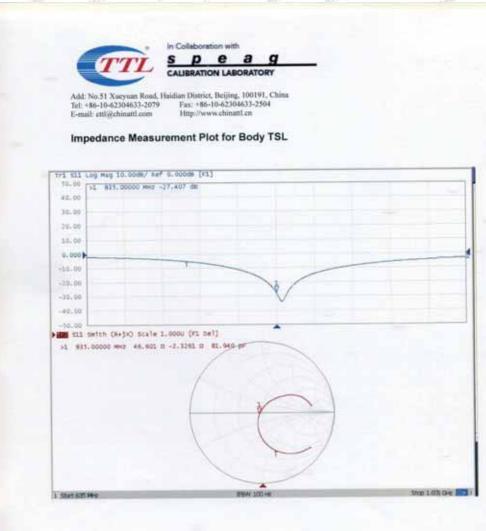
(botok

Report No.: R0219080013W

FCC ID: 2APX7K5B

Page 90 of 108

Anbote



Certificate No: Z18-97089 Page # of #

Shenzhen Anbotek Compliance Laboratory Limited

Address: 1/F., Building D, Sogood Science and Technology Park, Sanwei Community, Hangcheng Street, Bao'an District, Shenzhen, Guangdong, China. Tel:(86) 755-26066440 Fax: (86) 755-26014772 Email: service@anbotek.com



antro

Anbo

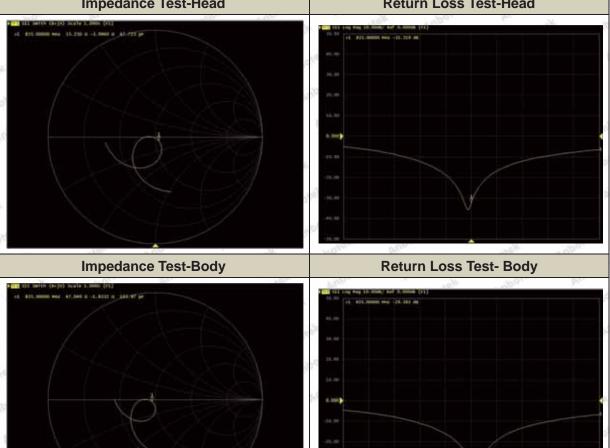
FCC ID: 2APX7K5B

Page 91 of 108

Justification of the extended calibration of Dipole D835V2 SN: 4d154

Per KDB 865664, we have Measured the Impedance and Return Loss as below, and the return lossis <-20dB, with 20% of prior calibration; the real or imaginary parts of the impedance is with 5 ohm of prior calibration. Therefore the verification result should support extended calibration.

Dipole 835 Head TST	Target Value	Measured Value	Difference
Impedance transformed tofeed point	49.20Ω-3.11jΩ	53.25Ω-3.99jΩ	R=4.05Ω,X=-0.88Ω
Return Loss	-29.80dB	-32.32dB	8.46%
Dipole 835 Body TST	Target Value	Measured Value	Difference
Impedance transformed tofeed point	46.60Ω-2.33jΩ	47.04Ω-1.83jΩ	R=0.44Ω,X=0.50Ω
Return Loss	-27.4dB	-29.58dB	7.96%
Measured Date	2018-06-16	2019-06-14	- intertert briter
Impedance	Tost-Hoad	Return Lo	es Test-Head



Shenzhen Anbotek Compliance Laboratory Limited

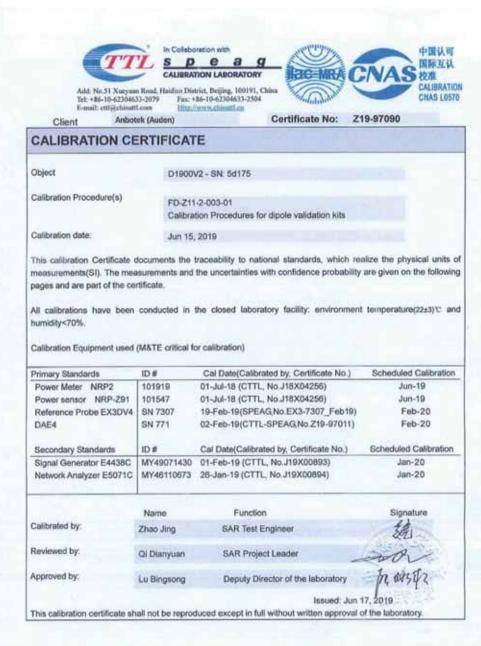
Address: 1/F., Building D, Sogood Science and Technology Park, Sanwel Community, Hangcheng Street, Bao'an District, Shenzhen, Guangdong, China. Tel:(86) 755–26066440 Fax: (86) 755–26014772 Email: service@anbotek.com





FCC ID: 2APX7K5B

Page 92 of 108



Certificate No: Z19-97090

Page 1 of 8

Shenzhen Anbotek Compliance Laboratory Limited

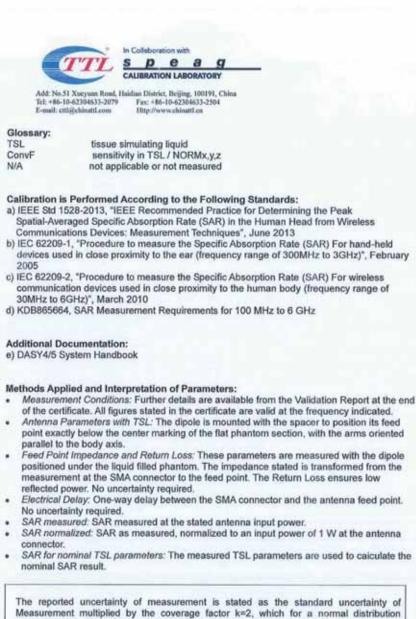
Address, 1/F., Building D, Sogood Science and Technology Park, Sanwel Community, Hangcheng Street, Bao'an District, Shenzhen, Guangdong, China. Tel:(86) 755–26066440 Fax: (86) 755–26014772 Email: service@anbotek.com





FCC ID: 2APX7K5B

Page 93 of 108



Corresponds to a coverage probability of approximately 95%.

Certificate No: Z19-97090

Page 2 of 8

Shenzhen Anbotek Compliance Laboratory Limited

Address: 1/F., Building D, Sogood Science and Technology Park, Sanwel Community, Hangcheng Street, Bao'an District, Shenzhen, Guangdong, China. Tel:(86) 755–26066440 Fax: (86) 755–26014772 Email: service@anbotek.com





FCC ID: 2APX7K5B

Page 94 of 108



Add: No.51 Xncyuan Road, Haidian District, Beijing, 100191, China Tel: +86-10-62304633-2079 Fax: +86-10-62304633-2504 E-mail: cttl@chinattl.com Http://www.chinattl.cn

Measurement Conditions

DASY Version	DASY52	52.8.8.1258
Extrapolation	Advanced Extrapolation	
Phantom	Triple Flat Phantom 5.1C	
Distance Dipole Center - TSL	10 mm	with Spacer
Zoom Scan Resolution	dx, dy, dz = 5 mm	
Frequency	1900 MHz ± 1 MHz	

Head TSL parameters

	Temperature	Permitt	ivity	Conductivity
Nominal Head TSL parameters	22.0 °C	40.0	1	1,40 mho/m
Measured Head TSL parameters	(22.0 ± 0.2) °C	40.3 ±	6 %	1.38 mho/m ± 6 %
Head TSL temperature change during test	<1.0 *C			
R result with Head TSL				
SAR averaged over 1 cm ³ (1 g) of Head TSL	. Cond	tion		
SAR measured	250 mW in	put power		9.99 mW / g
SAR for nominal Head TSL parameters	normalize	rd to 1W	40.4	mW /g ± 20.8 % (k=2)
SAR averaged over 10 cm ³ (10 g) of Head T	SL Condi	tion		
SAR measured	250 mW ir	put power		5.28 mW / g
SAR for nominal Head TSL parameters	normalize	d to 1W	21.3	mW /g ± 20.4 % (k=2)
			-	

Body TSL parameters

	Temperature	Permitti	ivity	Conductivity
Nominal Body TSL parameters	22.0 °C	53.3	f.	1.52 mho/m
Measured Body TSL parameters	(22.0 ± 0.2) *C	53.3 ±	6 %	1.54 mho/m ± 6 %
Body TSL temperature change during test	<1.0 °C			
R result with Body TSL				
SAR averaged over 1 cm ³ (1 g) of Body TSL	Con	dition	1.	
SAR measured	250 mW	input power		10.1 mW/g
SAR for nominal Body TSI, parameters	normalia	ted to 1W	40.1	mW /g ± 20.8 % (k=2)
SAR averaged over 10 cm3 (10 g) of Body T	SL Con	tition		
SAR measured	250 mW	input power		5.39 mW/g
SAR for nominal Body TSL parameters	normaliz	ted to 1W	21.5	mW /g ± 20.4 % (k=2)

Certificate No: Z19-97090

Page 3 of #

Shenzhen Anbotek Compliance Laboratory Limited

Address: 1/F., Building D, Sogood Science and Technology Park, Sanwel Community, Hangcheng Street, Bao'an District, Shenzhen, Guangdong, China. Tel:(86) 755–26066440 Fax: (86) 755–26014772 Email: service@anbotek.com





prior

huga

botek

Report No.: R0219080013W

FCC ID: 2APX7K5B

Page 95 of 108

The second second			tion wit	1	
TTT	S	P	e	a	g
	CAU	BRATIC	ON LAI	IORAT	DRY

Add: No.51 Xueyuan Road, Hahduan Dotriet, Beijing, 100191, China Tal. +86-10-62304633-2079 Fax: +86-10-62304633-2504 E-mail: ethl@chinatil.com Ibttp://www.chinatil.en

Appendix

Antenna Parameters with Head TSL

Impedance, transformed to feed point	53.2Ω+ 5.44jΩ	
Return Loss	~ 24.3dB	

Antenna Parameters with Body TSL

Impedance, transformed to feed point	48.9Ω+ 5.75jΩ	
Return Loss	- 24.6dB	

General Antenna Parameters and Design

304 ns
1

After long term use with 100W radiated power, only a slight warming of the dipole near the feedpoint can be measured.

The dipole is made of standard semirigid coaxial cable. The center conductor of the feeding line is directly connected to the second arm of the dipole. The antenna is therefore short-circuited for DC-signals. On some of the dipoles, small end caps are added to the dipole arms in order to improve matching when loaded according to the position as explained in the "Measurement Conditions" paragraph. The SAR data are not affected by this change. The overall dipole length is still according to the Standard. No excessive force must be applied to the dipole arms, because they might bend or the soldered connections near the feedpoint may be damaged.

Additional EUT Data

Manufactured by	SPEAG

Certificate No: Z19-97090

Page 4 of 8

Shenzhen Anbotek Compliance Laboratory Limited

Address: 1/F., Building D, Sogood Science and Technology Park, Sanwel Community, Hangcheng Street, Bao'an District, Shenzhen, Guangdong, China. Tel:(86) 755-26066440 Fax: (86) 755-26014772 Email: service@anbotek.com



Anbo



truggy

Report No.: R0219080013W

FCC ID: 2APX7K5B

Page 96 of 108



Add: No.51 Xueyuan Rund, Hasidian Diatrist, Beijing, 100191, China Tel: +16-10-62304633-2079 Fax: +16-10-62304633-2504 E-mail: ettlijechinatti.com Http://www.chinattil.cn

DASY5 Validation Report for Head TSL Test Laboratory: CTTL, Beijing, China DUT: Dinole 1900 MHz: Type: D1900V2: Serial:

Date: 06.15.2019

DUT: Dipole 1900 MHz; Type: D1900V2; Serial: D1900V2 - SN: 5d175 Communication System: UID 0, CW; Frequency: 1900 MHz; Duty Cycle: 1:1

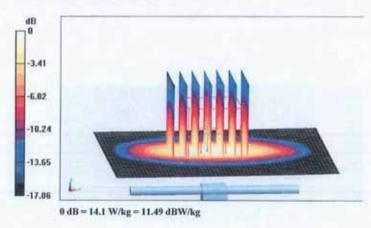
Medium parameters used: f = 1900 MHz; $\sigma = 1.381 \text{ S/m}$; $\epsilon r = 40.33$; $\rho = 1000 \text{ kg/m3}$ Phantom section: Right Section

Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2007)

DASY5 Configuration:

- Probe: EX3DV4 SN7307; ConvF(8.1, 8.1, 8.1); Calibrated: 2/19/2019;
- Sensor-Surface: 2mm (Mechanical Surface Detection)
- Electronics: DAE4 Sn771; Calibrated: 2/2/2019
- Phantom: Triple Flat Phantom 5.1C; Type: QD 000 P51 CA; Serial: 1161/1
- Measurement SW: DASY52, Version 52.8 (8); SEMCAD X Version 14.6.10 (7372)

System Performance Check/Zoom Scan (7x7x7) (7x7x7)/Cube 0: Measurement grid; dx=5mm, dy=5mm, dz=5mm Reference Value = 103.5V/m; Power Drift = 0.00 dB Peak SAR (extrapolated) = 18.0W/kg SAR(1 g) = 9.99 W/kg; SAR(10 g) = 5.28 W/kg Maximum value of SAR (measured) = 14.1 W/kg



Certificate No: Z19-97090

Page 5 of 8

Shenzhen Anbotek Compliance Laboratory Limited

Address: 1/F., Building D, Sogood Science and Technology Park, Sanwel Community, Hangcheng Street, Bao'an District, Shenzhen, Guangdong, China. Tel:(86) 755-26066440 Fax: (86) 755-26014772 Email: service@anbotek.com





Antophek

Antonek

pripoteix

Antonesk

ibone*

habat

Antophel

Report No.: R0219080013W

FCC ID: 2APX7K5B

Page 97 of 108

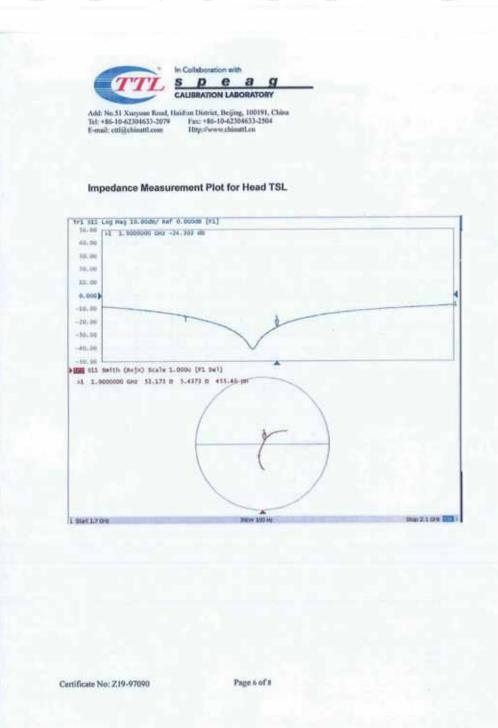
Anbo

Antostak

Asibo

Anbote

Anborek



Shenzhen Anbotek Compliance Laboratory Limited

Address: 1/F., Building D, Sogood Science and Technology Park, Sanwel Community, Hangcheng Street, Bao'an District, Shenzhen, Guangdong, China. Tel:(86) 755-26066440 Fax: (86) 755-26014772 Email: service@anbotek.com



Antiot

Anbor

pobl



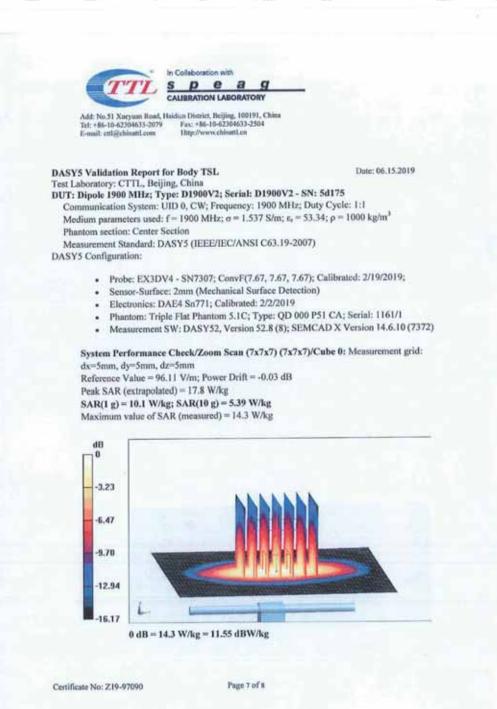
trupod

botek

Report No.: R0219080013W

FCC ID: 2APX7K5B

Page 98 of 108



Shenzhen Anbotek Compliance Laboratory Limited

Address: 1/F., Building D, Sogood Science and Technology Park, Sanwel Community, Hangcheng Street, Bao'an District, Shenzhen, Guangdong, China. Tel:(86) 755-26066440 Fax: (86) 755-26014772 Email: service@anbotek.com





Antophek

trupo

botek

Antopiek

Anabhr

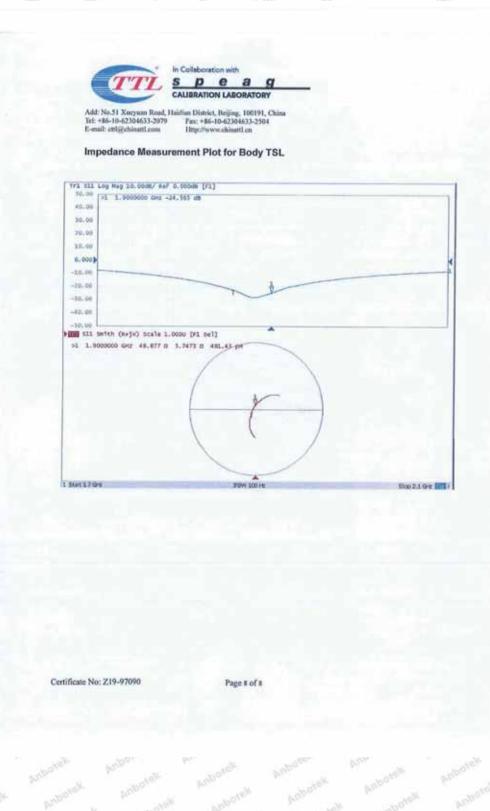
Report No.: R0219080013W

FCC ID: 2APX7K5B

Page 99 of 108

Anbolt

Anborel



Shenzhen Anbotek Compliance Laboratory Limited

Address: 1/F., Building D, Sogood Science and Technology Park, Sanwel Community, Hangcheng Street, Bao'an District, Shenzhen, Guangdong, China. Tel:(86) 755-26066440 Fax: (86) 755-26014772 Email: service@anbotek.com



6 inthi

haba

Antostak

Asibo



Issued: Jun 17, 2018

This calibration certificate shall not be reproduced except in full without written approval of the laboratory.

Certificate No: Z18-97091

Page 1 of 8

Shenzhen Anbotek Compliance Laboratory Limited

Address: 1/F., Building D, Sogood Science and Technology Park, Sanwei Community, Hangcheng Street, Bao'an District, Sherizhen, Guangdong, China. Tel:(86) 755-26066440 Fax: (86) 755-26014772 Email: service@anbotek.com



Anbotek Product Safety



E-mail: cttl@chinattl.com

Add: No.51 Xueyuan Road, Haidian District, Beijing, 100191, China Tel: +86-10-62304633-2079 Fax: +86-10-62304633-2504 Http://www.chinattl.cn

е CALIBRATION LABORATORY

FCC ID: 2APX7K5B

Glossary:

TSL ConvF N/A

tissue simulating liquid sensitivity in TSL / NORMx,y,z not applicable or not measured

Calibration is Performed According to the Following Standards:

- a) IEEE Std 1528-2013, "IEEE Recommended Practice for Determining the Peak Spatial-Averaged Specific Absorption Rate (SAR) in the Human Head from Wireless Communications Devices: Measurement Techniques", June 2013
- b) IEC 62209-1, "Procedure to measure the Specific Absorption Rate (SAR) For hand-held devices used in close proximity to the ear (frequency range of 300MHz to 3GHz)", February 2005
- c) IEC 62209-2, "Procedure to measure the Specific Absorption Rate (SAR) For wireless communication devices used in close proximity to the human body (frequency range of 30MHz to 6GHz)", March 2010
- d) KDB865664, SAR Measurement Requirements for 100 MHz to 6 GHz

Additional Documentation:

e) DASY4/5 System Handbook

Methods Applied and Interpretation of Parameters:

- Measurement Conditions: Further details are available from the Validation Report at the end of the certificate. All figures stated in the certificate are valid at the frequency indicated.
- Antenna Parameters with TSL: The dipole is mounted with the spacer to position its feed point exactly below the center marking of the flat phantom section, with the arms oriented parallel to the body axis.
- Feed Point Impedance and Return Loss: These parameters are measured with the dipole positioned under the liquid filled phantom. The impedance stated is transformed from the measurement at the SMA connector to the feed point. The Return Loss ensures low reflected power. No uncertainty required.
- Electrical Delay: One-way delay between the SMA connector and the antenna feed point. No uncertainty required.
- SAR measured: SAR measured at the stated antenna input power.
- SAR normalized: SAR as measured, normalized to an input power of 1 W at the antenna connector.
- SAR for nominal TSL parameters: The measured TSL parameters are used to calculate the nominal SAR result.

The reported uncertainty of measurement is stated as the standard uncertainty of Measurement multiplied by the coverage factor k=2, which for a normal distribution Corresponds to a coverage probability of approximately 95%.

Certificate No: Z18-9709

age 2 of 8

Shenzhen Anbotek Compliance Laboratory Limited

Address: 1/F., Building D. Sogood Science and Technology Park, Sanwei Community, Hangcheng Street, Bao'an District, Shenzhen, Guangdong, China. Tel:(86) 755-26066440 Fax: (86) 755-26014772 Email: service@anbotek.com



Page 101 of 108



Antonto

Report No.: R0219080013W



FCC ID: 2APX7K5B





In Collaboration 5 p е а CALIBRATION LABORATORY

Add: No.51 Xueyuan Road, Haidian District, Beijing, 100191, China Tel: +86-10-62304633-2079 Fax: +86-10-62304633-2504 E-mail: ettl@chinattl.com Http://www.chinattl.cn

Measurement Conditions

DASY system configuration, as far as not given on page 1.

DASY Version	DASY52	52.8.8.1258
Extrapolation	Advanced Extrapolation	United States Land C
Phantom	Triple Flat Phantom 5.1C	
Distance Dipole Center - TSL	10 mm	with Spacer
Zoom Scan Resolution	dx, dy, dz = 5 mm	
Frequency	2450 MHz ± 1 MHz	

Head TSL parameters

The following parameters and calculations were applied.

	Temperature	Permittivity	Conductivity
Nominal Head TSL parameters	22.0 °C	39.2	1.80 mhø/m
Measured Head TSL parameters	(22.0 ± 0.2) °C	39.0 ± 6 %	1.77 mho/n ± 6 %
Head TSL temperature change during test	<1.0 °C		

SAR result with Head TSL

SAR averaged over 1 cm ³ (1 g) of Head TSL	Condition	
SAR measured	250 mW input power	13.0 mW / g
SAR for nominal Head TSL parameters	normalized to 1W	52.4 mW /g ± 20.8 % (k=2)
SAR averaged over 10 cm ³ (10 g) of Head TSL	Condition	
SAR measured	250 mW input power	6.06 mW / g
SAR for nominal Head TSL parameters	normalized to 1W	24.3 mW /g ± 20.4 % (k=2)

Body TSL parameters

The following parameters and calculations were applied.

	Temperature	Permittivity	Conductivity
Nominal Body TSL parameters	22.0 °C	52.7	1.95 mho/m
Measured Body TSL parameters	(22.0 ± 0.2) °C	52.9 ± 6 %	1.97 mho/m ± 6 %
Body TSL temperature change during test	<1.0 °C	1111	1000

SAR result with Body TSL

SAR averaged over 1 cm ³ (1 g) of Body TSL	Condition	
SAR measured	250 mW input power	13.0 mW / g
SAR for nominal Body TSL parameters	normalized to 1W	51.8 mW /g ± 20.8 % (k=2)
SAR averaged over 10 cm ³ (10 g) of Body TSL	Condition	
SAR measured	250 mW input power	6.18 mW / g
SAR for nominal Body TSL parameters	normalized to 1W	24.7 mW /g ± 20.4 % (k=2)

Certificate No: Z18-97091

Page 3 of 8

Shenzhen Anbotek Compliance Laboratory Limited

Address: 1/F., Building D, Sogood Science and Technology Park, Sanwei Community, Hangcheng Street, Bao'an District, Shenzhen, Guangdong, China. Tel:(86) 755-26066440 Fax: (86) 755-26014772 Email: service@anbotek.com





Antontol

(botok

Report No.: R0219080013W

FCC ID: 2APX7K5B

Page 103 of 108



Add: No.51 Xueyuan Road, Haidian District, Beijing, 100191, China Tel: +86-10-62304633-2079 Fax: +86-10-62304633-2504 E-mail: ctil/@chinattl.com Http://www.chinattl.cn

Appendix

Antenna Parameters with Head TSL

Impedance, transformed to feed point	54.6Ω+ 2.77jΩ	
Return Loss	- 25.8dB	

Antenna Parameters with Body TSL

Impedance, transformed to feed point	50.7Ω+ 4.28jΩ	
Return Loss	- 27.3dB	

General Antenna Parameters and Design

Electrical Delay (one direction)	1.263 ns
----------------------------------	----------

After long term use with 100W radiated power, only a slight warming of the dipole near the feedpoint can be measured.

The dipole is made of standard semirigid coaxial cable. The center conductor of the feeding line is directly connected to the second arm of the dipole. The antenna is therefore short-circuited for DC-signals. On some of the dipoles, small end caps are added to the dipole arms in order to improve matching when leaded according to the position as explained in the "Measurement Conditions" paragraph. The SAR data are not affected by this change. The overall dipole length is still according to the Standard. No excessive force must be applied to the dipole arms, because they might bend or the soldered connections near the feedpoint may be damaged.

Additional EUT Data

Manufactured by	SPEAG

Certificate No: Z18-97091

Page 4 of 8

Shenzhen Anbotek Compliance Laboratory Limited

Address: 1/F., Building D, Sogood Science and Technology Park, Sanwei Community, Hangcheng Street, Bao'an District, Shenzhen, Guangdong, China. Tel:(86) 755-26066440 Fax: (86) 755-26014772 Email: service@anbotek.com





FCC ID: 2APX7K5B

Page 104 of 108



Fax: +86-10-62304633-2504 Http://www.chinattl.cn mail: ettl@chinattl.com

DASY5 Validation Report for Head TSL

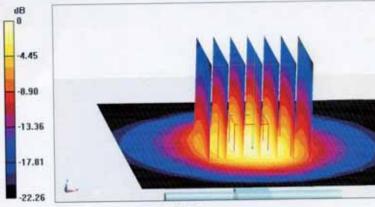
Date: 06.15.2018

Test Laboratory: CTTL, Beijing, China DUT: Dipole 2450 MHz; Type: D2450V2; Serial: D2450V2 - SN: 910 Communication System: UID 0, CW; Frequency: 2450 MHz; Duty Cycle: 1:1 Medium parameters used: f = 2450 MHz; σ = 1.767 S/m; εr = 39.01; ρ = 1000 kg/m3 Phantom section: Right Section Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2007) **DASY5** Configuration:

- Probe: EX3DV4 SN7307; ConvF(7.36, 7.36, 7.36); Calibrated: 2/19/2018;
- Sensor-Surface: 2mm (Mechanical Surface Detection)
- Electronics: DAE4 Sn771; Calibrated: 2018-02-02
- Phantom: Triple Flat Phantom 5.1C; Type: QD 000 P51 CA; Serial: 1161/1
- Measurement SW: DASY52, Version 52.8 (8); SEMCAD X Version 14.6.10 (7372)

Dipole Calibration/Zoom Scan (7x7x7) (7x7x7)/Cube 0: Measurement grid: dx=5mm, dy=5mm, dz=5mm Reference Value = 106.5 V/m; Power Drift = 0.02 dB Peak SAR (extrapolated) = 26.7 W/kg SAR(1 g) = 13 W/kg; SAR(10 g) = 6.06 W/kg

Maximum value of SAR (measured) = 19.7 W/kg



0 dB = 19.7 W/kg = 12.94 dBW/kg

Certificate No: Z18-97091

Page 5 of 8

Shenzhen Anbotek Compliance Laboratory Limited

(botok

Address: 1/F., Building D, Sogood Science and Technology Park, Sanwei Community, Hangcheng Street, Bao'an District, Sherizhen, Guangdong, China. Tel:(86) 755-26066440 Fax: (86) 755-26014772 Email: service@anbotek.com



Anbo



peilor

ANDO

Anbotel

(botok

Report No.: R0219080013W

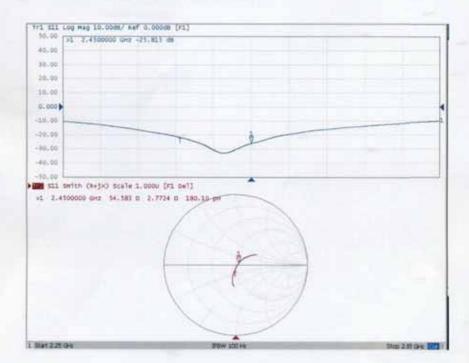
FCC ID: 2APX7K5B

Page 105 of 108

Anbote



Impedance Measurement Plot for Head TSL



Certificate No: Z18-97091

Page 6 of 8

Shenzhen Anbotek Compliance Laboratory Limited

Address: 1/F., Building D, Sogood Science and Technology Park, Sanwei Community, Hangcheng Street, Bao'an District, Shenzhen, Guangdong, China. Tel:(86) 755-26066440 Fax: (86) 755-26014772 Email: service@anbotek.com



antro

Anbo



FCC ID: 2APX7K5B

Page 106 of 108



ian District, Beijing, 100191, China Fax: +86-10-62304633-2504 Tel: +86-10-62304633-2079 E-mail: cttlijchinattl.com Http://www.chinattl.cn

DASY5 Validation Report for Body TSL

Date: 06.15.2018

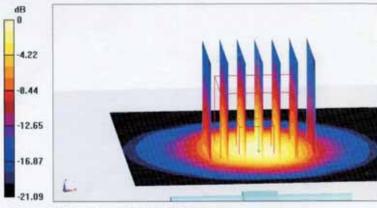
Test Laboratory: CTTL, Beijing, China DUT: Dipole 2450 MHz; Type: D2450V2; Serial: D2450V2 - SN: 910 Communication System: UID 0, CW; Frequency: 2450 MHz; Duty Cycle: 1:1 Medium parameters used: f = 2450 MHz; $\sigma = 1.972$ S/m; $\epsilon_r = 52.92$; $\rho = 1000$ kg/m³ Phantom section: Center Section Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2007)

DASY5 Configuration:

- Probe: EX3DV4 SN7307; ConvF(7.22, 7.22, 7.22); Calibrated: 2/19/2018; ٠
- Sensor-Surface: 2mm (Mechanical Surface Detection)
- Electronics: DAE4 Sn771; Calibrated: 2018-02-02
- Phantom: Triple Flat Phantom 5.1C; Type: QD 000 P51 CA; Serial: 1161/1
- Measurement SW: DASY52, Version 52.8 (8); SEMCAD X Version 14.6.10 (7:72)

Dipole Calibration/Zoom Scan (7x7x7) (7x7x7)/Cube 0: Measurement grid: dx=5mm dy=5mm, dz=5mm

Reference Value = 98.89 V/m; Power Drift = 0.03 dB Peak SAR (extrapolated) = 25.6 W/kg SAR(1 g) = 13 W/kg; SAR(10 g) = 6.18 W/kg Maximum value of SAR (measured) = 19.3 W/kg



0 dB = 19.3 W/kg = 12.86 dBW/kg

Certificate No: Z18-97091

Page 7 of 8

Shenzhen Anbotek Compliance Laboratory Limited

botok

Address: 1/F., Building D, Sogood Science and Technology Park, Sanwei Community, Hangcheng Street, Bao'an District, Sherizhen, Guangdong, China. Tel:(86) 755-26066440 Fax: (86) 755-26014772 Email: service@anbotek.com



Anbotek Product Safety

prilor

Anton

Anbotel

Amboliak

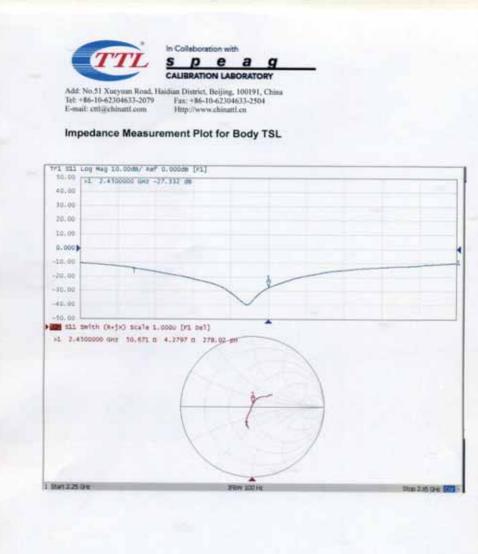
(botok

Report No.: R0219080013W

FCC ID: 2APX7K5B

Page 107 of 108

Anbote



Certificate No: Z18-97091

Page # of #

Shenzhen Anbotek Compliance Laboratory Limited

Address: 1/F., Building D, Sogood Science and Technology Park, Sanwei Community, Hangcheng Street, Bao'an District, Sherizhen, Guangdong, China. Tel:(86) 755-26066440 Fax: (86) 755-26014772 Email: service@anbotek.com



anto

Anbo

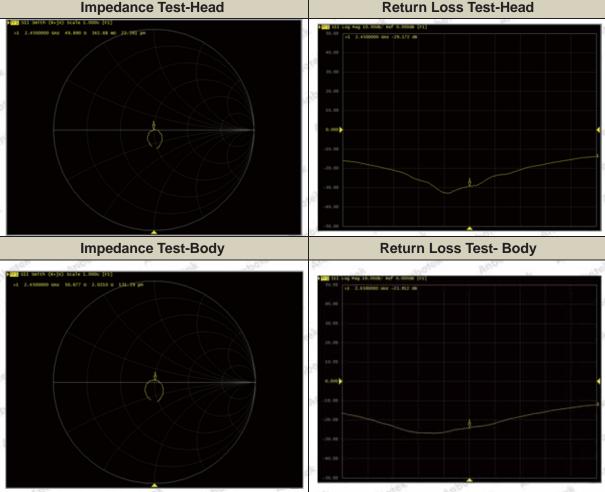
Report No.: R0219080013W FCC ID: 2APX7K5B

Page 108 of 108

Justification of the extended calibration of Dipole D2450V2 SN: 910

Per KDB 865664, we have Measured the Impedance and Return Loss as below, and the return lossis <-20dB, with 20% of prior calibration; the real or imaginary parts of the impedance is with 5 ohm of prior calibration. Therefore the verification result should support extended calibration.

Dipole 835 Head TST	Target Value	Measured Value	Difference
Impedance transformed tofeed point	54.60Ω+2.77jΩ	49.89Ω+0.34jΩ	R=-4.71Ω,X=-2.43Ω
Return Loss	-25.80dB	-29.17dB	13.06%
Dipole 835 Body TST	Target Value	Measured Value	Difference
Impedance transformed tofeed point	50.70Ω+4.28jΩ	50.68Ω+2.02jΩ	R=-0.02Ω,X=-2.26Ω
Return Loss	-27.4dB	-23.91dB	12.74%
Measured Date	2018-06-15	2019-06-14	- nootek Anbor
	Frat Hand	Determine	The fille of the



*****END OF REPORT****

Shenzhen Anbotek Compliance Laboratory Limited

Address: 1/F., Building D, Sogood Science and Technology Park, Sanwei Community, Hangcheng Street, Bao'an District, Shenzhen, Guangdong, China. Tel:(86) 755–26066440 Fax: (86) 755–26014772 Email: service@anbotek.com

